

PIC16F526 Data Sheet

14-Pin, 8-Bit Flash Microcontroller

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14-Pin, 8-Bit Flash Microcontroller

High-Performance RISC CPU:

- Only 33 Single-Word Instructions
- All Single-Cycle Instructions except for Program Branches which are Two-Cycle
- Two-Level Deep Hardware Stack
- Direct, Indirect and Relative Addressing modes for Data and Instructions
- · Operating Speed:
 - DC 20 MHz crystal oscillator
 - DC 200 ns instruction cycle
- On-chip Flash Program Memory:
- 1024 x 12
- · General Purpose Registers (SRAM):
- 67 x 8
- · Flash Data Memory:
 - 64 x 8

Special Microcontroller Features:

- 8 MHz Precision Internal Oscillator:
 - Factory calibrated to ±1%
- In-Circuit Serial Programming[™] (ICSP[™])
- In-Circuit Debugging (ICD) Support
- Power-On Reset (POR)
- Device Reset Timer (DRT)
- Watchdog Timer (WDT) with Dedicated On-Chip RC Oscillator for Reliable Operation
- Programmable Code Protection
- Multiplexed MCLR Input Pin
- Internal Weak Pull-ups on I/O Pins
- · Power-Saving Sleep mode
- Wake-Up from Sleep on Pin Change
- Selectable Oscillator Options:
 - INTRC: 4 MHz or 8 MHz precision Internal RC oscillator
 - EXTRC: External low-cost RC oscillator
 - XT: Standard crystal/resonator
 - HS: High-speed crystal/resonator
 - LP: Power-saving, low-frequency crystal
 - EC: High-speed external clock input

Low-Power Features/CMOS Technology:

- Standby current:
- 100 nA @ 2.0V, typical
- Operating current:
 - 11 μA @ 32 kHz, 2.0V, typical
 - 175 μA @ 4 MHz, 2.0V, typical
- Watchdog Timer current:
 - 1 μA @ 2.0V, typical
 - 7 μA @ 5.0V, typical
- High Endurance Program and Flash Data Memory cells:
 - 100,000 write Program Memory endurance
 - 1,000,000 write Flash Data Memory endurance
 - Program and Flash Data retention: >40 years
- Fully Static Design
- Wide Operating Voltage Range: 2.0V to 5.5V:
 - Wide temperature range
 - Industrial: -40°C to +85°C
 - Extended: -40°C to +125°C

Peripheral Features:

- 12 I/O Pins:
 - 11 I/O pins with individual direction control
 - 1 input-only pin
 - High current sink/source for direct LED drive
 - Wake-up on change
 - Weak pull-ups
- 8-bit Real-time Clock/Counter (TMR0) with 8-bit Programmable Prescaler
- Two Analog Comparators:
 - Comparator inputs and output accessible externally
 - One comparator with 0.6V fixed on-chip absolute voltage reference (VREF)
 - One comparator with programmable on-chip voltage reference (VREF)
- Analog-to-Digital (A/D) Converter:
 - 8-bit resolution
 - 3-channel external programmable inputs
 - 1-channel internal input to internal absolute 0.6 voltage reference

Device	Program Memory	Data Me	mory	I/O	Comparators	Timers 8-bit	8-bit A/D Channels	
Device	Flash (words)	SRAM (bytes)	Flash (bytes)	1/0	Comparators			
PIC16F526	1024	67	64	12	2	1	3	

FIGURE 1-1: 14-PIN PDIP, SOIC, TSSOP DIAGRAM

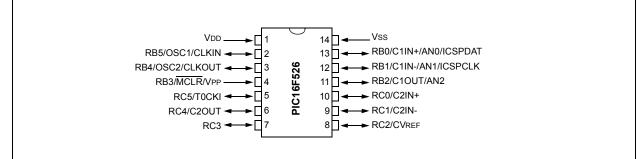


FIGURE 1-2: 16-PIN QFN DIAGRAM

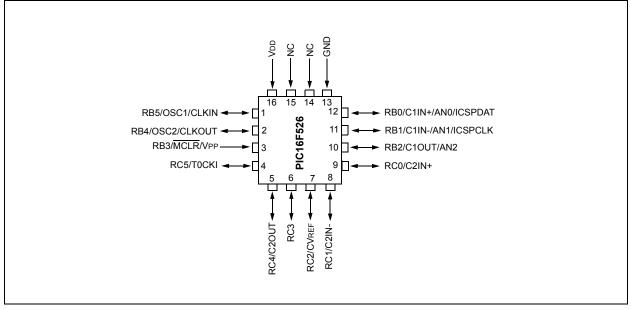


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NOTES:

1.0 GENERAL DESCRIPTION

The PIC16F526 device from Microchip Technology is low-cost, high-performance, 8-bit, fully-static, Flashbased CMOS microcontrollers. It employs a RISC architecture with only 33 single-word/single-cycle instructions. All instructions are single cycle ($200 \ \mu$ s) except for program branches, which take two cycles. The PIC16F526 device delivers performance an order of magnitude higher than their competitors in the same price category. The 12-bit wide instructions are highly symmetrical, resulting in a typical 2:1 code compression over other 8-bit microcontrollers in its class. The easy-to-use and easy to remember instruction set reduces development time significantly.

The PIC16F526 product is equipped with special features that reduce system cost and power requirements. The Power-on Reset (POR) and Device Reset Timer (DRT) eliminate the need for external Reset circuitry. There are four oscillator configurations to choose from, including INTRC Internal Oscillator mode and the power-saving LP (Low-Power) Oscillator mode. Power-Saving Sleep mode, Watchdog Timer and code protection features improve system cost, power and reliability.

The PIC16F526 device is available in the cost-effective Flash programmable version, which is suitable for production in any volume. The customer can take full advantage of Microchip's price leadership in Flash programmable microcontrollers, while benefiting from the Flash programmable flexibility.

The PIC16F526 product is supported by a full-featured macro assembler, a software simulator, an in-circuit emulator, a 'C' compiler, a low-cost development programmer and a full featured programmer. All the tools are supported on IBM[®] PC and compatible machines.

1.1 Applications

The PIC16F526 device fits in applications ranging from personal care appliances and security systems to lowpower remote transmitters/receivers. The Flash technology makes customizing application programs (transmitter codes, appliance settings, receiver frequencies, etc.) extremely fast and convenient. The small footprint packages, for through hole or surface mounting, make these microcontrollers perfect for applications with space limitations. Low cost, low power, high performance, ease of use and I/O flexibility make the PIC16F526 device very versatile even in areas where no microcontroller use has been considered before (e.g., timer functions, logic and PLDs in larger systems and coprocessor applications).

PIC16F526

Maximum Frequency of Operation (MHz)	20
Flash Program Memory	1024
SRAM Data Memory (bytes)	67
Flash Data Memory (bytes)	64
Timer Module(s)	TMR0
Wake-up from Sleep on Pin Change	Yes
I/O Pins	11
Input Pins	1
Internal Pull-ups	Yes
In-Circuit Serial Programming [™]	Yes
Number of Instructions	33
Packages	14-pin PDIP, SOIC, TSSOP, QFN
	Flash Program Memory SRAM Data Memory (bytes) Flash Data Memory (bytes) Timer Module(s) Wake-up from Sleep on Pin Change I/O Pins Input Pins Internal Pull-ups In-Circuit Serial Programming [™] Number of Instructions

TABLE 1-1:FEATURES AND MEMORY OF PIC16F526

The PIC16F526 device has Power-on Reset, selectable Watchdog Timer, selectable code-protect, high I/O current capability and precision internal oscillator.

The PIC16F526 device uses serial programming with data pin RB0 and clock pin RB1.

NOTES:

2.0 PIC16F526 DEVICE VARIETIES

A variety of packaging options are available. Depending on application and production requirements, the proper device option can be selected using the information in this section. When placing orders, please use the PIC16F526 Product Identification System at the back of this data sheet to specify the correct part number.

2.1 Quick Turn Programming (QTP) Devices

Microchip offers a QTP programming service for factory production orders. This service is made available for users who choose not to program medium-to-high quantity units and whose code patterns have stabilized. The devices are identical to the Flash devices but with all Flash locations and fuse options already programmed by the factory. Certain code and prototype verification procedures do apply before production shipments are available. Please contact your local Microchip Technology sales office for more details.

2.2 Serialized Quick Turn ProgrammingSM (SQTPSM) Devices

Microchip offers a unique programming service, where a few user-defined locations in each device are programmed with different serial numbers. The serial numbers may be random, pseudo-random or sequential.

Serial programming allows each device to have a unique number, which can serve as an entry code, password or ID number.

NOTES:

3.0 ARCHITECTURAL OVERVIEW

The high performance of the PIC16F526 device can be attributed to a number of architectural features commonly found in RISC microprocessors. To begin with, the PIC16F526 device uses a Harvard architecture in which program and data are accessed on separate buses. This improves bandwidth over traditional von Neumann architectures where program and data are fetched on the same bus. Separating program and data memory further allows instructions to be sized differently than the 8-bit wide data word. Instruction opcodes are 12 bits wide, making it possible to have all single-word instructions. A 12-bit wide program memory access bus fetches a 12-bit instruction in a single cycle. A two-stage pipeline overlaps fetch and execution of instructions. Consequently, all instructions (33) execute in a single cycle (200 ns @ 20 MHz, 1 µs @ 4 MHz) except for program branches.

Table 3-1 below lists memory supported by the PIC16F526 device.

TABLE 3-1: PIC16F526 MEMORY

Device	Program Memory	Data Memory			
Device	Flash (words)	SRAM (bytes)	Flash (bytes)		
PIC16F526	1024	67	64		

The PIC16F526 device can directly or indirectly address its register files and data memory. All Special Function Registers (SFR), including the PC, are mapped in the data memory. The PIC16F526 device has a highly orthogonal (symmetrical) instruction set that makes it possible to carry out any operation, on any register, using any Addressing mode. This symmetrical nature and lack of "special optimal situations" make programming with the PIC16F526 device simple, yet efficient. In addition, the learning curve is reduced significantly. The PIC16F526 device contains an 8-bit ALU and working register. The ALU is a general purpose arithmetic unit. It performs arithmetic and Boolean functions between data in the working register and any register file.

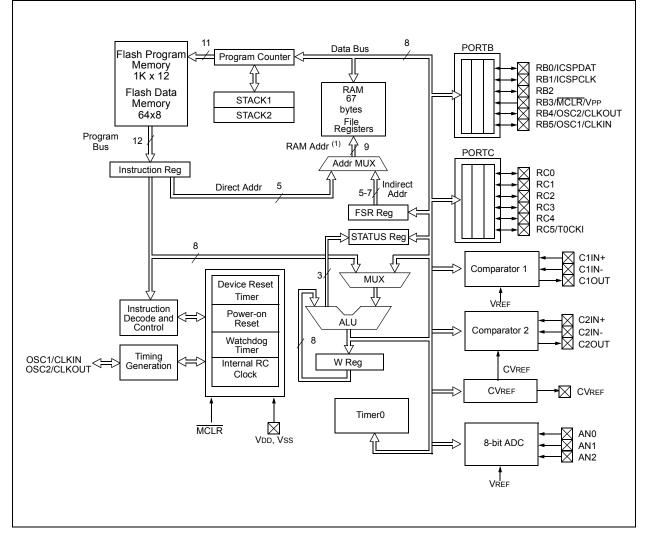
The ALU is 8 bits wide and capable of addition, subtraction, shift and logical operations. Unless otherwise mentioned, arithmetic operations are two's complement in nature. In two-operand instructions, one operand is typically the W (working) register. The other operand is either a file register or an immediate constant. In single operand instructions, the operand is either the W register or a file register.

The W register is an 8-bit working register used for ALU operations. It is not an addressable register.

Depending on the instruction executed, the ALU may affect the values of the Carry (C), Digit Carry (DC) and Zero (Z) bits in the STATUS register. The C and DC bits operate as a borrow and digit borrow out bit, respectively, in subtraction. See the SUBWF and ADDWF instructions for examples.

A simplified block diagram is shown in Figure 3-2, with the corresponding device pins described in Table 3-2.





Name	Function	Input Type	Output Type	Description
RB0//C1IN+/AN0/ ICSPDAT	RB0	TTL	CMOS	Bidirectional I/O pin. Can be software programmed for internal weak pull-up and wake-up from Sleep on pin change.
	C1IN+	AN		Comparator 1 input.
	AN0	AN		ADC channel input.
	ICSPDAT	ST	CMOS	ICSP™ mode Schmitt Trigger.
RB1/C1IN-/AN1/ ICSPCLK	RB1	TTL	CMOS	Bidirectional I/O pin. Can be software programmed for internal weak pull-up and wake-up from Sleep on pin change.
	C1IN-	AN		Comparator 1 input.
	AN1	AN		ADC channel input.
	ICSPCLK	ST	CMOS	ICSP mode Schmitt Trigger.
RB2/C1OUT/AN2	RB2	TTL	CMOS	Bidirectional I/O pin.
	C10UT	_	CMOS	Comparator 1 output.
	AN2	AN	—	ADC channel input.
RB3/MCLR/VPP	RB3	TTL	—	Input pin. Can be software programmed for internal weak pull-up and wake-up from Sleep on pin change.
	MCLR	ST	_	Master Clear (Reset). When configured as MCLR, this pin is an active-low Reset to the device. Voltage on MCLR/VPP must not exceed VDD during normal device operation or the device will enter Programming mode. Weak pull-up always on if configured as MCLR.
	VPP	HV	_	Programming voltage input.
RB4/OSC2/CLKOUT	RB4	TTL	CMOS	Bidirectional I/O pin. Can be software programmed for internal weak pull-up and wake-up from Sleep on pin change.
	OSC2	—	XTAL	Oscillator crystal output. Connections to crystal or resonator in Crystal Oscillator mode (XT, HS and LP modes only, PORTB in other modes).
	CLKOUT		CMOS	EXTRC/INTRC CLKOUT pin (Fosc/4).
RB5/OSC1/CLKIN	RB5	TTL	CMOS	Bidirectional I/O pin.
	OSC1	XTAL		Oscillator crystal input.
	CLKIN	ST		External clock source input.
RC0/C2IN+	RC0	TTL	CMOS	Bidirectional I/O port.
	C2IN+	AN		Comparator 2 input.
RC1/C2IN-	RC1	TTL	CMOS	Bidirectional I/O port.
	C2IN-	AN	—	Comparator 2 input.
RC2/CVREF	RC2	TTL	CMOS	Bidirectional I/O port.
	CVREF		AN	Programmable Voltage Reference output.
RC3	RC3	TTL	CMOS	Bidirectional I/O port.
RC4/C2OUT	RC4	TTL	CMOS	Bidirectional I/O port.
	C2OUT		CMOS	Comparator 2 output.
RC5/T0CKI	RC5	TTL	CMOS	Bidirectional I/O port.
	TOCKI	ST		Timer0 Schmitt Trigger input pin.
Vdd	Vdd		Р	Positive supply for logic and I/O pins.
Vss	Vss		Р	Ground reference for logic and I/O pins.

TABLE 3-2: PIC16F526 PINOUT DESCRIPTION

Legend: I = Input, O = Output, I/O = Input/Output, P = Power, — = Not used, TTL = TTL input, ST = Schmitt Trigger input, HV = High Voltage

3.1 Clocking Scheme/Instruction Cycle

The clock input (OSC1/CLKIN pin) is internally divided by four to generate four non-overlapping quadrature clocks, namely Q1, Q2, Q3 and Q4. Internally, the PC is incremented every Q1 and the instruction is fetched from program memory and latched into the instruction register in Q4. It is decoded and executed during the following Q1 through Q4. The clocks and instruction execution flow is shown in Figure 3-2 and Example 3-1.

3.2 Instruction Flow/Pipelining

An instruction cycle consists of four Q cycles (Q1, Q2, Q3 and Q4). The instruction fetch and execute are pipelined such that fetch takes one instruction cycle, while decode and execute take another instruction cycle. However, due to the pipelining, each instruction effectively executes in one cycle. If an instruction causes the PC to change (e.g., GOTO), then two cycles are required to complete the instruction (Example 3-1).

A fetch cycle begins with the PC incrementing in Q1.

In the execution cycle, the fetched instruction is latched into the Instruction Register (IR) in cycle Q1. This instruction is then decoded and executed during the Q2, Q3 and Q4 cycles. Data memory is read during Q2 (operand read) and written during Q4 (destination write).

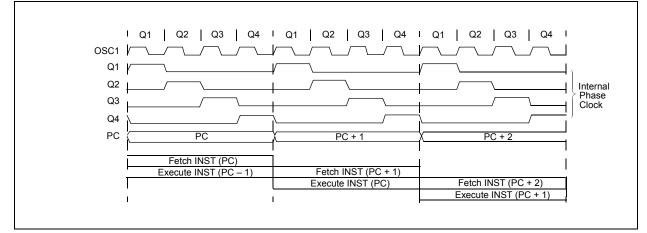
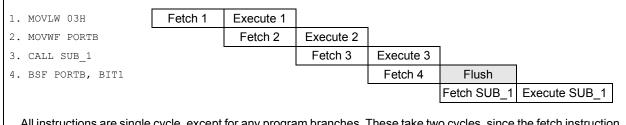


FIGURE 3-2: CLOCK/INSTRUCTION CYCLE

EXAMPLE 3-1: INSTRUCTION PIPELINE FLOW



All instructions are single cycle, except for any program branches. These take two cycles, since the fetch instruction is "flushed" from the pipeline, while the new instruction is being fetched and then executed.

4.0 MEMORY ORGANIZATION

The PIC16F526 memories are organized into program memory and data memory (SRAM). The self-writable portion of the program memory called Flash data memory is located at addresses at 400h-43Fh. All Program mode commands that work on the normal Flash memory work on the Flash data memory. This includes bulk erase, row/column/cycling toggles, Load and Read data commands (Refer to Section 5.0 "Flash Data Memory Control" for more details). For devices with more than 512 bytes of program memory, a paging scheme is used. Program memory pages are accessed using one STATUS register bit. For the PIC16F526, with data memory register files of more than 32 registers, a banking scheme is used. Data memory banks are accessed using the File Select Register (FSR).

4.1 Program Memory Organization for the PIC16F526

The PIC16F526 device has an 11-bit Program Counter (PC) capable of addressing a 2K x 12 program memory space. Program memory is partitioned into user memory, data memory and configuration memory spaces.

The user memory space is the on-chip user program memory. As shown in Figure 4-1, it extends from 0x000 to 0x3FF and partitions into pages, including Reset vector at address 0x3FF.

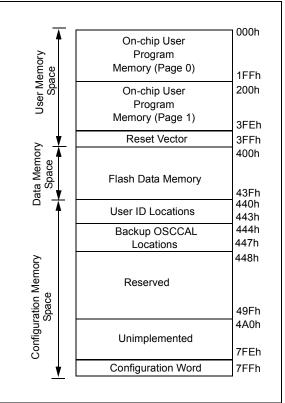
The data memory space is the Flash data memory block and is located at addresses PC = 400h-43Fh. All Program mode commands that work on the normal Flash memory work on the Flash data memory block. This includes bulk erase, Load and Read data commands.

The configuration memory space extends from 0x440 to 0x7FF. Locations from 0x448 through 0x49F are reserved. The user ID locations extend from 0x440 through 0x443. The Backup OSCCAL locations extend from 0x444 through 0x447. The Configuration Word is physically located at 0x7FF.

Refer to "*PIC16F526 Memory Programming Specification*" (DS41317) for more details.

FIGURE 4-1:

MEMORY MAP



4.2 Data Memory (SRAM and FSRs)

Data memory is composed of registers or bytes of SRAM. Therefore, data memory for a device is specified by its register file. The register file is divided into two functional groups: Special Function Registers (SFR) and General Purpose Registers (GPR).

The Special Function Registers are registers used by the CPU and peripheral functions for controlling desired operations of the PIC16F526. See Figure 4-1 for details.

The PIC16F526 register file is composed of 16 Special Function Registers and 67 General Purpose Registers.

4.2.1 GENERAL PURPOSE REGISTER FILE

The General Purpose Register file is accessed, either directly or indirectly, through the File Select Register (FSR). See Section 4.8 "Indirect Data Addressing: INDF and FSR Registers".

4.2.2 SPECIAL FUNCTION REGISTERS

The Special Function Registers (SFRs) are registers used by the CPU and peripheral functions to control the operation of the device (Table 4-1).

The Special Function Registers can be classified into two sets. The Special Function Registers associated with the "core" functions are described in this section. Those related to the operation of the peripheral features are described in the section for each peripheral feature.

FSR<6:5>	▶ 00	01	10	11
File Address		20h	40h	60h
00h	INDF ⁽¹⁾	INDF ⁽¹⁾	INDF ⁽¹⁾	INDF ⁽¹⁾
▼ 01h	TMR0	EECON	TMR0	EECON
02h	PCL	PCL	PCL	PCL
03h	STATUS	STATUS	STATUS	STATUS
04h	FSR	FSR	FSR	FSR
05h	OSCCAL	EEDATA	OSCCAL	EEDATA
06h	PORTB	EEADR	PORTB	EEADR
07h	PORTC	PORTC	PORTC	PORTC
08h	CM1CON0	CM1CON0	CM1CON0	CM1CON0
09h	ADCON0	ADCON0	ADCON0	ADCON0
0Ah	ADRES	ADRES	ADRES	ADRES
0Bh	CM2CON0	CM2CON0	CM2CON0	CM2CON0
0Ch	VRCON	VRCON	VRCON	VRCON
0Dh 0Fh	General Purpose Registers	ad	l dresses map back dresses in Bank 0. 4Fh	to 6Fh
10h		30h	50h	70h
	General Purpose Registers	General Purpose Registers	General Purpose Registers	General Purpose Registers
1Fh		3Fh	5Fh	7Fh
L	Bank 0	Bank 1	Bank 2	Bank 3
ote 1: Not a phys	sical register. See	Section 4.8 "Indire	ect Data Addressin	ig: INDF and FSR F

FIGURE 4-2: REGISTER FILE MAP

Addr	Name	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	Value on Power-on Reset	Page #
N/A	TRIS	_	—	I/O Control	Register (PC	ORTB, PORT	IC)			11 1111	27
N/A	OPTION	Contains co	ontrol bits to c	onfigure Tim	ner0 and Tim	er0/WDT pre	escaler			1111 1111	19
00h	INDF	Uses conte	nts of FSR to	Address Da	ata Memory (i	not a physica	al register)			XXXX XXXX	22
01h/41h	TMR0	Timer0 Mo	dule Register							XXXX XXXX	37
02h ⁽¹⁾	PCL	Low order	3 bits of PC							1111 1111	21
03h	STATUS	RBWUF	CWUF	PA0	TO	PD	Z	DC	С	0001 1xxx	18
04h	FSR	Indirect Da	Indirect Data Memory Address Pointer								22
05h/45h	OSCCAL	CAL6	CAL5	CAL4	CAL3	CAL2	CAL1	CAL0	_	1111 111-	20
06h/46h	PORTB	—	—	RB5	RB4	RB3	RB2	RB1	RB0	xx xxxx	27
07h	PORTC		_	RC5	RC4	RC3	RC2	RC1	RC0	xx xxxx	28
08h	CM1CON0	C1OUT	C10UTEN	C1POL	C1T0CS	C10N	C1NREF	C1PREF	C1WU	q111 1111	63
09h	ADCON0	ANS1	ANS0	ADCS1	ADCS0	CHS1	CHS0	GO/DONE	ADON	1111 1100	61
0Ah	ADRES	ADC Conve	ersion Result				•			XXXX XXXX	62
0Bh	CM2CON0	C2OUT	C2OUTEN	C2POL	C2PREF2	C2ON	C2NREF	C2PREF1	C2WU	q111 1111	64
0Ch	VRCON	VREN	VROE	VRR		VR3	VR2	VR1	VR0	001- 1111	69
21h/61h	EECON	—	—	_	FREE	WRERR	WREN	WR	RD	0 x000	23
25h/65h	EEDATA	SELF REA	SELF READ/WRITE DATA								23
26h/66h	EEADR		—	SELF REA	D/WRITE AD	DRESS				xx xxxx	23

TABLE 4-1: SPECIAL FUNCTION REGISTER (SFR) SUMMARY

 Legend:
 x = unknown, u = unchanged, - = unimplemented, read as '0' (if applicable), q = value depends on condition. Shaded cells = unimplemented or unused

 Note 1:
 The upper byte of the Program Counter is not directly accessible. See Section 4.6 "Program Counter" for an explanation of how to

access these bits.

4.3 STATUS Register

This register contains the arithmetic status of the ALU, the Reset status and the page preselect bit.

The STATUS register can be the destination for any instruction, as with any other register. If the STATUS register is the destination for an instruction that affects the Z, DC or C bits, then the write to these three bits is disabled. These bits are set or cleared according to the device logic. Furthermore, the TO and PD bits are not writable. Therefore, the result of an instruction with the STATUS register as destination may be different than intended.

For example, CLRF STATUS, will clear the upper three bits and set the Z bit. This leaves the STATUS register as 000u uluu (where u = unchanged).

Therefore, it is recommended that only BCF, BSF and MOVWF instructions be used to alter the STATUS register. These instructions do not affect the Z, DC or C bits from the STATUS register. For other instructions which do affect Status bits, see Section 12.0 "Instruction Set Summary".

REGISTER 4-1: STATUS: STATUS REGISTER

R/W-0	R/W-0	R/W-0	R-1	R-1	R/W-x	R/W-x	R/W-x
RBWUF	CWUF	PA0	TO	PD	Z	DC	С
bit 7							bit 0
Legend:							
R = Readable		W = Writable b	it	U = Unimple	emented bit, read	as '0'	
-n = Value at F	POR	'1' = Bit is set		'0' = Bit is cl	eared	x = Bit is unkno	wn
bit 7	1 = Reset due	e-up from Sleep to wake-up from er-up or other Re	n Sleep on pi	-			
bit 6	1 = Reset due	up from Sleep o to wake-up from er-up or other Re	n Sleep on co		nge		
bit 5	PA0 : Program 1 = Page 1 (00 0 = Page 0 (20	,	bit				
bit 4		bit er-up, CLRWDT in ne-out occurred	struction, or	SLEEP instruct	ion		
bit 3		wn bit er-up or by the Ci on of the SLEEP		ction			
bit 2	 Z: Zero bit 1 = The result of an arithmetic or logic operation is zero 0 = The result of an arithmetic or logic operation is not zero 						
bit 1	ADDWF: 1 = A carry fro 0 = A carry fro SUBWF: 1 = A borrow f	//borrow bit (for 2 m the 4th low-or m the 4th low-or rom the 4th low- rom the 4th low-	der bit of the der bit of the order bit of th	result occurre result did not ne result did not	d occur ot occur		
bit 0		w bit (for ADDWF SU curred 1 =		RRF, RLF instr d not occur	uctions) RRF or RLF:	o or MSb, respecti	vely

4.4 **OPTION Register**

The OPTION register is a 8-bit wide, write-only register, which contains various control bits to configure the Timer0/WDT prescaler and Timer0.

By executing the <code>OPTION</code> instruction, the contents of the W register will be transferred to the <code>OPTION</code> register. A Reset sets the <code>OPTION <7:0></code> bits.

Note:	If TRIS bit is set to '0', the wake-up on
	change and pull-up functions are disabled
	for that pin (i.e., note that TRIS overrides
	Option control of RBPU and RBWU).

REGISTER 4-2: OPTION: OPTION REGISTER

W-1	W-1	W-1	W-1	W-1	W-1	W-1	W-1
RBWU	RBPU	T0CS ⁽¹⁾	T0SE	PSA	PS2	PS1	PS0
bit 7 bit 0							

Legend:			
R = Readable bit	W = Writable bit	U = Unimplemented bit, read	l as '0'
-n = Value at POR	'1' = Bit is set	'0' = Bit is cleared	x = Bit is unknown

bit 7	RBWU: Enable Wake-up On Pin Change bit (RB0, RB1, RB3, RB4) 1 = Disabled 0 = Enabled								
bit 6	RBPU: Enable Weak Pull-ups bit (RB0, RB1, RB3, RB4) 1 = Disabled 0 = Enabled								
bit 5	TOCS: Timer0 Clock Source Select bit ⁽¹⁾ 1 = Transition on T0CKI pin 0 = Internal instruction cycle clock (CLKOUT)								
bit 4	TOSE: Timer0 Source Edge Select bit 1 = Increment on high-to-low transition on T0CKI pin 0 = Increment on low-to-high transition on T0CKI pin	1 = Increment on high-to-low transition on T0CKI pin							
bit 3	 PSA: Prescaler Assignment bit 1 = Prescaler assigned to the WDT 0 = Prescaler assigned to Timer0 	PSA: Prescaler Assignment bit 1 = Prescaler assigned to the WDT							
bit 2-0	PS<2:0>: Prescaler Rate Select bits								
	Bit Value Timer0 Rate WDT Rate								
	$\begin{array}{ c c c c c c c c c c c c c c c c c c c$								

Note 1: If the TOCS bit is set to '1', it will override the TRIS function on the TOCKI pin.

4.5 OSCCAL Register

The Oscillator Calibration (OSCCAL) register is used to calibrate the 8 MHz internal oscillator macro. It contains 7 bits of calibration that uses a two's complement scheme for controlling the oscillator speed. See Register 4-3 for details.

REGISTER 4-3: OSCCAL: OSCILLATOR CALIBRATION REGISTER

R/W-1	U-0						
CAL6	CAL5	CAL4	CAL3	CAL2	CAL1	CAL0	—
bit 7							bit 0

Legend:				
R = Readable bit	W = Writable bit	U = Unimplemented bit, read as '0'		
-n = Value at POR	'1' = Bit is set	'0' = Bit is cleared	x = Bit is unknown	

bit 7-1 CAL<6:0>: Oscillator Calibration bits 0111111 = Maximum frequency

bit 0

4.6 **Program Counter**

As a program instruction is executed, the Program Counter (PC) will contain the address of the next program instruction to be executed. The PC value is increased by one every instruction cycle, unless an instruction changes the PC.

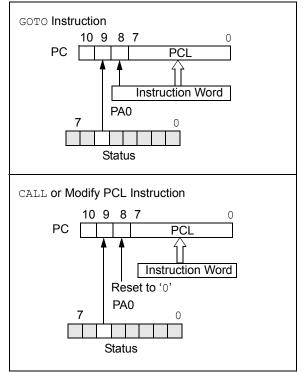
For a GOTO instruction, bits 8:0 of the PC are provided by the GOTO instruction word. The Program Counter (PCL) is mapped to PC<7:0>. Bit 5 of the STATUS register provides page information to bit 9 of the PC (Figure 4-3).

For a CALL instruction, or any instruction where the PCL is the destination, bits 7:0 of the PC again are provided by the instruction word. However, PC<8> does not come from the instruction word, but is always cleared (Figure 4-3).

Instructions where the PCL is the destination, or modify PCL instructions, include MOVWF PCL, ADDWF PCL and BSF PCL, 5.

Note:	Because bit 8 of the PC is cleared in the CALL instruction or any modify PCL
	instruction, all subroutine calls or com- puted jumps are limited to the first 256 locations of any program memory page (512 words long).

FIGURE 4-3: LOADING OF PC BRANCH INSTRUCTIONS



4.6.1 EFFECTS OF RESET

The PC is set upon a Reset, which means that the PC addresses the last location in the last page (i.e., the oscillator calibration instruction). After executing MOVLW XX, the PC will roll over to location 00h and begin executing user code.

The STATUS register page preselect bits are cleared upon a Reset, which means that page 0 is pre-selected.

Therefore, upon a Reset, a GOTO instruction will automatically cause the program to jump to page 0 until the value of the page bits is altered.

4.7 Stack

The PIC16F526 device has a 2-deep, 12-bit wide hardware PUSH/POP stack.

A CALL instruction will PUSH the current value of Stack 1 into Stack 2 and then PUSH the current PC value, incremented by one, into Stack Level 1. If more than two sequential CALLs are executed, only the most recent two return addresses are stored.

A RETLW instruction will POP the contents of Stack Level 1 into the PC and then copy Stack Level 2 contents into Stack Level 1. If more than two sequential RETLWS are executed, the stack will be filled with the address previously stored in Stack Level 2. Note that the W register will be loaded with the literal value specified in the instruction. This is particularly useful for the implementation of data look-up tables within the program memory.

Note 1:	There are no Status bits to indicate Stack Overflows or Stack Underflow conditions.
2:	There are no instruction mnemonics called PUSH or POP. These are actions that occur from the execution of the CALL
	and RETLW instructions.

4.8 Indirect Data Addressing: INDF and FSR Registers

The INDF Register is not a physical register. Addressing INDF actually addresses the register whose address is contained in the FSR Register (FSR is a *pointer*). This is indirect addressing.

Reading INDF itself indirectly (FSR = 0) will produce 00h. Writing to the INDF Register indirectly results in a no-operation (although Status bits may be affected).

The FSR is an 8-bit wide register. It is used in conjunction with the INDF Register to indirectly address the data memory area.

The FSR<4:0> bits are used to select data memory addresses 00h to 1Fh.

FSR<6:5> are the bank select bits and are used to select the bank to be addressed (00 = Bank 0, 01 = Bank 1, 10 = Bank 2, 11 = Bank 3).

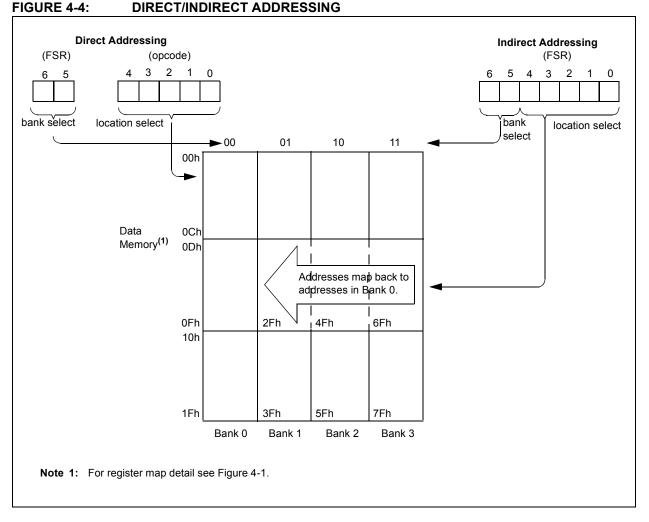
FSR<7> is unimplemented and read as '1'.



A simple program to clear RAM locations 10h-1Fh using indirect addressing is shown in Example 4-1.

EXAMPLE 4-1: HOW TO CLEAR RAM **USING INDIRECT** ADDRESSING

NEXT	MOVLW MOVWF CLRF INCF BTFSC GOTO	0x10 FSR INDF FSR,F FSR,4 NEXT	<pre>;initialize pointer ;to RAM ;clear INDF ;register ;inc pointer ;all done? ;NO, clear next</pre>
CONTINU	JE		
	:		;YES, continue
	:		



5.0 FLASH DATA MEMORY CONTROL

The Flash data memory is readable and writable during normal operation (full VDD range). This memory is not directly mapped in the register file space. Instead, it is indirectly addressed through the Special Function Registers (SFRs).

5.1 Reading Flash Data Memory

To read a Flash data memory location the user must:

- Write the EEADR register
- · Set the RD bit of the EECON register

The value written to the EEADR register determines which Flash data memory location is read. Setting the RD bit of the EECON register initiates the read. Data from the Flash data memory read is available in the EEDATA register immediately. The EEDATA register will hold this value until another read is initiated or it is modified by a write operation. Program execution is suspended while the read cycle is in progress. Execution will continue with the instruction following the one that sets the WR bit. See Example 1 for sample code.

EXAMPLE 1: READING FROM FLASH DATA MEMORY

BANKSEL EEADR	;
MOVF DATA_EE_ADDR, W	;
MOVWF EEADR	;Data Memory
	;Address to read
BANKSEL EECON1	;
BSF EECON, RD	;EE Read
MOVF EEDATA, W	;W = EEDATA

Note: Only a BSF command will work to enable the Flash data memory read documented in Example 1. No other sequence of commands will work, no exceptions.

5.2 Writing and Erasing Flash Data Memory

Flash data memory is erased one row at a time and written one byte at a time. The 64-byte array is made up of eight rows. A row contains eight sequential bytes. Row boundaries exist every eight bytes.

Generally, the procedure to write a byte of data to Flash data memory is:

- 1. Identify the row containing the address where the byte will be written.
- 2. If there is other information in that row that must be saved, copy those bytes from Flash data memory to RAM.

- 3. Perform a row erase of the row of interest.
- 4. Write the new byte of data and any saved bytes back to the appropriate addresses in Flash data memory.

To prevent accidental corruption of the Flash data memory, an unlock sequence is required to initiate a write or erase cycle. This sequence requires that the bit set instructions used to configure the EECON register happen exactly as shown in Example 2 and Example 3, depending on the operation requested.

5.2.1 ERASING FLASH DATA MEMORY

A row must be manually erased before writing new data. The following sequence must be performed for a single row erase.

- 1. Load EEADR with an address in the row to be erased.
- 2. Set the FREE bit to enable the erase.
- 3. Set the WREN bit to enable write access to the array.
- 4. Set the WR bit to initiate the erase cycle.

If the WREN bit is not set in the instruction cycle after the FREE bit is set, the FREE bit will be cleared in hardware.

If the WR bit is not set in the instruction cycle after the WREN bit is set, the WREN bit will be cleared in hardware.

Sample code that follows this procedure is included in Example 2.

Program execution is suspended while the erase cycle is in progress. Execution will continue with the instruction following the one that sets the WR bit.

EXAMPLE 2: ERASING A FLASH DATA MEMORY ROW

BANKSEL	EEADR	
MOVLW	EE_ADR_ERASE	; LOAD ADDRESS OF ROW TO
		; ERASE
MOVWF	EEADR	;
BSF	EECON, FREE	; SELECT ERASE
BSF	EECON, WREN	; ENABLE WRITES
BSF	EECON, WR	; INITITATE ERASE

- Note 1: The FREE bit may be set by any command normally used by the core. However, the WREN and WR bits can only be set using a series of BSF commands, as documented in Example 1. No other sequence of commands will work, no exceptions.
 - **2:** Bits <5:3> of the EEADR register indicate which row is to be erased.

5.2.2 WRITING TO FLASH DATA MEMORY

Once a cell is erased, new data can be written. Program execution is suspended during the write cycle. The following sequence must be performed for a single byte write.

- 1. Load EEADR with the address.
- 2. Load EEDATA with the data to write.
- 3. Set the WREN bit to enable write access to the array.
- 4. Set the WR bit to initiate the erase cycle.

If the WR bit is not set in the instruction cycle after the WREN bit is set, the WREN bit will be cleared in hardware.

Sample code that follows this procedure is included in Example 3.

EXAMPLE 3: WRITING A FLASH DATA MEMORY ROW

BANKSEL	EEADR		
MOVLW	EE_ADR_WRITE	;	LOAD ADDRESS
MOVWF	EEADR	;	
MOVLW	EE_DATA_TO_WRITE	;	LOAD DATA
MOVWF	EEDATA	;	INTO EEDATA REGISTER
BSF	EECON, WREN	;	ENABLE WRITES
BSF	EECON,WR	;	INITITATE ERASE

- Note 1: Only a series of BSF commands will work to enable the memory write sequence documented in Example 2. No other sequence of commands will work, no exceptions.
 - 2: For reads, erases and writes to the Flash data memory, there is no need to insert a NOP into the user code as is done on mid-range devices. The instruction immediately following the "BSF EECON, WR/RD" will be fetched and executed properly.

5.3 Write Verify

Depending on the application, good programming practice may dictate that data written to the Flash data memory be verified. Example 4 is an example of a write verify.

EXAMPLE 4: WRITE VERIFY OF FLASH DATA MEMORY

MOVF	EEDATA, W	;EEDATA has not changed
		;from previous write
BSF	EECON, RD	;Read the value written
XORWF	EEDATA, W	;
BTFSS	STATUS, Z	;Is data the same
GOTO	WRITE_ERR	;No, handle error
		;Yes, continue

REGISTER 5-1: EEDATA: FLASH DATA REGISTER

| R/W-x |
|---------|---------|---------|---------|---------|---------|---------|---------|
| EEDATA7 | EEDATA6 | EEDATA5 | EEDATA4 | EEDATA3 | EEDATA2 | EEDATA1 | EEDATA0 |
| bit 7 | | | | | | | bit 0 |

Legend:			
R = Readable bit	R = Readable bit W = Writable bit		d as '0'
-n = Value at POR	'1' = Bit is set	'0' = Bit is cleared	x = Bit is unknown

bit 7-0 EEDATA<7:0>: 8-bits of data to be read from/written to data Flash

REGISTER 5-2: EEADR: FLASH ADDRESS REGISTER

U-0	U-0	R/W-x	R/W-x	R/W-x	R/W-x	R/W-x	R/W-x
—	—	EEADR5	EEADR4	EEADR3	EEADR2	EEADR1	EEADR0
bit 7							bit 0

Legend:			
R = Readable bit	W = Writable bit	U = Unimplemented bit, read	as '0'
-n = Value at POR	'1' = Bit is set	'0' = Bit is cleared	x = Bit is unknown

bit 7-6 Unimplemented: Read as '0'.

bit 5-0 EEADR<5:0>: 6-bits of data to be read from/written to data Flash

U-0	U-0	U-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	
_	— — F		FREE	WRERR	WREN	WR	RD	
bit 7							bit (
Legend:								
S = Bit can o	onlv be set							
R = Readab	•	W = Writable b	oit	U = Unimpler	nented bit, read	as '0'		
-n = Value a	n = Value at POR '1' = Bit is set			'0' = Bit is cle		x = Bit is unknown		
bit 7-5	Unimpleme	nted: Read as '0)'.					
bit 4		Data Memory F	20w Frase Fr	ahla Rit				
	FREE: Flash	Data Memory P		labic bit				
	1 = Program	m memory row b	eing pointed	to by EEADR w			cycle. No write	
	1 = Program will be	m memory row b performed. This	eing pointed	to by EEADR w			cycle. No write	
bit 3	1 = Program will be p 0 = Perform	m memory row b performed. This n write only	eing pointed bit is cleared	to by EEADR w			cycle. No writ	
	1 = Program will be p 0 = Perforn WRERR: Wr	m memory row b performed. This	eing pointed bit is cleared	to by EEADR w at the complet	ion of the erase		cycle. No writ	
	1 = Program will be 0 = Perform WRERR: Wr 1 = A write	m memory row b performed. This n write only ite Error Flag bit	eing pointed bit is cleared nated premati	to by EEADR w at the complet urely (by device	ion of the erase		cycle. No writ	
	1 = Program will be 0 = Perform WRERR: Wr 1 = A write	m memory row b performed. This n write only ite Error Flag bit operation termin peration comple	eing pointed bit is cleared nated premati	to by EEADR w at the complet urely (by device	ion of the erase		cycle. No writ	
bit 3	 Program will be p Perform WRERR: Wr A write Write o WREN: Write 	m memory row b performed. This n write only ite Error Flag bit operation termin peration comple e Enable bit	eing pointed bit is cleared nated premate ted successfi	to by EEADR w at the complet urely (by device ully	ion of the erase		cycle. No writ	
bit 3	 Program will be point will be p	m memory row b performed. This n write only ite Error Flag bit operation termin peration comple	eing pointed bit is cleared nated premate ted successfu	to by EEADR w at the complet urely (by device ully nory	ion of the erase		cycle. No writ	
bit 3	 Program will be point will be p	m memory row b performed. This n write only ite Error Flag bit operation termin peration comple e Enable bit write cycle to Fla write cycle to Fla	eing pointed bit is cleared nated premate ted successfu	to by EEADR w at the complet urely (by device ully nory	ion of the erase		cycle. No writ	
bit 3 bit 2	 Programwill be point Perform WRERR: Write A write Write o WREN: Write Allows Inhibits WR: Write C 	m memory row b performed. This n write only ite Error Flag bit operation termin peration comple e Enable bit write cycle to Fla write cycle to Fla ontrol bit	eing pointed bit is cleared nated premati ted successfi ash data men ash data mer	to by EEADR w at the complet urely (by device ully nory	ion of the erase		cycle. No writ	
bit 3 bit 2	 Programwill be point Perform WRERR: Write A write Write o WREN: Write Allows Inhibits WR: Write C Initiate 	m memory row b performed. This n write only ite Error Flag bit operation termin peration comple e Enable bit write cycle to Fla write cycle to Fla	eing pointed bit is cleared nated premati ted successfu ash data men ash data mer cycle	to by EEADR w at the complet urely (by device ully nory	ion of the erase		cycle. No writ	
bit 3 bit 2	 Programwill be point Perform WRERR: Write A write Write o WREN: Write Allows Inhibits WR: Write C Initiate 	m memory row b performed. This n write only ite Error Flag bit operation termin peration complete Enable bit write cycle to Fla write cycle to Fla ontrol bit a erase or write trase cycle is cor	eing pointed bit is cleared nated premati ted successfu ash data men ash data mer cycle	to by EEADR w at the complet urely (by device ully nory	ion of the erase		cycle. No writ	
bit 3 bit 2 bit 1	 Programwill be point will be point with the point will be point with the point will be point will	m memory row b performed. This n write only ite Error Flag bit operation termin peration complete Enable bit write cycle to Fla write cycle to Fla ontrol bit a erase or write trase cycle is cor	eing pointed bit is cleared nated prematu ted successfu ash data men ash data men cycle mplete	to by EEADR w at the complet urely (by device ully nory mory	ion of the erase		cycle. No writ	

EECON ELASH CONTROL DECISTED DECISTED 5.3.

Code Protection Code protection does not prevent the CPU from

5.4

performing read or write operations on the Flash data memory. Refer to the code protection chapter for more information.

NOTES:

6.0 I/O PORT

As with any other register, the I/O register(s) can be written and read under program control. However, read instructions (e.g., MOVF PORTB, W) always read the I/O pins independent of the pin's Input/Output modes. On Reset, all I/O ports are defined as input (inputs are at high-impedance) since the I/O control registers are all set.

6.1 PORTB

PORTB is a 6-bit I/O register. Only the low-order 6 bits are used (RB<5:0>). Bits 7 and 6 are unimplemented and read as '0's. Please note that RB3 is an input-only pin. The Configuration Word can set several I/O's to alternate functions. When acting as alternate functions, the pins will read as '0' during a port read. Pins RB0, RB1, RB3 and RB4 can be configured with weak pullups and also for wake-up on change. The wake-up on change and weak pull-up functions are not pin selectable. If RB3/MCLR is configured as MCLR, weak pull-up is always on and wake-up on change for this pin is not enabled.

6.2 PORTC

PORTC is a 6-bit I/O register. Only the low-order 6 bits are used (RC<5:0>). Bits 7 and 6 are unimplemented and read as '0's.

6.3 TRIS Register

The Output Driver Control register is loaded with the contents of the W register by executing the TRIS f instruction. A '1' from a TRIS register bit puts the corresponding output driver in a High-Impedance mode. A '0' puts the contents of the output data latch on the selected pins, enabling the output buffer. The exceptions are RB3, which is input-only and the TOCKI pin, which may be controlled by the OPTION register. See Register 4-2.

TRIS registers are "write-only". Active bits in these registers are set (output drivers disabled) upon Reset.

TABLE 6-1: WEAK PULL-UP ENABLED PINS

Device	RB0 Weak Pull-up	RB1 Weak Pull-up	RB3 Weak Pull-up ⁽¹⁾	RB4 Weak Pull-up
PIC16F526	Yes	Yes	Yes	Yes

Note 1: When MCLREN = 1, the weak pull-up on RB3/MCLR is always enabled.

U-0	U-0	R/W-x	R/W-x	R/W-x	R/W-x	R/W-x	R/W-x
_	_	RB5	RB4	RB3	RB2	RB1	RB0
bit 7							bit 0

REGISTER 6-1: PORTB: PORTB REGISTER

Legend:			
R = Readable bit	W = Writable bit	U = Unimplemented bit,	read as '0'
-n = Value at POR	'1' = Bit is set	'0' = Bit is cleared	x = Bit is unknown

bit 7-6 Unimplemented: Read as '0'

bit 5-0 **RB<5:0>**: PORTB I/O Pin bits

1 = Port pin is >VIH min.

0 = Port pin is <VI∟ max.

REGISTER 6-2: PORTC: PORTC REGISTER

RC5 RC4	RC3 RC2	RC1	DCO
		1.01	RC0
		·	bit 0
<pre>/ = Writable bit</pre>	U = Unimplemented bit, re	ad as '0'	
' = Bit is set	'0' = Bit is cleared	x = Bit is unkr	Iown
	/ = Writable bit ' = Bit is set	•	

bit 7-6 Unimplemented: Read as '0'

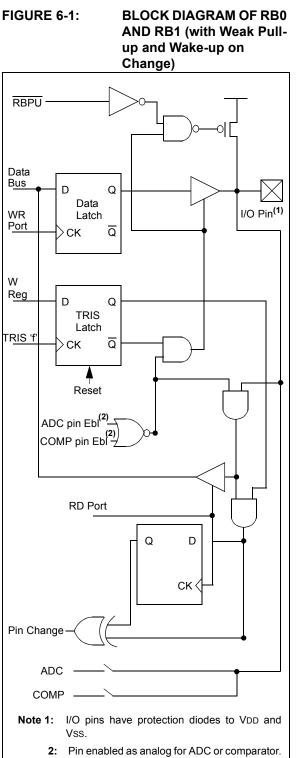
bit 5-0 RC<5:0>: PORTC I/O Pin bits

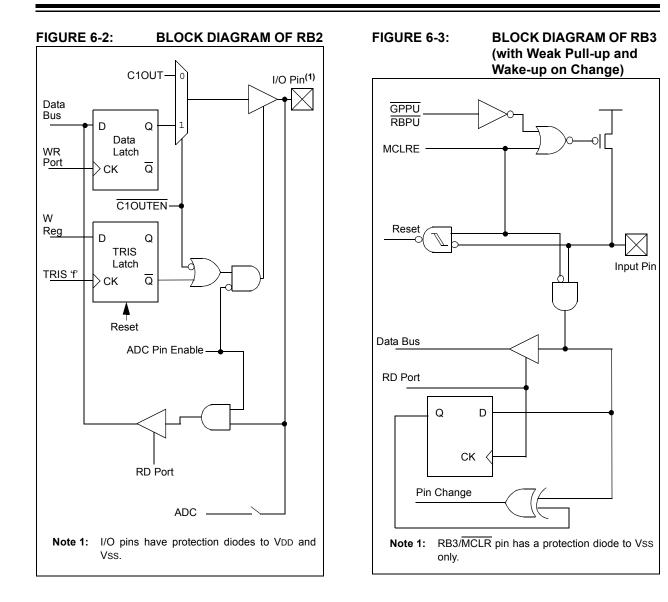
1 = Port pin is >VIH min.

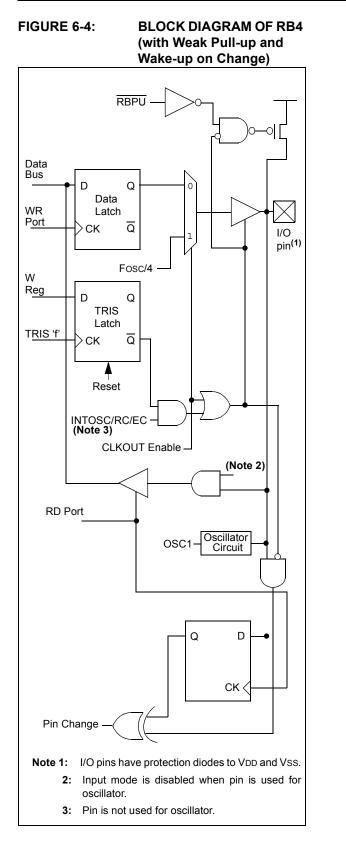
0 = Port pin is <VIL max.

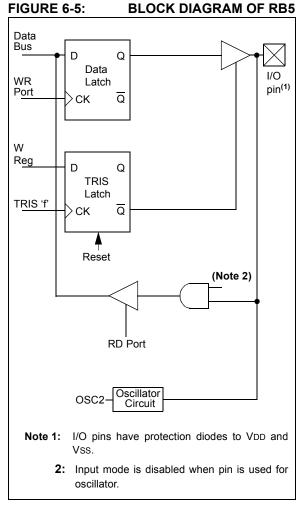
6.4 I/O Interfacing

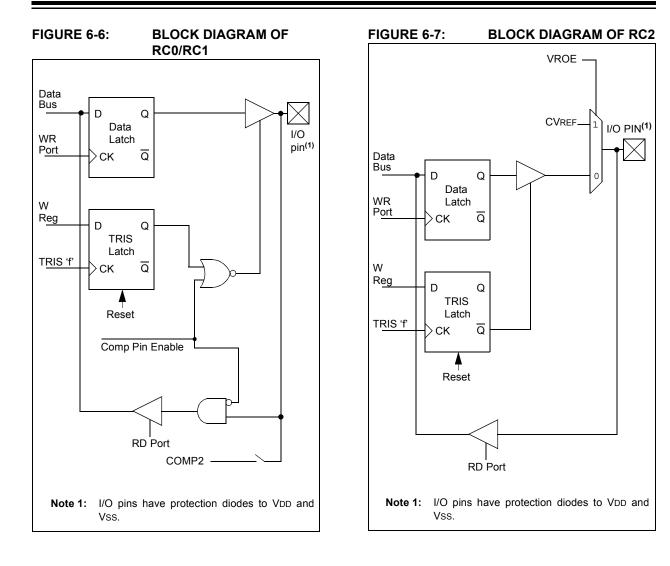
The equivalent circuit for an I/O port pin is shown in Figure 6-1. All port pins, except RB3 which is inputonly, may be used for both input and output operations. For input operations, these ports are non-latching. Any input must be present until read by an input instruction (e.g., MOVF PORTB, W). The outputs are latched and remain unchanged until the output latch is rewritten. To use a port pin as output, the corresponding direction control bit in TRIS must be cleared (= 0). For use as an input, the corresponding TRIS bit must be set. Any I/O pin (except RB3) can be programmed individually as input or output.

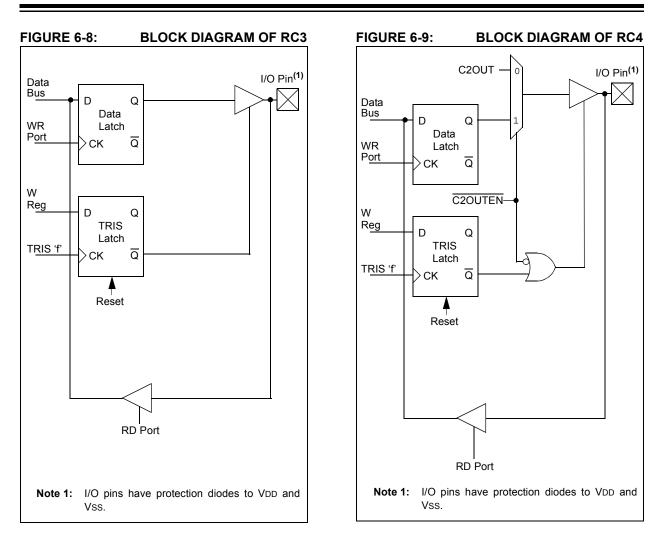














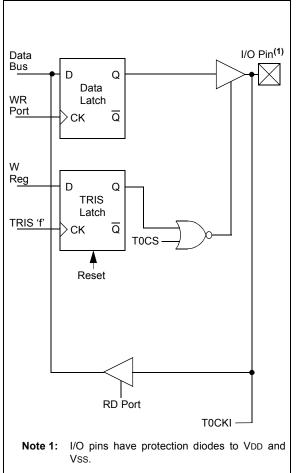


TABLE 6-2: SUMMARY OF PORT REGISTERS

Addr	Name	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	Value on Power-On Reset	Value on All Other Resets
N/A	TRIS		_	I/O Cont	rol Regis	ster (PO	RTB, P	ORTC)		11 1111	11 1111
N/A	OPTION	RBWU	RBPU	TOCS	TOSE	PSA	PS2	PS1	PS0	1111 1111	1111 1111
03h	STATUS	RBWUF	CWUF	PA0	TO	PD	Z	DC	С	0001 1xxx	qq0q quuu (1)
06h	PORTB	_	_	RB5	RB4	RB3	RB2	RB1	RB0	xx xxxx	uu uuuu
07h	PORTC		_	RC5	RC4	RC3	RC2	RC1	RC0	xx xxxx	uu uuuu

Legend: Shaded cells are not used by PORT registers, read as '0'. – = unimplemented, read as '0', x = unknown, u = unchanged,

q = depends on condition.

Note 1: If Reset was due to wake-up on pin change, then bit 7 = 1. All other Resets will cause bit 7 = 0.

TABLE 6-3: I/O PINS ORDER OF PRECEDENCE

Priority	RB0	RB1	RB2	RB3	RC0	RC1	RC2	RC4	RC5
1	AN0	AN1	AN2	RB3/MCLR	C2IN+	C2IN-	CVREF	C2OUT	T0CKI
2	C1IN+	C1IN-	C10UT	—	TRISC	TRISC	TRISC	TRISC	TRISC
3	TRISB	TRISB	TRISB		_				

6.5 I/O Programming Considerations

6.5.1 BIDIRECTIONAL I/O PORTS

Some instructions operate internally as read followed by write operations. The BCF and BSF instructions, for example, read the entire port into the CPU, execute the bit operation and rewrite the result. Caution must be used when these instructions are applied to a port where one or more pins are used as input/outputs. For example, a BSF operation on bit 5 of PORTB will cause all eight bits of PORTB to be read into the CPU, bit 5 to be set and the PORTB value to be written to the output latches. If another bit of PORTB is used as a bidirectional I/O pin (say bit 0) and it is defined as an input at this time, the input signal present on the pin itself would be read into the CPU and rewritten to the data latch of this particular pin, overwriting the previous content. As long as the pin stays in the Input mode, no problem occurs. However, if bit 0 is switched into Output mode later on, the content of the data latch may now be unknown.

Example 6-1 shows the effect of two sequential Read-Modify-Write instructions (e.g., BCF, BSF, etc.) on an I/O port.

A pin actively outputting a high or a low should not be driven from external devices at the same time in order to change the level on this pin ("wired OR", "wired AND"). The resulting high output currents may damage the chip.

EXAMPLE 6-1: READ-MODIFY-WRITE INSTRUCTIONS ON AN I/O PORT(e.g. DSTEMP)

;Initial PORTB Se ;PORTB<5:3> Input ;PORTB<2:0> Output	ts	
;;;;;;;;;;;;;;;;;;;;;;;;;;;;;;;;;;;;;;;	PORTB latch PORTB pins	
,	;01 -ppp11 pppp ;10 -ppp11 pppp	
TRIS PORTB	;10 -ppp11 pppp	
be '00	may have expected the pin values to pppp'. The 2nd BCF caused RB5 to as the pin value (High).	

6.5.2 SUCCESSIVE OPERATIONS ON I/O PORTS

The actual write to an I/O port happens at the end of an instruction cycle, whereas for reading, the data must be valid at the beginning of the instruction cycle (Figure 6-11). Therefore, care must be exercised if a write followed by a read operation is carried out on the same I/O port. The sequence of instructions should allow the pin voltage to stabilize (load dependent) before the next instruction causes that file to be read into the CPU. Otherwise, the previous state of that pin may be read into the CPU rather than the new state. When in doubt, it is better to separate these instructions with a NOP or another instruction not accessing this I/O port.

	PC	X PC + 1	PC + 2	PC + 3	This example shows a write to POI
Struction Fetched	MOVWF PORTB	MOVF PORTB, W	NOP	NOP	followed by a read from PORTB. Data setup time = (0.25 Tcy – TPD) where: Tcy = instruction cycle.
R8<5:0>		<u> </u>	X:;		TPD = propagation delay
		Port pin written here	Port pin sampled here		Therefore, at higher clock frequencies, a write followed by a read may be problema
nstruction Executed		MOVWF PORTB (Write to PORTB)	MOVF PORTB,W (Read PORTB)	NOP	
1		1 I	1		

FIGURE 6-11: SUCCESSIVE I/O OPERATION

7.0 TIMER0 MODULE AND TMR0 REGISTER

The Timer0 module has the following features:

- 8-bit timer/counter register, TMR0
- Readable and writable
- 8-bit software programmable prescaler
- · Internal or external clock select:
- Edge select for external clock

Figure 7-1 is a simplified block diagram of the Timer0 module.

Timer mode is selected by clearing the T0CS bit of the OPTION register. In Timer mode, the Timer0 module will increment every instruction cycle (without prescaler). If TMR0 register is written, the increment is inhibited for the following two cycles (Figure 7-2 and Figure 7-3). The user can work around this by writing an adjusted value to the TMR0 register.

There are two types of Counter mode. The first Counter mode uses the T0CKI pin to increment Timer0. It is selected by setting the T0CS bit of the OPTION register, setting the <u>C1T0CS</u> bit of the CM1CON0 register and setting the <u>C1OUTEN</u> bit of the CM1CON0 register. In this mode, Timer0 will increment either on every rising or falling edge of pin T0CKI. The T0SE bit of the OPTION register determines the source edge. Clearing the T0SE bit selects the rising edge. Restrictions on the external clock input are discussed in detail in **Section 7.1 "Using Timer0 with an External Clock"**.

The second Counter mode uses the output of the comparator to increment Timer0. It can be entered in two different ways. The first way is selected by setting the T0CS bit of the OPTION register, and clearing the C1T0CS bit of the CM1CON0 register (C10UTEN [CM1CON0<6>] does not affect this mode of operation). This enables an internal connection between the comparator and the Timer0.

The prescaler may be used by either the Timer0 module or the Watchdog Timer, but not both. The prescaler assignment is controlled in software by the control bit, PSA of the OPTION register. Clearing the PSA bit will assign the prescaler to Timer0. The prescaler is not readable or writable. When the prescaler is assigned to the Timer0 module, prescale values of 1:2, 1:4,..., 1:256 are selectable. **Section 7.2 "Prescaler"** details the operation of the prescaler.

A summary of registers associated with the Timer0 module is found in Table 7-1.

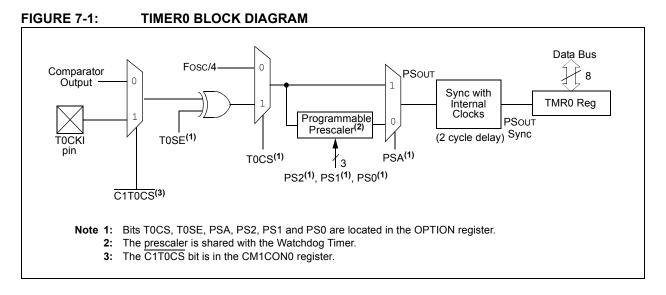


FIGURE 7-2: TIMER0 TIMING: INTERNAL CLOCK/NO PRESCALE

PC (Program	Q1 Q2 Q3 Q4	Q1 Q2 Q3 Q4	Q1 Q2 Q3 Q4	Q1 Q2 Q3 Q4	Q1 Q2 Q3 Q4			
Counter)	(PC – 1	PC	Y PC + 1	PC + 2	(PC + 3)	(PC + 4	PC + 5	(PC + 6
Instruction Fetch	1 1 1	MOVWF TMR0	MOVF TMR0,W	MOVF TMR0,W	MOVF TMR0,W	MOVF TMR0,W	MOVF TMR0,W	
	1		1	1				· · ·
Timer0	(то)	Τ0 + 1 /	T0 + 2	 	NTO X	χ	NT0 + 1	NT0 + 2
Instruction	1	1 1	1	. ▲		•	. ▲	i 🖌 👘 🕴

FIGURE 7-3: TIMER0 TIMING: INTERNAL CLOCK/PRESCALE 1:2

(Program Counter)	PC – 1	<u>)</u> РС	(PC + 1	PC + 2	PC + 3	PC + 4	(PC + 5	PC + 6
Instruction Fetch	1 1 1	MOVWF TMR0	MOVF TMR0,W	, , , ,				
īmer0		T0 + 1			NT0	1 1 1		NT0 + 1
nstruction Executed	1 1 1 1		Write TMR0 executed	Read TMR0 reads NT0	Read TMR0 reads NT0	Read TMR0 reads NT0	Read TMR0 reads NT0 + 1	Read TMR0 reads NT0 + 2

TABLE 7-1: **REGISTERS ASSOCIATED WITH TIMER0**

Addr	Name	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	Value on Power-On Reset	Value on All Other Resets
01h	TMR0	Timer0 – 8	imer0 – 8-bit Real-Time Clock/Counter						XXXX XXXX	uuuu uuuu	
08h	CM1CON0	C10UT	C10UTEN	C1POL	C1T0CS	C10N	C1NREF	C1PREF	C1WU	1111 1111	uuuu uuuu
0Bh	CM2CON0	C2OUT	C2OUTEN	C2POL	C2PREF2	C2ON	C2NREF	C2PREF1	C2WU	1111 1111	uuuu uuuu
N/A	OPTION	RBWU	RBPU	TOCS	T0SE	PSA	PS2	PS1	PS0	1111 1111	1111 1111
N/A	TRIS ⁽¹⁾	_	_	I/O Control Register (PORTB, PORTC)				11 1111	11 1111		

Shaded cells are not used by Timer0. – = unimplemented, $x_{\rm c}$ = unknown, $u_{\rm c}$ = unchanged. The TRIS of the T0CKI pin is overridden when T0CS = 1. Legend:

Note 1:

7.1 Using Timer0 with an External Clock

When an external clock input is used for Timer0, it must meet certain requirements. The external clock requirement is due to internal phase clock (Tosc) synchronization. Also, there is a delay in the actual incrementing of Timer0 after synchronization.

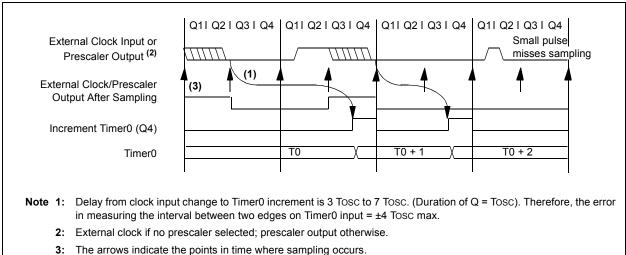
7.1.1 EXTERNAL CLOCK SYNCHRONIZATION

When no prescaler is used, the external clock input is the same as the prescaler output. The synchronization of T0CKI with the internal phase clocks is accomplished by sampling the prescaler output on the Q2 and Q4 cycles of the internal phase clocks (Figure 7-4). Therefore, it is necessary for T0CKI to be high for at least 2 Tosc (and a small RC delay of 2 Tt0H) and low for at least 2 Tosc (and a small RC delay of 2 Tt0H). Refer to the electrical specification of the desired device. When a prescaler is used, the external clock input is divided by the asynchronous ripple counter-type prescaler, so that the prescaler output is symmetrical. For the external clock to meet the sampling requirement, the ripple counter must be taken into account. Therefore, it is necessary for TOCKI to have a period of at least 4 Tosc (and a small RC delay of 4 TtOH) divided by the prescaler value. The only requirement on TOCKI high and low time is that they do not violate the minimum pulse width requirement of TtOH. Refer to parameters 40, 41 and 42 in the electrical specification of the desired device.

7.1.2 TIMER0 INCREMENT DELAY

Since the prescaler output is synchronized with the internal clocks, there is a small delay from the time the external clock edge occurs to the time the Timer0 module is actually incremented. Figure 7-4 shows the delay from the external clock edge to the timer incrementing.





7.2 Prescaler

An 8-bit counter is available as a prescaler for the Timer0 module or as a postscaler for the Watchdog Timer (WDT), respectively (see **Section 8.6** "Watchdog Timer (WDT)"). For simplicity, this counter is being referred to as "prescaler" throughout this data sheet.

Note:	The prescaler may be used by either the Timer0 module or the WDT, but not both.
	Thus, a prescaler assignment for the Timer0 module means that there is no
	prescaler for the WDT and vice versa.

The PSA and PS<2:0> bits of the OPTION register determine prescaler assignment and prescale ratio.

When assigned to the Timer0 module, all instructions writing to the TMR0 register (e.g., CLRF TMR0, MOVWF TMR0, etc.) will clear the prescaler. When assigned to WDT, a CLRWDT instruction will clear the prescaler along with the WDT. The prescaler is neither readable nor writable. On a Reset, the prescaler contains all '0's.

7.2.1 SWITCHING PRESCALER ASSIGNMENT

The prescaler assignment is fully under software control (i.e., it can be changed "on-the-fly" during program execution). To avoid an unintended device Reset, the following instruction sequence (Example 7-1) must be executed when changing the prescaler assignment from Timer0 to the WDT.

EXAMPLE 7-1: CHANGING PRESCALER (TIMER0 \rightarrow WDT)

CLRWDT		;Clear WDT
CLRF	TMR0	;Clear TMR0 & Prescaler
MOVLW	b'00xx1111'	
CLRWDT		;PS<2:0> are 000 or 001
MOVLW	b'00xx1xxx'	;Set Postscaler to
OPTION		;desired WDT rate

To change the prescaler from the WDT to the Timer0 module, use the sequence shown in Example 7-2. This sequence must be used even if the WDT is disabled. A CLRWDT instruction should be executed before switching the prescaler.

EXAMPLE 7-2:	CHANGING PRESCALER
	(WDT \rightarrow TIMER0)

CLRWDT		;Clear WDT and
		;prescaler
MOVLW b	'xxxx0xxx'	;Select TMR0, new
		;prescale value and
		;clock source
OPTION		

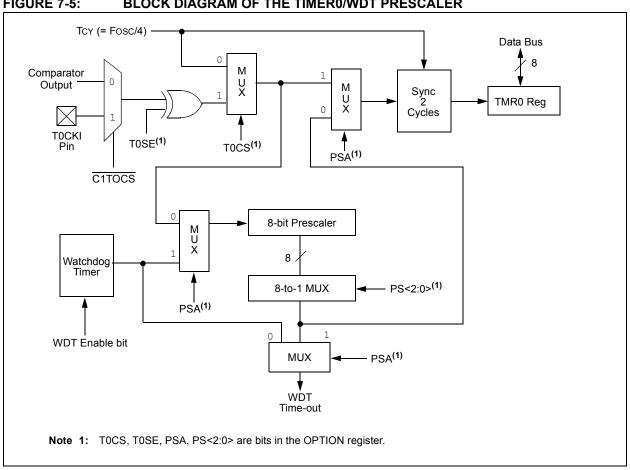


FIGURE 7-5: **BLOCK DIAGRAM OF THE TIMER0/WDT PRESCALER**

NOTES:

8.0 SPECIAL FEATURES OF THE CPU

What sets a microcontroller apart from other processors are special circuits that deal with the needs of real-time applications. The PIC16F526 microcontrollers have a host of such features intended to maximize system reliability, minimize cost through elimination of external components, provide power-saving operating modes and offer code protection. These features are:

- Oscillator Selection
- Reset:
 - Power-on Reset (POR)
 - Device Reset Timer (DRT)
 - Wake-up from Sleep on Pin Change
- Watchdog Timer (WDT)
- Sleep
- Code Protection
- · ID Locations
- In-Circuit Serial Programming[™]
- Clock Out

The PIC16F526 device has a Watchdog Timer, which can be shut off only through Configuration bit WDTE. It runs off of its own RC oscillator for added reliability. If using HS, XT or LP selectable oscillator options, there is always an 18 ms (nominal) delay provided by the Device Reset Timer (DRT), intended to keep the chip in Reset until the crystal oscillator is stable. If using INTRC or EXTRC, there is a 1 ms delay only on VDD power-up. With this timer on-chip, most applications need no external Reset circuitry.

The Sleep mode is designed to offer a very low current Power-Down mode. The user can wake-up from Sleep through a change on input pins or through a Watchdog Timer time-out. Several oscillator options are also made available to allow the part to fit the application, including an internal 4/8 MHz oscillator. The EXTRC oscillator option saves system cost while the LP crystal option saves power. A set of Configuration bits are used to select various options.

8.1 Configuration Bits

The PIC16F526 Configuration Words consist of 12 bits. Configuration bits can be programmed to select various device configurations. Three bits are for the selection of the oscillator type; one bit is the Watchdog Timer enable bit, one bit is the MCLR enable bit and one bit is for code protection (Register 8-1).

REGISTER 8-1: CONFIG: CONFIGURATION WORD REGISTER

CPDF	IOSCFS	MCLRE	CP	WDTE	FOSC2	FOSC1	FOSC0
bit 7	100010	MOLILE	01	WDIE	10002	10001	bit 0
bit 7	CPDF : Code 1 = Code prot 0 = Code prot		Flash Data N	lemory			
bit 6	1 = 8 MHz IN	rnal Oscillator I TOSC frequend TOSC frequend	cy c	lect bit			
bit 5	1 = RB3/MCL	ter Clear Enab R pin functions R pin functions	as MCLR	_R internally tio	ed to VDD		
bit 4	1 = Code prot	CP : Code Protection bit – User Program Memory 1 = Code protection off 0 = Code protection on					
bit 3	1 = WDT enal	WDTE: Watchdog Timer Enable bit 1 = WDT enabled 0 = WDT disabled					
bit 2-0	000 = LP osc 001 = XT osc 010 = HS osc 011 = EC osc 100 = INTRC 101 = INTRC 110 = EXTRC	FOSC<2:0>: Oscillator Selection bits 000 = LP oscillator and 18 ms DRT 001 = XT oscillator and 18 ms DRT 010 = HS oscillator and 18 ms DRT 011 = EC oscillator and 18 ms DRT 011 = EC oscillator with RB4 function on RB4/OSC2/CLKOUT and 1 ms DRT ⁽¹⁾ 100 = INTRC with RB4 function on RB4/OSC2/CLKOUT and 1 ms DRT ⁽¹⁾ 101 = INTRC with CLKOUT function on RB4/OSC2/CLKOUT and 1 ms DRT ⁽¹⁾ 110 = EXTRC with RB4 function on RB4/OSC2/CLKOUT and 1 ms DRT ⁽¹⁾ 111 = EXTRC with RB4 function on RB4/OSC2/CLKOUT and 1 ms DRT ⁽¹⁾ 111 = EXTRC with CLKOUT function on RB4/OSC2/CLKOUT and 1 ms DRT ⁽¹⁾					
Note 1:	Refer to the "PIC: Configuration Wor		y Programmir	ng Specificatio	<i>n</i> ", DS41317 to	determine how	to access the

2: DRT length (18 ms or 1 ms) is a function of Clock mode selection. It is the responsibility of the application designer to ensure the use of either 18 ms (nominal) DRT or the 1 ms (nominal) DRT will result in acceptable operation. Refer to Section 14.1 "DC Characteristics: PIC16F526 (Industrial)" and Section 14.2 "DC Characteristics: PIC16F526 (Extended)" for VDD rise time and stability requirements for this mode of operation.

8.2 Oscillator Configurations

8.2.1 OSCILLATOR TYPES

The PIC16F526 device can be operated in up to six different oscillator modes. The user can program up to three Configuration bits (FOSC<2:0>). To select one of these modes:

- LP: Low-Power Crystal
- XT: Crystal/Resonator
- HS: High-Speed Crystal/Resonator
- INTRC: Internal 4/8 MHz Oscillator
- · EXTRC: External Resistor/Capacitor
- EC: External High-Speed Clock Input

8.2.2 CRYSTAL OSCILLATOR/CERAMIC RESONATORS

In HS, XT or LP modes, a crystal or ceramic resonator is connected to the RB5/OSC1/CLKIN and RB4/OSC2/ CLKOUT pins to establish oscillation (Figure 8-1). The PIC16F526 oscillator designs require the use of a parallel cut crystal. Use of a series cut crystal may give a frequency out of the crystal manufacturers specifications. When in HS, XT or LP modes, the device can have an external clock source drive the RB5/OSC1/CLKIN pin (Figure 8-2). In this mode, the output drive levels on the OSC2 pin are very weak. If the part is used in this fashion, then this pin should be left open and unloaded. Also when using this mode, the external clock should observe the frequency limits for the Clock mode chosen (HS, XT or LP).

- Note 1: This device has been designed to perform to the parameters of its data sheet. It has been tested to an electrical specification designed to determine its conformance with these parameters. Due to process differences in the manufacture of this device, this device may have different performance characteristics than its earlier version. These differences may cause this device to perform differently in your application than the earlier version of this device.
 - 2: The user should verify that the device oscillator starts and performs as expected. Adjusting the loading capacitor values and/or the Oscillator mode may be required.

FIGURE 8-1:

CRYSTAL OPERATION (OR CERAMIC RESONATOR) (HS, XT OR LP OSC CONFIGURATION)

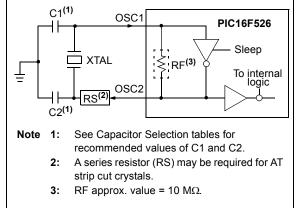


FIGURE 8-2:

EXTERNAL CLOCK INPUT OPERATION (HS, XT, LP OR EC OSC CONFIGURATION)

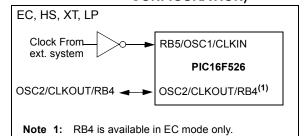


TABLE 8-1:CAPACITOR SELECTION FOR
CERAMIC RESONATORS

Osc Type	Resonator Freq.	Cap. Range C1	Cap. Range C2			
XT	4.0 MHz	30 pF	30 pF			
HS	16 MHz	10-47 pF	10-47 pF			
Note 1:	only. Since on characterist the resonate	These values are for design guidance only. Since each resonator has its own characteristics, the user should consult the resonator manufacturer for appropriate values of external				

TABLE 8-2: CAPACITOR SELECTION FOR CRYSTAL OSCILLATOR⁽²⁾

Osc Type	Resonator Freq.	Cap. Range C1	Cap. Range C2		
LP	32 kHz ⁽¹⁾	15 pF	15 pF		
ХТ	200 kHz 1 MHz 4 MHz	47-68 pF 15 pF 15 pF	47-68 pF 15 pF 15 pF		
HS	20 MHz	15-47 pF	15-47 pF		
Note 1:	For VDD > 4.5V, C1 = C2 \approx 30 pF is recommended.				
2:	These values are for design guidance only. Rs may be required to avoid over- driving crystals with low drive level specifi- cation. Since each crystal has its own characteristics, the user should consult				

8.2.3 EXTERNAL CRYSTAL OSCILLATOR CIRCUIT

the crystal manufacturer for appropriate values of external components.

Either a prepackaged oscillator or a simple oscillator circuit with TTL gates can be used as an external crystal oscillator circuit. Prepackaged oscillators provide a wide operating range and better stability. A well-designed crystal oscillator will provide good performance with TTL gates. Two types of crystal oscillator circuits can be used: one with parallel resonance, or one with series resonance.

Figure 8-3 shows implementation of a parallel resonant oscillator circuit. The circuit is designed to use the fundamental frequency of the crystal. The 74AS04 inverter performs the 180-degree phase shift that a parallel oscillator requires. The 4.7 k Ω resistor provides the negative feedback for stability. The 10 k Ω potentiometers bias the 74AS04 in the linear region. This circuit could be used for external oscillator designs.

FIGURE 8-3: EXTERNAL PARALLEL RESONANT CRYSTAL OSCILLATOR CIRCUIT

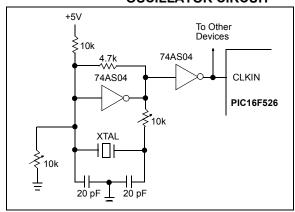
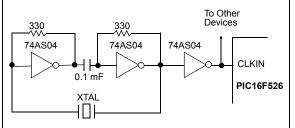


Figure 8-4 shows a series resonant oscillator circuit. This circuit is also designed to use the fundamental frequency of the crystal. The inverter performs a 180-degree phase shift in a series resonant oscillator circuit. The 330 Ω resistors provide the negative feedback to bias the inverters in their linear region.





8.2.4 EXTERNAL RC OSCILLATOR

For timing insensitive applications, the RC device option offers additional cost savings. The RC oscillator frequency is a function of the supply voltage, the resistor (REXT) and capacitor (CEXT) values, and the operating temperature. In addition to this, the oscillator frequency will vary from unit-to-unit due to normal process parameter variation. Furthermore, the difference in lead frame capacitance between package types will also affect the oscillation frequency, especially for low CEXT values. The user also needs to take into account variation due to tolerance of external R and C components used.

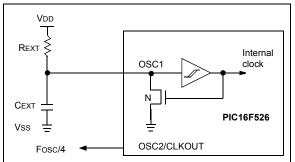
Figure 8-5 shows how the R/C combination is connected to the PIC16F526 device. For REXT values below 3.0 k Ω , the oscillator operation may become unstable, or stop completely. For very high REXT values (e.g., 1 M Ω), the oscillator becomes sensitive to noise, humidity and leakage. Thus, we recommend keeping REXT between 5.0 k Ω and 100 k Ω .

Although the oscillator will operate with no external capacitor (CEXT = 0 pF), we recommend using values above 20 pF for noise and stability reasons. With no or small external capacitance, the oscillation frequency can vary dramatically due to changes in external capacitances, such as PCB trace capacitance or package lead frame capacitance.

Section 14.0 "Electrical Characteristics" shows RC frequency variation from part-to-part due to normal process variation. The variation is larger for larger values of R (since leakage current variation will affect RC frequency more for large R) and for smaller values of C (since variation of input capacitance will affect RC frequency more).

Also, see the Electrical Specifications section for variation of oscillator frequency due to VDD for given REXT/CEXT values, as well as frequency variation due to operating temperature for given R, C and VDD values.

FIGURE 8-5: EXTERNAL RC OSCILLATOR MODE



8.2.5 INTERNAL 4/8 MHz RC OSCILLATOR

The internal RC oscillator provides a fixed 4/8 MHz (nominal) system clock at VDD = 5V and $25^{\circ}C$, (see **Section 14.0** "**Electrical Characteristics**" for information on variation over voltage and temperature).

In addition, a calibration instruction is programmed into the last address of memory, which contains the calibration value for the internal RC oscillator. This location is always non-code protected, regardless of the codeprotect settings. This value is programmed as a MOVLW XX instruction where XX is the calibration value, and is placed at the Reset vector. This will load the W register with the calibration value upon Reset and the PC will then roll over to the users program at address 0x000. The user then has the option of writing the value to the OSCCAL Register (05h) or ignoring it.

OSCCAL, when written to with the calibration value, will "trim" the internal oscillator to remove process variation from the oscillator frequency.

Note: Erasing the device will also erase the preprogrammed internal calibration value for the internal oscillator. The calibration value must be read prior to erasing the part so it can be reprogrammed correctly later.

For the PIC16F526 device, only bits 7:1 of OSCCAL are used for calibration. See Register 4-3 for more information.

Note: The bit 0 of the OSCCAL register is unimplemented and should be written as '0' when modifying OSCCAL for compatibility with future devices.

8.3 Reset

The device differentiates between various kinds of Reset:

- Power-on Reset (POR)
- MCLR Reset during normal operation
- MCLR Reset during Sleep
- WDT Time-out Reset during normal operation
- WDT Time-out Reset during Sleep
- · Wake-up from Sleep on pin change

Some registers are not reset in any way, they are unknown on POR and unchanged in any other Reset. Most other registers are reset to "Reset state" on Power-on Reset (POR), MCLR, WDT or Wake-up on pin change Reset during normal operation. They are not affected by a WDT Reset during Sleep or MCLR Reset during Sleep, since these Resets are viewed as resumption of normal operation. The exceptions to this are TO, PD and RBWUF bits. They are set or cleared differently in different Reset situations. These bits are used in software to determine the nature of Reset. See Table 8-3 for a full description of Reset states of all registers.

Register	Address	Power-on Reset	MCLR Reset, WDT Time-out, Wake-up On Pin Change
W	_	qqqq qqq0 ⁽¹⁾	qqqq qqq0 ⁽¹⁾
INDF	00h	XXXX XXXX	սսսս սսսս
TMR0	01h	XXXX XXXX	սսսս սսսս
PCL	02h	1111 1111	1111 1111
STATUS	03h	0001 1xxx	qq0q quuu ⁽²⁾
FSR	04h	100x xxxx	1uuu uuuu
OSCCAL	05h	1111 111-	uuuu uuu-
PORTB	06h	xx xxxx	uu uuuu
PORTC	07h	xx xxxx	uu uuuu
CMICON0	08h	q111 1111	quuu uuuu
ADCON0	09h	1111 1100	1111 1100
ADRES	0Ah	XXXX XXXX	นนนน นนนน
CM2CON0	0Bh	q111 1111	quuu uuuu
VRCON	0Ch	001-1111	นนน-นนนน
OPTION	-	1111 1111	1111 1111
TRISB	-	11 1111	11 1111
TRISC	-	11 1111	11 1111
EECON	21h/61h	0 x000	0 q000
EEDATA	25h/65h	XXXX XXXX	սսսս սսսս
EEADR	26h/66h	xx xxxx	uu uuuu

TABLE 8-3: RESET CONDITIONS FOR REGISTERS

Legend: u = unchanged, x = unknown, – = unimplemented bit, read as '0', q = value depends on condition.

Note 1: Bits <7:1> of W register contain oscillator calibration values due to MOVLW XX instruction at top of memory.

2: See Table 8-4 for Reset value for specific conditions.

TABLE 8-4: RESET CONDITION FOR SPECIAL REGISTERS

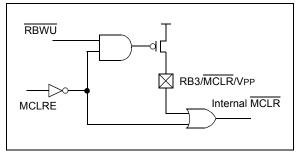
	STATUS Addr: 03h
Power-on Reset	0001 1xxx
MCLR Reset during normal operation	000u uuuu
MCLR Reset during Sleep	0001 Ouuu
WDT Reset during Sleep	0000 Ouuu
WDT Reset normal operation	0000 uuuu
Wake-up from Sleep on pin change	1001 Ouuu
Wake-up from Sleep on comparator change	0101 0uuu

Legend: u = unchanged, x = unknown, – = unimplemented bit, read as '0'.

8.3.1 MCLR ENABLE

This Configuration bit, when unprogrammed (left in the '1' state), enables the external MCLR function. When programmed, the MCLR function is tied to the internal VDD and the pin is assigned to be a I/O. See Figure 8-6.

FIGURE 8-6: MCLR SELECT



8.4 Power-on Reset (POR)

The PIC16F526 device incorporates an on-chip Poweron Reset (POR) circuitry, which provides an internal chip Reset for most power-up situations.

The on-chip POR circuit holds the chip in Reset until VDD has reached a high enough level for proper operation. To take advantage of the internal POR, program the RB3/MCLR/VPP pin as MCLR and tie through a resistor to VDD, or program the pin as RB3. An internal weak pull-up resistor is implemented using a transistor (refer to Table 14-5 for the pull-up resistor ranges). This will eliminate external RC components usually needed to create a Power-on Reset. A maximum rise time for VDD is specified. See Section 14.0 "Electrical Characteristics" for details.

When the device starts normal operation (exit the Reset condition), device operating parameters (volt-age, frequency, temperature,...) must be met to ensure operation. If these conditions are not met, the device must be held in Reset until the operating parameters are met.

A simplified block diagram of the on-chip Power-on Reset circuit is shown in Figure 8-7.

The Power-on Reset circuit and the Device Reset Timer (see **Section 8.5 "Device Reset Timer (DRT)**") circuit are closely related. On power-up, the Reset latch is set and the DRT is reset. The DRT timer begins counting once it detects MCLR to be high. After the time-out period, which is typically 18 ms or 1 ms, it will reset the Reset latch and thus end the on-chip Reset signal.

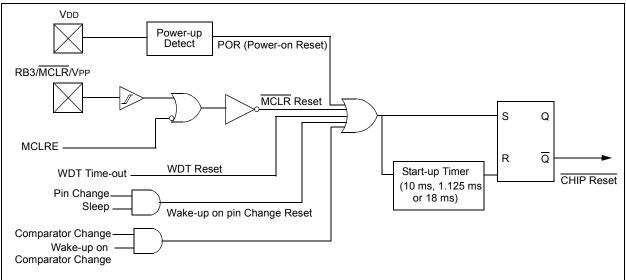
A power-up example where MCLR is held low is shown in Figure 8-8. VDD is allowed to rise and stabilize before bringing MCLR high. The chip will actually come out of Reset TDRT msec after MCLR goes high.

In Figure 8-9, the on-chip Power-on Reset feature is being used (MCLR and VDD are tied together or the pin is programmed to be RB3. The VDD is stable before the start-up timer times out and there is no problem in getting a proper Reset. However, Figure 8-10 depicts a problem situation where VDD rises too slowly. The time between when the DRT senses that MCLR is high and when MCLR and VDD actually reach their full value, is too long. In this situation, when the start-up timer times out, VDD has not reached the VDD (min) value and the chip may not function correctly. For such situations, we recommend that external RC circuits be used to achieve longer POR delay times (Figure 8-9).

Note:	When the device starts normal operation (exit the Reset condition), device operat- ing parameters (voltage, frequency, tem- perature, etc.) must be met to ensure operation. If these conditions are not met, the device must be held in Reset until the
	operating conditions are met.

For additional information, refer to Application Notes AN522 *"Power-Up Considerations"* (DS00522) and AN607 *"Power-up Trouble Shooting"* (DS00607).







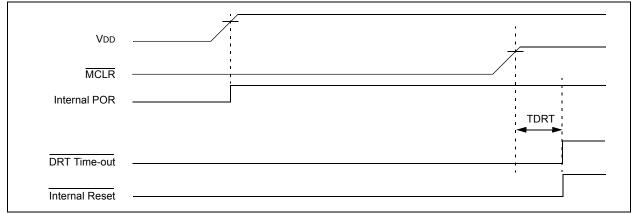
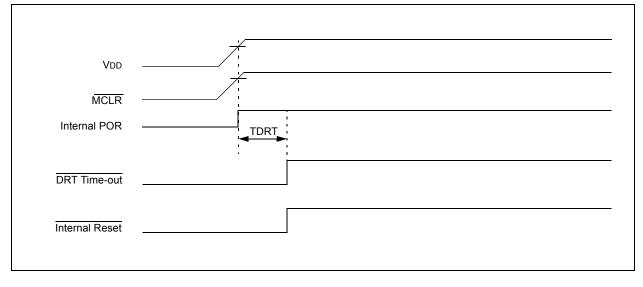
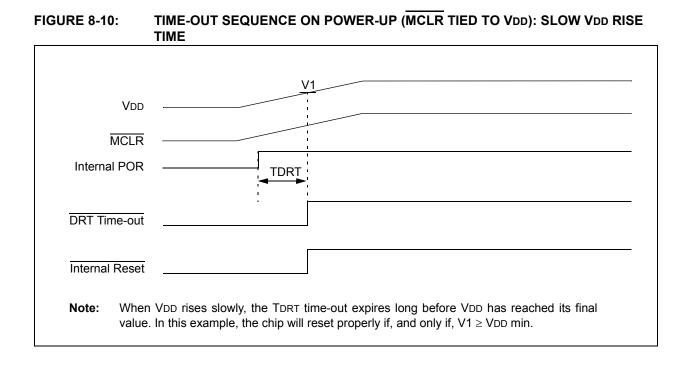


FIGURE 8-9: TIME-OUT SEQUENCE ON POWER-UP (MCLR TIED TO VDD): FAST VDD RISE TIME





8.5 Device Reset Timer (DRT)

On the PIC16F526 device, the DRT runs any time the device is powered up. DRT runs from Reset and varies based on oscillator selection and Reset type (see Table 8-5).

The DRT operates on an internal RC oscillator. The processor is kept in Reset as long as the DRT is active. The DRT delay allows VDD to rise above VDD min. and for the oscillator to stabilize.

Oscillator circuits based on crystals or ceramic resonators require a certain time after power-up to establish a stable oscillation. The on-chip DRT keeps the device in a Reset condition after MCLR has reached a logic high (VIH MCLR) level. Programming RB3/MCLR/VPP as MCLR and using an external RC network connected to the MCLR input is not required in most cases. This allows savings in cost-sensitive and/or space restricted applications, as well as allowing the use of the RB3/ MCLR/VPP pin as a general purpose input.

The Device Reset Time delays will vary from chip-tochip due to VDD, temperature and process variation. See AC parameters for details.

The DRT will also be triggered upon a Watchdog Timer time-out from Sleep. This is particularly important for applications using the WDT to wake from Sleep mode automatically.

Reset sources are POR, MCLR, WDT time-out and wake-up on pin or comparator change. See Section 8.9.2 "Wake-up from Sleep", Notes 1, 2 and 3.

8.6 Watchdog Timer (WDT)

The Watchdog Timer (WDT) is a free running on-chip RC oscillator, which does not require any external components. This RC oscillator is separate from the external RC oscillator of the RB5/OSC1/CLKIN pin and the internal 4/8 MHz oscillator. This means that the WDT will run even if the main processor clock has been stopped, for example, by execution of a SLEEP instruction. During normal operation or Sleep, a WDT Reset or wake-up Reset, generates a device Reset.

The $\overline{\text{TO}}$ bit of the STATUS register will be cleared upon a Watchdog Timer Reset.

The WDT can be permanently disabled by programming the configuration WDTE as a '0' (see **Section 8.1 "Configuration Bits"**). Refer to the PIC16F526 Programming Specifications to determine how to access the Configuration Word.

TABLE 8-5:TYPICAL DRT PERIODS

Oscillator Configuration	POR Reset	Subsequent Resets		
HS, XT, LP	18 ms	18 ms		
EC	1.125 ms	10 μs		
INTOSC, EXTRC	1.125 ms	10 μs		

8.6.1 WDT PERIOD

The WDT has a nominal time-out period of 18 ms, (with no prescaler). If a longer time-out period is desired, a prescaler with a division ratio of up to 1:128 can be assigned to the WDT (under software control) by writing to the OPTION register. Thus, a time-out period of a nominal 2.3 seconds can be realized. These periods vary with temperature, VDD and part-to-part process variations (see DC specs).

Under worst-case conditions (VDD = Min., Temperature = Max., max. WDT prescaler), it may take several seconds before a WDT time-out occurs.

8.6.2 WDT PROGRAMMING CONSIDERATIONS

The CLRWDT instruction clears the WDT and the postscaler, if assigned to the WDT, and prevents it from timing out and generating a device Reset.

The SLEEP instruction resets the WDT and the postscaler, if assigned to the WDT. This gives the maximum Sleep time before a WDT wake-up Reset.

FIGURE 8-11: WATCHDOG TIMER BLOCK DIAGRAM

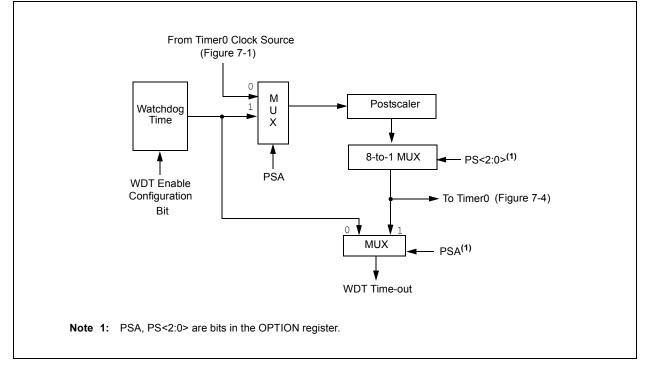


TABLE 8-6: SUMMARY OF REGISTERS ASSOCIATED WITH THE WATCHDOG TIMER

Address	Name	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	Value on Power-On Reset	Value on All Other Resets
N/A	OPTION	RBWU	RBPU	TOCS	T0SE	PSA	PS2	PS1	PS0	1111 1111	1111 1111

Legend: Shaded boxes = Not used by Watchdog Timer.

8.7 Time-out Sequence, Power-down and <u>Wake-up</u> from Sleep Status Bits (TO, PD, RBWUF, CWUF)

The $\overline{\text{TO}}$, $\overline{\text{PD}}$ and RBWUF bits in the STATUS register can be tested to determine if a Reset condition has been caused by a power-up condition, a $\overline{\text{MCLR}}$ or Watchdog Timer (WDT) Reset.

TABLE 8-7: TO/PD/RBWUF/CWUF STATUS AFTER RESET

CWUF	RBWUF	то	PD	Reset Caused By
0	0	0	0	WDT wake-up from Sleep
0	0	0	u	WDT time-out (not from Sleep)
0	0	1	0	MCLR wake-up from Sleep
0	0	1	1	Power-up
0	0	u	u	MCLR not during Sleep
0	1	1	0	Wake-up from Sleep on pin change
1	0	1	0	Wake up from Sleep on comparator change

Legend: u = unchanged

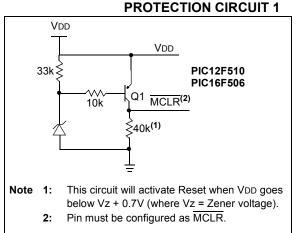
Note 1: The TO, PD and RBWUF bits maintain their status (u) until a Reset occurs. A low-pulse on the MCLR input does not change the TO, PD and RBWUF Status bits.

8.8 Reset on Brown-out

A brown-out is a condition where device power (VDD) dips below its minimum value, but not to zero, and then recovers. The device should be reset in the event of a brown-out.

To reset PIC16F526 devices when a brown-out occurs, external brown-out protection circuits may be built, as shown in Figure 8-12 and Figure 8-13.

FIGURE 8-12: BROWN-OUT





BROWN-OUT PROTECTION CIRCUIT 2

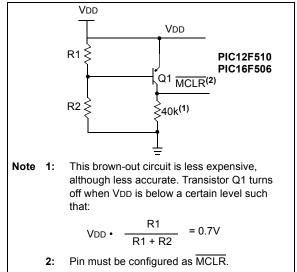
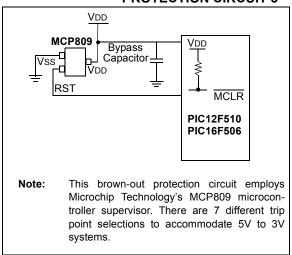


FIGURE 8-14: BROWN-OUT PROTECTION CIRCUIT 3



8.9 Power-down Mode (Sleep)

A device may be powered down (Sleep) and later powered up (wake-up from Sleep).

8.9.1 SLEEP

The Power-Down mode is entered by executing a SLEEP instruction.

If enabled, the Watchdog Timer will be cleared but keeps running, the TO bit of the STATUS register is set, the PD bit of the STATUS register is cleared and the oscillator driver is turned off. The I/O ports maintain the status they had before the SLEEP instruction was executed (driving high, driving low or high-impedance).

Note: A Reset generated by a WDT time-out does not drive the MCLR pin low.

For lowest current consumption while powered down, the T0CKI input should be at VDD or VSS and the RB3/ MCLR/VPP pin must be at a logic high level if MCLR is enabled.

8.9.2 WAKE-UP FROM SLEEP

The device can wake-up from Sleep through one of the following events:

- 1. An external Reset input on RB3/MCLR/VPP pin, when configured as MCLR.
- 2. A Watchdog Timer Time-out Reset (if WDT was enabled).
- 3. A change on input pin RB0, RB1, RB3 or RB4 when wake-up on change is enabled.
- A change in one of the comparator output bits, C1OUT or C2OUT (if comparator wake-up is enabled).

These events cause a device Reset. The $\overline{\text{TO}}$, $\overline{\text{PD}}$ and CWUF/RBWUF bits can be used to determine the cause of device Reset. The $\overline{\text{TO}}$ bit is cleared if a WDT time-out occurred (and caused wake-up). The $\overline{\text{PD}}$ bit, which is set on power-up, is cleared when SLEEP is invoked. The CWUF bit indicates a change in a comparator output state while the device was in Sleep. The RBWUF bit indicates a change in state while in Sleep at pins RB0, RB1, RB3 or RB4 (since the last file or bit operation on RB port).

Note:	Caution: Right before entering Sleep,					
	read the input pins. When in Sleep,					
	wake-up occurs when the values at the					
	pins change from the state they were in at					
	the last reading. If a wake-up on change					
	occurs and the pins are not read before					
	re-entering Sleep, a wake-up will occur					
	immediately even if no pins change while					
	in Sleep mode.					

The WDT is cleared when the device wakes from Sleep, regardless of the wake-up source.

Note: Caution: Right before entering Sleep, read the comparator Configuration register(s) CM1CON0 and CM2CON0. When in Sleep, wake-up occurs when the comparator output bit C1OUT and C2OUT change from the state they were in at the last reading. If a wake-up on comparator change occurs and the pins are not read before re-entering Sleep, a wake-up will occur immediately, even if no pins change while in Sleep mode.

8.10 Program Verification/Code Protection

If the code protection bit has not been programmed, the on-chip program memory can be read out for verification purposes.

The first 64 locations and the last location (OSCCAL) can be read, regardless of the code protection bit setting.

The last memory location can be read regardless of the code protection bit setting on the PIC16F526 device.

8.11 ID Locations

Four memory locations are designated as ID locations where the user can store checksum or other code identification numbers. These locations are not accessible during normal execution, but are readable and writable during Program/Verify.

Use only the lower 4 bits of the ID locations and always program the upper 8 bits as '0's.

8.12 In-Circuit Serial Programming™

The PIC16F526 microcontroller can be serially programmed while in the end application circuit. This is simply done with two lines for clock and data, and three other lines for power, ground and the programming voltage. This allows customers to manufacture boards with unprogrammed devices and then program the microcontroller just before shipping the product. This also allows the most recent firmware, or a custom firmware, to be programmed.

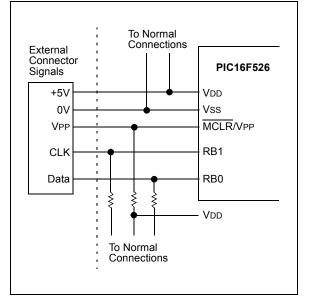
The devices are placed into a Program/Verify mode by holding the RB1 and RB0 pins low while raising the $\overline{\text{MCLR}}$ (VPP) pin from VIL to VIHH (see programming specification). RB1 becomes the programming clock and B0 becomes the programming data. Both RB1 and RB0 are Schmitt Trigger inputs in this mode.

After Reset, a 6-bit command is then supplied to the device. Depending on the command, 14 bits of program data are then supplied to or from the device, depending if the command was a Load or a Read. For complete details of serial programming, please refer to the PIC16F526 Programming Specifications.

A typical In-Circuit Serial Programming connection is shown in Figure 8-15.

FIGURE 8-15:

TYPICAL IN-CIRCUIT SERIAL PROGRAMMING CONNECTION



NOTES:

9.0 ANALOG-TO-DIGITAL (A/D) CONVERTER

The A/D Converter allows conversion of an analog signal into an 8-bit digital signal.

9.1 Clock Divisors

The ADC has 4 clock source settings ADCS<1:0>. There are 3 divisor values 16, 8 and 4. The fourth setting is INTOSC with a divisor of 4. These settings will allow a proper conversion when using an external oscillator at speeds from 20 MHz to 350 kHz. Using an external oscillator at a frequency below 350 kHz requires the ADC oscillator setting to be INTOSC/4 (ADCS<1:0> = 11) for valid ADC results.

The ADC requires 13 TAD periods to complete a conversion. The divisor values do not affect the number of TAD periods required to perform a conversion. The divisor values determine the length of the TAD period.

When the ADCS<1:0> bits are changed while an ADC conversion is in process, the new ADC clock source will not be selected until the next conversion is started. This clock source selection will be lost when the device enters Sleep.

Note:	The ADC clock is derived from the instruc-						
	tion clock. The ADCS divisors are then						
	applied to create the ADC clock						

9.1.1 VOLTAGE REFERENCE

There is no external voltage reference for the ADC. The ADC reference voltage will always be VDD.

9.1.2 ANALOG MODE SELECTION

The ANS<1:0> bits are used to configure pins for analog input. Upon any Reset, ANS<1:0> defaults to 11. This configures pins ANO, AN1 and AN2 as analog inputs. The comparator output, C1OUT, will override AN2 as an input if the comparator output is enabled. Pins configured as analog inputs are not available for digital output. Users should not change the ANS bits while a conversion is in process. ANS bits are active regardless of the condition of ADON.

9.1.3 ADC CHANNEL SELECTION

The CHS bits are used to select the analog channel to be sampled by the ADC. The CHS<1:0> bits can be changed at any time without adversely effecting a conversion. To acquire an analog signal the CHS<1:0> selection must match one of the pin(s) selected by the ANS<1:0> bits. When the ADC is on (ADON = 1) and a channel is selected that is also being used by the comparator, then both the comparator and the ADC will see the analog voltage on the pin.

Note:	It is the users responsibility to ensure that use of the ADC and comparator simulta-						
	neously on the same pin, does not						
	adversely affect the signal being						
	monitored or adversely effect device						
	operation.						

When the CHS<1:0> bits are changed during an ADC conversion, the new channel will not be selected until the current conversion is completed. This allows the current conversion to complete with valid results. All channel selection information will be lost when the device enters Sleep.

TABLE 9-1: CHANNEL SELECT (ADCS) BITS AFTER AN EVENT

Event	ADCS<1:0>
MCLR	11
Conversion completed	CS<1:0>
Conversion terminated	CS<1:0>
Power-on	11
Wake from Sleep	11

9.1.4 THE GO/DONE BIT

The GO/DONE bit is used to determine the status of a conversion, to start a conversion and to manually halt a conversion in process. Setting the GO/DONE bit starts a conversion. When the conversion is complete, the ADC module clears the GO/DONE bit. A conversion can be terminated by manually clearing the GO/DONE bit while a conversion is in process. Manual termination of a conversion may result in a partially converted result in ADRES.

The GO/DONE bit is cleared when the device enters Sleep, stopping the current conversion. The ADC does not have a dedicated oscillator, it runs off of the instruction clock. Therefore, no conversion can occur in sleep.

The GO/DONE bit cannot be set when ADON is clear.

9.1.5 SLEEP

This ADC does not have a dedicated ADC clock, and therefore, no conversion in Sleep is possible. If a conversion is underway and a Sleep command is executed, the GO/DONE and ADON bit will be cleared. This will stop any conversion in process and powerdown the ADC module to conserve power. Due to the nature of the conversion process, the ADRES may contain a partial conversion. At least 1 bit must have been converted prior to Sleep to have partial conversion data in ADRES. The ADCS and CHS bits are reset to their default condition; ANS<1:0> = 11 and CHS<1:0> = 11.

- For accurate conversions, TAD must meet the following:
- + 500 ns < TAD < 50 μs
- TAD = 1/(FOSC/divisor)

Shaded areas indicate TAD out of range for accurate conversions. If analog input is desired at these frequencies, use INTOSC/8 for the ADC clock source.

Source	ADCS <1:0>	Divisor	20 MHz	16 MHz	8 MHz	4 MHz	1 MHz	500 kHz	350 kHz	200 kHz	100 kHz	32 kHz
INTOSC	11	4			.5 μs	1 μs					_	
FOSC	10	4	.2 μs	.25 μs	.5 μs	1 μs	4 μs	8 μ s	11 μs	20 μs	40 μs	125 μs
FOSC	01	8	.4 μs	.5 μs	1 μs	2 μs	8 μs	16 μs	23 μs	40 μs	80 μs	250 μs
FOSC	00	16	.8 μs	1 μs	2 μ s	4 μs	16 μs	32 μ s	46 μs	80 µS	160 μs	500 μs

TABLE 9-2: TAD FOR ADCS SETTINGS WITH VARIOUS OSCILLATORS

TABLE 9-3: EFFECTS OF SLEEP ON ADCON0

	ANS1	ANS0	ADCS1	ADCS0	CHS1	CHS0	GO/DONE	ADON
Entering Sleep	Unchanged	Unchanged	1	1	1	1	0	0
Wake or Reset	1	1	1	1	1	1	0	0

9.1.6 ANALOG CONVERSION RESULT REGISTER

The ADRES register contains the results of the last conversion. These results are present during the sampling period of the next analog conversion process. After the sampling period is over, ADRES is cleared (= 0). A 'leading one' is then right shifted into the ADRES to serve as an internal conversion complete bit. As each bit weight, starting with the MSB, is converted, the leading one is shifted right and the converted bit is stuffed into ADRES. After a total of 9

right shifts of the 'leading one' have taken place, the conversion is complete; the 'leading one' has been shifted out and the GO/DONE bit is cleared.

If the GO/DONE bit is cleared in software during a conversion, the conversion stops. The data in ADRES is the partial conversion result. This data is valid for the bit weights that have been converted. The position of the 'leading one' determines the number of bits that have been converted. The bits that were not converted before the GO/DONE was cleared are unrecoverable.

REGISTER 9-1: ADCON0: A/D CONTROL REGISTER

Legend: R = Readable bi		W = Writable bi			ented hit read as		
bit 7							bit 0
ANS1	ANS0	ADCS1	ADCS0	CHS1	CHS0	GO/DONE	ADON
R/W-1	R/W-1	R/W-1	R/W-1	R/W-1	R/W-1	R/W-0	R/W-0

R - Reauable bil		0 – Onimplemented bit, read as	5 0
-n = Value at POR	'1' = Bit is set	'0' = Bit is cleared	x = Bit is unknown

bit 7-6	ANS<1:0>: ADC Analog Input Pin Select bits ^{(1), (2), (5)} 00 = No pins configured for analog input 01 = AN2 configured as an analog input 10 = AN2 and AN0 configured as analog inputs 11 = AN2, AN1 and AN0 configured as analog inputs
bit 5-4	ADCS<1:0>: ADC Conversion Clock Select bits 00 = Fosc/16 01 = Fosc/8 10 = Fosc/4 11 = INTOSC/4
bit 3-2	CHS<1:0>: ADC Channel Select bits ^(3, 5) 00 = Channel AN0 01 = Channel AN1 10 = Channel AN2 11 = 0.6V absolute voltage reference
bit 1	 GO/DONE: ADC Conversion Status bit⁽⁴⁾ 1 = ADC conversion in progress. Setting this bit starts an ADC conversion cycle. This bit is automatically cleared by hardware when the ADC is done converting. 0 = ADC conversion completed/not in progress. Manually clearing this bit while a conversion is in process terminates the current conversion.
bit 0	ADON: ADC Enable bit 1 = ADC module is operating 0 = ADC module is shut-off and consumes no power
Note 1:	When the ANS bits are set, the channels selected will automatically be forced into Analog mode, regardless of the pin function previously defined. The only exception to this is the comparator, where the analog input to the comparator and the ADC will be active at the same time. It is the users responsibility to ensure that the ADC loading on the comparator input does not affect their application.
2:	The ANS<1:0> bits are active regardless of the condition of ADON.
3:	CHS<1:0> bits default to 11 after any Reset.
4:	If the ADON bit is clear, the GO/DONE bit cannot be set.
5.	C10UT when enabled overrides AN2

5: C1OUT, when enabled, overrides AN2.

							DIL U
bit 7	•		•				bit 0
ADRES7	ADRES6	ADRES5	ADRES4	ADRES3	ADRES2	ADRES1	ADRES0
R/W-X							

Legend:			
R = Readable bit	W = Writable bit	U = Unimplemented bit, read	l as '0'
-n = Value at POR	'1' = Bit is set	'0' = Bit is cleared	x = Bit is unknown

EXAMPLE 9-1: PERFORMING AN ANALOG-TO-DIGITAL CONVERSION

;Sample	e code operates out	of BANK0
	MOVLW 0xF1 MOVWF ADCON0	;configure A/D
		;start conversion
loopO	BTFSC ADCON0, 1 GOTO loop0	;wait for `DONE'
	MOVF ADRES, W	;read result
	MOVWF result0	;save result
		;setup for read of ;channel 1
		;start conversion
loop1	BTFSC ADCON0, 1	;wait for `DONE'
	GOTO loop1	
	MOVF ADRES, W	
	MOVWF result1	;save result
		;setup for read of
	BCF ADCONO, 2	
1 0	,	;start conversion
100p2	BTFSC ADCON0, 1 GOTO loop2	; walt for 'DONE'
	MOVF ADRES, W	;read result
	MOVWF result2	;save result

EXAMPLE 9-2: CHANNEL SELECTION CHANGE DURING CONVERSION

	MOVLW 0xF1 MOVWF ADCON0	;configure A/D
	,	;start conversion
	BSF ADCONU, 2	;setup for read of ;channel 1
loopO	BTFSC ADCON0, GOTO loop0	1; wait for 'DONE'
	MOVF ADRES, W	;read result
	MOVWF result0	;save result
	BSF ADCON0, 1	;start conversion
	BSF ADCON0, 3	;setup for read of
	BCF ADCON0, 2	;channel 2
loopl	,	1;wait for `DONE'
	GOTO loop1	
		;read result
	MOVWF result1	;save result
	BSF ADCON0, 1	;start conversion
loop2	,	1;wait for `DONE'
	GOTO loop2	
		;read result
		;save result
		;optional: returns
		tal mode and turns off
	;the ADC modul	Le

10.0 COMPARATOR(S)

This device contains two comparators and a comparator voltage reference.

REGISTER 10-1: CM1CON0: COMPARATOR C1 CONTROL REGISTER

R-1	R/W-1	R/W-1	R/W-1	R/W-1	R/W-1	R/W-1	R/W-1				
C10UT	C10UTEN	C1POL	C1T0CS	C10N	C1NREF	C1PREF	C1WU				
bit 7	·	•	•	•	•	•	bit 0				
Legend:											
R = Readat	ole bit	W = Writable	bit	U = Unimpler	mented bit, read	d as '0'					
-n = Value a	at POR	'1' = Bit is set		'0' = Bit is cle		x = Bit is unkn	iown				
L:1 7			L:4								
bit 7	1 = VIN+ > VI	parator Output	DI								
	1 = VIN + > VII $0 = VIN + < VII$										
bit 6	C1OUTEN: C	omparator Out	tput Enable bit	(1), (2)							
		comparator is	•		pin						
	•	comparator is		C1OUT pin							
bit 5		parator Output									
		1 = Output of comparator is not inverted									
	<u> </u>	comparator is		(2)							
bit 4		nparator TMR(ck source sele									
		tor output used	•								
bit 3	•	arator Enable									
		1 = Comparator is on									
	0 = Comparat										
bit 2	C1NREF: Co	mparator Nega	tive Reference	e Select bit ⁽²⁾							
	1 = C1IN- pin										
	0 = 0.6V VREF			2 1 1 1 1 1 1 1 1 1 1							
bit 1		mparator Posit	ive Reference	Select bit ⁽²⁾							
	1 = C1IN+ pir 0 = C1IN- pin										
bit 0		parator Wake-u	in On Change	Enable hit(2)							
bit 0		On Comparato	•								
		On Comparato									
Note 1:	Overrides T0CS	bit for TRIS co	ntrol of RB2.								
2:	When comparator	r is turned on,	these control b	oits assert ther	nselves. Other	wise. the other r	eqisters have				

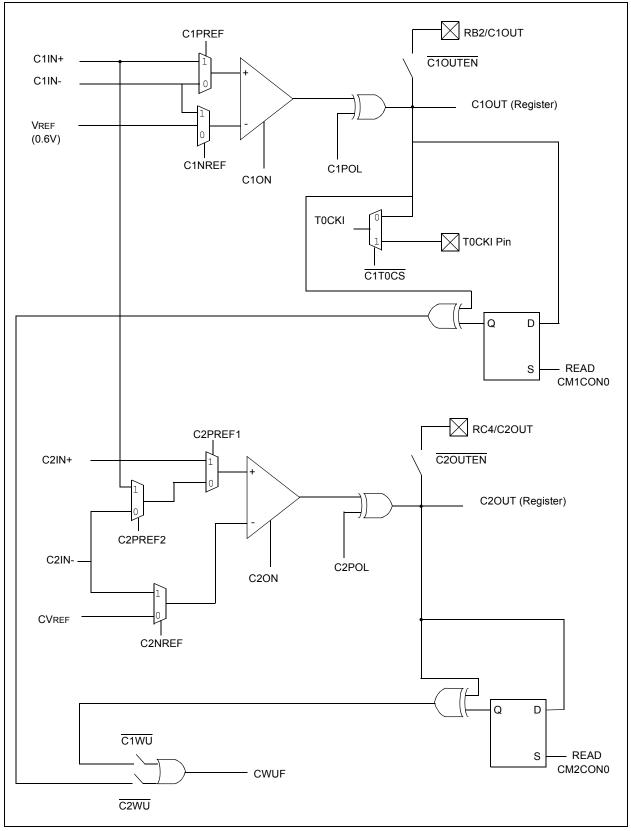
2: When comparator is turned on, these control bits assert themselves. Otherwise, the other registers have precedence.

R-1	R/W-1	R/W-1	R/W-1	R/W-1	R/W-1	R/W-1	R/W-1				
C2OUT	C2OUTEN	C2POL	C2PREF2	C2ON	C2NREF	C2PREF1	C2WU				
bit 7		•					bit				
Legend:											
R = Readable		W = Writable		-	nented bit, rea						
-n = Value at	POR	'1' = Bit is se	t	'0' = Bit is cle	ared	x = Bit is unkn	own				
bit 7	C2OUT: Com	parator Outpu	t bit								
	1 = VIN+ > VII										
	0 = VIN + < VII	-									
bit 6			itput Enable bit								
		L = Output of comparator is NOT placed on the C2OUT pin									
	0 = Output of comparator is placed in the C2OUT pin										
bit 5	C2POL: Comparator Output Polarity bit ⁽²⁾										
	 Output of comparator not inverted Output of comparator inverted 										
bit 4	C2PREF2: Comparator Positive Reference Select bit ⁽²⁾										
	1 = C1IN+ pir	•									
	0 = C2IN- pin										
bit 3	C2ON: Comp	arator Enable	bit								
	1 = Comparator is on										
	0 = Comparat			(2)							
bit 2			ative Reference	e Select bit ⁽²⁾							
	1 = C2IN- pin 0 = CVREF										
bit 1											
	C2PREF1: Comparator Positive Reference Select bit ⁽²⁾ 1 = C2IN+ pin										
	0 = C2PREF2 controls analog input selection										
bit 0			up on Change	(
	1 = Wake-up	on Comparato	or change is dis	abled							
	0 = Wake-up	0		ablad							

REGISTER 10-2: CM2CON0: COMPARATOR C2 CONTROL REGISTER

2: When comparator is turned on, these control bits assert themselves. Otherwise, the other registers have precedence.

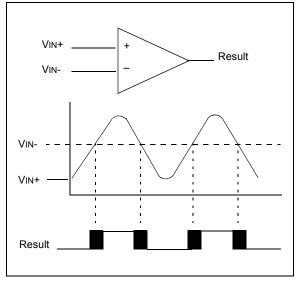




10.1 Comparator Operation

A single comparator is shown in Figure 10-2 along with the relationship between the analog input levels and the digital output. When the analog input at VIN+ is less than the analog input VIN-, the output of the comparator is a digital low level. The shaded area of the output of the comparator in Figure 10-2 represent the uncertainty due to input offsets and response time. See Table 14-2 for Common Mode Voltage.

FIGURE 10-2: SINGLE COMPARATOR



10.2 Comparator Reference

An internal reference signal may be used depending on the comparator operating mode. The analog signal that is present at VIN- is compared to the signal at VIN+, and the digital output of the comparator is adjusted accordingly (Figure 10-2). Please see **Section 11.0 "Comparator Voltage Reference Module"** for internal reference specifications.

10.3 Comparator Response Time

Response time is the minimum time after selecting a new reference voltage or input source before the comparator output is to have a valid level. If the comparator inputs are changed, a delay must be used to allow the comparator to settle to its new state. Please see Table 14-3 for comparator response time specifications.

10.4 Comparator Output

The comparator output is read through the CM1CON0 or CM2CON0 register. This bit is read-only. The comparator output may also be used externally, see Figure 10-1.

Note:	Analog levels on any pin that is defined as
	a digital input may cause the input buffer
	to consume more current than is specified.

10.5 Comparator Wake-up Flag

The Comparator Wake-up Flag is set whenever all of the following conditions are met:

- <u>C1WU</u> = 0 (CM1CON0<0>) or
 <u>C2WU</u> = 0 (CM2CON0<0>)
- CM1CON0 or CM2CON0 has been read to latch the last known state of the C1OUT and C2OUT bit (MOVF CM1CON0, W)
- Device is in Sleep
- · The output of a comparator has changed state

The wake-up flag may be cleared in software or by another device Reset.

10.6 Comparator Operation During Sleep

When the comparator is enabled it is active. To minimize power consumption while in Sleep mode, turn off the comparator before entering Sleep.

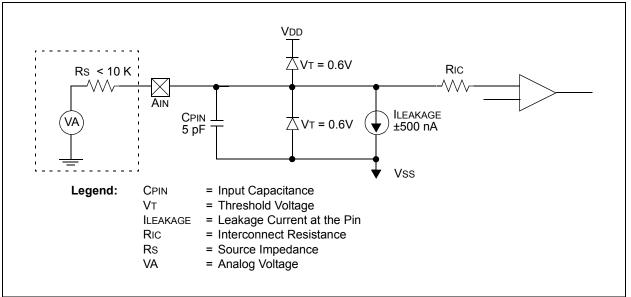
10.7 Effects of Reset

A Power-on Reset (POR) forces the CM2CON0 register to its Reset state. This forces the Comparator input pins to analog Reset mode. Device current is minimized when analog inputs are present at Reset time.

10.8 Analog Input Connection Considerations

A simplified circuit for an analog input is shown in Figure 10-3. Since the analog pins are connected to a digital output, they have reverse biased diodes to VDD and Vss. The analog input, therefore, must be between Vss and VDD. If the input voltage deviates from this range by more than 0.6V in either direction, one of the diodes is forward biased and a latch-up may occur. A maximum source impedance of 10 k Ω is recommended for the analog sources. Any external component connected to an analog input pin, such as a capacitor or a Zener diode, should have very little leakage current.





Name	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	Value on POR	Value on All Other Resets
STATUS	RBWUF	CWUF	PA0	TO	PD	Z	DC	С	0001 1xxx	qq0q quuu
CM1CON0	C1OUT	C10UTEN	C1POL	C1T0CS	C10N	C1NREF	C1PREF	C1WU	q111 1111	quuu uuuu
CM2CON0	C2OUT	C2OUTEN	C2POL	C2PREF2	C2ON	C2NREF	C2PREF1	C2WU	q111 1111	quuu uuuu
TRIS	-	—	I/O Contro	O Control Register (PORTB, PORTC)					11 1111	11 1111

Legend: x = Unknown, u = Unchanged, - = Unimplemented, read as '0', q = Depends on condition.

NOTES:

11.0 COMPARATOR VOLTAGE REFERENCE MODULE

The Comparator Voltage Reference module also allows the selection of an internally generated voltage reference for one of the C2 comparator inputs. The VRCON register (Register 11-1) controls the Voltage Reference module shown in Figure 11-1.

11.1 Configuring The Voltage Reference

The voltage reference can output 32 voltage levels; 16 in a high range and 16 in a low range.

Equation 11-1 determines the output voltages:

EQUATION 11-1:

 $VRR = 1 (low range): CVREF = (VR < 3:0 > /24) \times VDD$ VRR = 0 (high range):CVREF = (VDD/4) + (VR < 3:0 > x VDD/32)

11.2 Voltage Reference Accuracy/Error

The full range of VSS to VDD cannot be realized due to construction of the module. The transistors on the top and bottom of the resistor ladder network (Figure 11-1) keep CVREF from approaching VSS or VDD. The exception is when the module is disabled by clearing the VREN bit of the VRCON register. When disabled, the reference voltage is VSS when VR<3:0> is '0000' and the VRR bit of the VRCON register is set. This allows the comparator to detect a zero-crossing and not consume the CVREF module current.

The voltage reference is VDD derived and, therefore, the CVREF output changes with fluctuations in VDD. The tested absolute accuracy of the comparator voltage reference can be found in **Section 14.0 "Electrical Characteristics"**.

REGISTER 11-1: VRCON: VOLTAGE REFERENCE CONTROL REGISTER

R/W-0	R/W-0	R/W-0	U-0	R/W-0	R/W-0	R/W-0	R/W-0
VREN	VROE	VRR	—	VR3	VR2	VR1	VR0
bit 7							bit 0

Legend:			
R = Readable bit	W = Writable bit	U = Unimplemented bit, read	d as '0'
-n = Value at POR	'1' = Bit is set	'0' = Bit is cleared	x = Bit is unknown

bit 7	VREN: CVREF Enable bit
	1 = CVREF is powered on
	0 = CVREF is powered down, no current is drawn
bit 6	VROE: CVREF Output Enable bit ⁽¹⁾
	1 = CVREF output is enabled
	0 = CVREF output is disabled
bit 5	VRR: CVREF Range Selection bit
	1 = Low range
	0 = High range
bit 4	Unimplemented: Read as '0'
bit 3-0	VR<3:0> CVREF Value Selection bit
	When VRR = 1: CVREF= (VR<3:0>/24)*VDD
	When VRR = 0: CVREF= VDD/4+(VR<3:0>/32)*VDD

Note 1: When this bit is set, the TRIS for the CVREF pin is overridden and the analog voltage is placed on the CVREF pin.



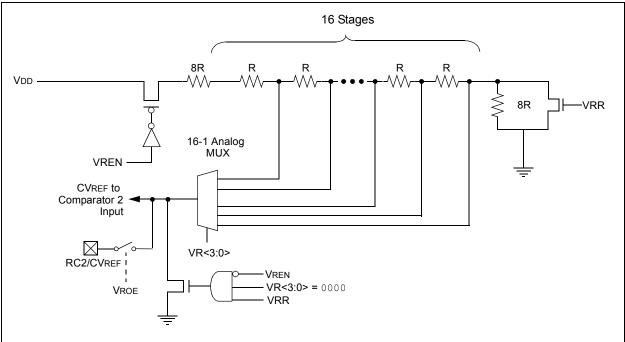


TABLE 11-1: REGISTERS ASSOCIATED WITH COMPARATOR VOLTAGE REFERENCE

Name	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	Value on POR	Value on all other Resets
VRCON	VREN	VROE	VRR	—	VR3	VR2	VR1	VR0	001- 1111	uuu- uuuu
CM1CON0	C1OUT	C10UTEN	C1POL	C1T0CS	C10N	C1NREF	C1PREF	C1WU	q111 1111	quuu uuuu
CM2CON0	C2OUT	C2OUTEN	C2POL	C2PREF2	C2ON	C2NREF	C2PREF1	C2WU	q111 1111	quuu uuuu

Legend: x = unknown, u = unchanged, - = unimplemented, read as '0', q = value depends on condition.

12.0 INSTRUCTION SET SUMMARY

The PIC16 instruction set is highly orthogonal and is comprised of three basic categories.

- Byte-oriented operations
- Bit-oriented operations
- Literal and control operations

Each PIC16 instruction is a 12-bit word divided into an **opcode**, which specifies the instruction type, and one or more **operands** which further specify the operation of the instruction. The formats for each of the categories is presented in Figure 12-1, while the various opcode fields are summarized in Table 12-1.

For **byte-oriented** instructions, 'f' represents a file register designator and 'd' represents a destination designator. The file register designator specifies which file register is to be used by the instruction.

The destination designator specifies where the result of the operation is to be placed. If 'd' is '0', the result is placed in the W register. If 'd' is '1', the result is placed in the file register specified in the instruction.

For **bit-oriented** instructions, 'b' represents a bit field designator which selects the number of the bit affected by the operation, while 'f' represents the number of the file in which the bit is located.

For **literal and control** operations, 'k' represents an 8 or 9-bit constant or literal value.

TABLE 12-1: OPCODE FIELD DESCRIPTIONS

Field	Description
f	Register file address (0x00 to 0x7F)
W	Working register (accumulator)
b	Bit address within an 8-bit file register
k	Literal field, constant data or label
х	Don't care location (= 0 or 1) The assembler will generate code with x = 0 . It is the recommended form of use for compatibility with all Microchip software tools.
d	Destination select; d = 0 (store result in W) d = 1 (store result in file register 'f') Default is d = 1
label	Label name
TOS	Top-of-Stack
PC	Program Counter
WDT	Watchdog Timer counter
TO	Time-out bit
PD	Power-down bit
dest	Destination, either the W register or the specified register file location
[]	Options
()	Contents
Æ	Assigned to
< >	Register bit field
Œ	In the set of
italics	User defined term (font is courier)

All instructions are executed within a single instruction cycle, unless a conditional test is true or the program counter is changed as a result of an instruction. In this case, the execution takes two instruction cycles. One instruction cycle consists of four oscillator periods. Thus, for an oscillator frequency of 4 MHz, the normal instruction execution time is 1 μ s. If a conditional test is true or the program counter is changed as a result of an instruction, the instruction execution time is 2 μ s.

Figure 12-1 shows the three general formats that the instructions can have. All examples in the figure use the following format to represent a hexadecimal number:

0xhhh

where 'h' signifies a hexadecimal digit.

FIGURE 12-1: GENERAL FORMAT FOR INSTRUCTIONS

Byte-o	oriented file regi	ster	oper	ations	
11	6	5	4		0
	OPCODE	d		f (FILE #)	
c	d = 0 for destinati d = 1 for destinati = 5-bit file regist	on f		s	
Bit-ori	iented file regist	er op	erat	ions	
11	8	7	5	4	0
	OPCODE	b (Bl	T#)	f (FILE #)	
	= 5-bit file regist				
11		8	7		0
	OPCODE			k (literal)	
k	x = 8-bit immedia	ite va	lue		
Litera	l and control op	eratio	ons -	- GOTO instruct	ion
11		9	8		0
					-
	OPCODE			k (literal)	

Mnemonic,		Deceriation	Cualas	12-Bit Opcode			Status	
Oper	ands	Description	Cycles	MSb		LSb	Affected	Notes
ADDWF	f, d	Add W and f	1	0001	11df	ffff	C, DC, Z	1, 2, 4
ANDWF	f, d	AND W with f	1	0001	01df	ffff	Z	2, 4
CLRF	f	Clear f	1	0000	011f	ffff	Z	4
CLRW	—	Clear W	1	0000	0100	0000	Z	
COMF	f, d	Complement f	1	0010	01df	ffff	Z	
DECF	f, d	Decrement f	1	0000	11df	ffff	Z	2, 4
DECFSZ	f, d	Decrement f, Skip if 0	1 ⁽²⁾	0010	11df	ffff	None	2, 4
INCF	f, d	Increment f	1	0010	10df	ffff	Z	2, 4
INCFSZ	f, d	Increment f, Skip if 0	1 ⁽²⁾	0011	11df	ffff	None	2, 4
IORWF	f, d	Inclusive OR W with f	1	0001	00df	ffff	Z	2, 4
MOVF	f, d	Move f	1	0010	00df	ffff	Z	2, 4
MOVWF	f	Move W to f	1	0000	001f	ffff	None	1, 4
NOP	_	No Operation	1	0000	0000	0000	None	
RLF	f, d	Rotate left f through Carry	1	0011	01df	ffff	С	2, 4
RRF	f, d	Rotate right f through Carry	1	0011	00df	ffff	С	2, 4
SUBWF	f, d	Subtract W from f	1	0000	10df	ffff	C, DC, Z	1, 2, 4
SWAPF	f, d	Swap f	1	0011	10df	ffff	None	2, 4
XORWF	f, d	Exclusive OR W with f	1	0001	10df	ffff	Z	2, 4
		BIT-ORIENTED FILE REC	SISTER OPER					,
BCF	f, b	Bit Clear f	1	0100	bbbf	ffff	None	2, 4
BSF	f, b	Bit Set f	1	0101	bbbf	ffff	None	2, 4
BTFSC	f, b	Bit Test f, Skip if Clear	1 ⁽²⁾	0110	bbbf	ffff	None	-
BTFSS	f, b	Bit Test f, Skip if Set	1 ⁽²⁾	0111	bbbf	ffff	None	
		LITERAL AND CONT		ONS				1
ANDLW	k	AND literal with W	1	1110	kkkk	kkkk	Z	
CALL	k	Call Subroutine	2	1001	kkkk	kkkk	None	1
CLRWDT	_	Clear Watchdog Timer	1	0000	0000	0100	TO, PD	
GOTO	k	Unconditional branch	2	101k	kkkk	kkkk	None	
IORLW	k	Inclusive OR literal with W	1	1101	kkkk	kkkk	Z	
MOVLW	k	Move literal to W	1	1100	kkkk	kkkk	None	
OPTION	_	Load OPTION register	1	0000	0000	0010	None	
RETLW	k	Return, place literal in W	2	1000	kkkk	kkkk	None	
	_	Go into Standby mode	1	0000	0000	0011	TO, PD	
	_							
SLEEP	f	Load TRIS register	1	0000	0000	Offf	None	3

TABLE 12-2: INSTRUCTION SET SUMMARY

GOTO. See Section 4.6 "Program Counter".
When an I/O register is modified as a function of itself (e.g. MOVF PORTB, 1), the value used will be that value present on the pins themselves. For example, if the data latch is '1' for a pin configured as input and

value present on the pins themselves. For example, if the data latch is '1' for a pin configured as input and is driven low by an external device, the data will be written back with a '0'.

3: The instruction TRIS f, where f = 6, causes the contents of the W register to be written to the tri-state latches of PORTB. A '1' forces the pin to a high-impedance state and disables the output buffers.

4: If this instruction is executed on the TMR0 register (and, where applicable, d = 1), the prescaler will be cleared (if assigned to TMR0).

ADDWF	Add W and f
Syntax:	[<i>label</i>] ADDWF f,d
Operands:	$\begin{array}{l} 0 \leq f \leq 31 \\ d \in [0,1] \end{array}$
Operation:	$(W) + (f) \to (dest)$
Status Affected:	C, DC, Z
Description:	Add the contents of the W register and register 'f'. If 'd' is'0', the result is stored in the W register. If 'd' is '1', the result is stored back in register 'f'.

BCF	Bit Clear f
Syntax:	[<i>label</i>] BCF f,b
Operands:	$\begin{array}{l} 0 \leq f \leq 31 \\ 0 \leq b \leq 7 \end{array}$
Operation:	$0 \rightarrow (f \le b >)$
Status Affected:	None
Description:	Bit 'b' in register 'f' is cleared.

ANDLW	AND literal with W
Syntax:	[<i>label</i>] ANDLW k
Operands:	$0 \leq k \leq 255$
Operation:	(W).AND. (k) \rightarrow (W)
Status Affected:	Z
Description:	The contents of the W register are AND'ed with the eight-bit literal 'k'. The result is placed in the W register.

BSF	Bit Set f
Syntax:	[<i>label</i>] BSF f,b
Operands:	$\begin{array}{l} 0 \leq f \leq 31 \\ 0 \leq b \leq 7 \end{array}$
Operation:	$1 \rightarrow (f \le b >)$
Status Affected:	None
Description:	Bit 'b' in register 'f' is set.

ANDWF	AND W with f
Syntax:	[<i>label</i>] ANDWF f,d
Operands:	$\begin{array}{l} 0\leq f\leq 31\\ d\in [0,1] \end{array}$
Operation:	(W) .AND. (f) \rightarrow (dest)
Status Affected:	Z
Description:	The contents of the W register are AND'ed with register 'f'. If 'd' is '0', the result is stored in the W register. If 'd' is '1', the result is stored back in register 'f'.

BTFSC	Bit Test f, Skip if Clear
Syntax:	[label] BTFSC f,b
Operands:	$\begin{array}{l} 0 \leq f \leq 31 \\ 0 \leq b \leq 7 \end{array}$
Operation:	skip if (f) = 0
Status Affected:	None
Description:	If bit 'b' in register 'f' is '0', then the next instruction is skipped.
	If bit 'b' is '0', then the next instruc- tion fetched during the current instruction execution is discarded, and a NOP is executed instead, making this a two-cycle instruction.

BTFSS	Bit Test f, Skip if Set
Syntax:	[<i>label</i>] BTFSS f,b
Operands:	$\begin{array}{l} 0 \leq f \leq 31 \\ 0 \leq b < 7 \end{array}$
Operation:	skip if (f) = 1
Status Affected:	None
Description:	If bit 'b' in register 'f' is '1', then the next instruction is skipped.
	If bit 'b' is '1', then the next instruc- tion fetched during the current instruction execution, is discarded and a NOP is executed instead, making this a two-cycle instruction.

CLRW	Clear W
Syntax:	[label] CLRW
Operands:	None
Operation:	$\begin{array}{l} 00h \rightarrow (W); \\ 1 \rightarrow Z \end{array}$
Status Affected:	Z
Description:	The W register is cleared. Zero bit (Z) is set.

CALL	Subroutine Call
Syntax:	[<i>label</i>] CALL k
Operands:	$0 \leq k \leq 255$
Operation:	(PC) + 1 \rightarrow Top-of-Stack; k \rightarrow PC<7:0>; (STATUS<6:5>) \rightarrow PC<10:9>; 0 \rightarrow PC<8>
Status Affected:	None
Description:	Subroutine call. First, return address (PC + 1) is PUSHed onto the stack. The eight-bit immediate address is loaded into PC bits <7:0>. The upper bits PC<10:9> are loaded from STATUS<6:5>, PC<8> is cleared. CALL is a two-cycle instruction.

CLRWDT	Clear Watchdog Timer
Syntax:	[label] CLRWDT
Operands:	None
Operation:	00h \rightarrow WDT; 0 \rightarrow WDT prescaler (if assigned); 1 \rightarrow TO; 1 \rightarrow PD
Status Affected:	TO, PD
Description:	The CLRWDT instruction resets the WDT. It also resets the prescaler, if the prescaler is assigned to the WDT and not Timer0. Status bits \overline{TO} and \overline{PD} are set.

CLRF	Clear f
Syntax:	[<i>label</i>] CLRF f
Operands:	$0 \leq f \leq 31$
Operation:	$\begin{array}{l} 00h \rightarrow (f); \\ 1 \rightarrow Z \end{array}$
Status Affected:	Z
Description:	The contents of register 'f' are cleared and the Z bit is set.

COMF	Complement f
Syntax:	[<i>label</i>] COMF f,d
Operands:	$\begin{array}{l} 0\leq f\leq 31\\ d\in [0,1] \end{array}$
Operation:	$(\overline{f}) \rightarrow (dest)$
Status Affected:	Z
Description:	The contents of register 'f' are complemented. If 'd' is '0', the result is stored in the W register. If 'd' is '1', the result is stored back in register 'f'.

DECF	Decrement f
Syntax:	[<i>label</i>] DECF f,d
Operands:	$\begin{array}{l} 0\leq f\leq 31\\ d\in [0,1] \end{array}$
Operation:	$(f) - 1 \rightarrow (dest)$
Status Affected:	Z
Description:	Decrement register 'f'. If 'd' is '0', the result is stored in the W register. If 'd' is '1', the result is stored back in register 'f'.

Decrement f, Skip if 0

[label] DECFSZ f,d

(f) $-1 \rightarrow d$; skip if result = 0

The contents of register 'f' are decremented. If 'd' is '0', the result is placed in the W register. If 'd' is '1', the result is placed back in

If the result is '0', the next instruction, which is already fetched, is

discarded and a NOP is executed

instead making it a two-cycle

 $\begin{array}{l} 0 \leq f \leq 31 \\ d \, \in \, [0,1] \end{array}$

register 'f'.

instruction.

None

DECFSZ

Operands:

Operation:

Description:

Status Affected:

Syntax:

INCF	Increment f
Syntax:	[<i>label</i>] INCF f,d
Operands:	$\begin{array}{l} 0\leq f\leq 31\\ d\in [0,1] \end{array}$
Operation:	(f) + 1 \rightarrow (dest)
Status Affected:	Z
Description:	The contents of register 'f' are incremented. If 'd' is '0', the result is placed in the W register. If 'd' is '1', the result is placed back in register 'f'.
INCFSZ	Increment f, Skip if 0
INCFSZ Syntax:	Increment f, Skip if 0 [<i>label</i>] INCFSZ f,d
_	
Syntax:	[<i>label</i>] INCFSZ f,d $0 \le f \le 31$
Syntax: Operands:	$\begin{bmatrix} \textit{label} \end{bmatrix} \text{INCFSZ f,d} \\ 0 \le f \le 31 \\ d \in [0,1] \end{bmatrix}$

If the result is '0', then the next instruction, which is already fetched, is discarded and a NOP is executed instead making it a two-cycle instruction.

GOTO	Unconditional Branch
Syntax:	[<i>label</i>] GOTO k
Operands:	$0 \leq k \leq 511$
Operation:	k → PC<8:0>; STATUS<6:5> → PC<10:9>
Status Affected:	None
Description:	GOTO is an unconditional branch. The 9-bit immediate value is loaded into PC bits <8:0>. The upper bits of PC are loaded from STATUS<6:5>. GOTO is a two- cycle instruction.

IORLW	Inclusive OR literal with W
Syntax:	[<i>label</i>] IORLW k
Operands:	$0 \leq k \leq 255$
Operation:	(W) .OR. (k) \rightarrow (W)
Status Affected:	Z
Description:	The contents of the W register are OR'ed with the eight-bit literal 'k'. The result is placed in the W register.

IORWF	Inclusive OR W with f
Syntax:	[<i>label</i>] IORWF f,d
Operands:	$\begin{array}{l} 0\leq f\leq 31\\ d\in [0,1] \end{array}$
Operation:	(W).OR. (f) \rightarrow (dest)
Status Affected:	Z
Description:	Inclusive OR the W register with register 'f'. If 'd' is '0', the result is placed in the W register. If 'd' is '1', the result is placed back in register 'f'.

MOVWF	Move W to f
Syntax:	[<i>label</i>] MOVWF f
Operands:	$0 \leq f \leq 31$
Operation:	$(W) \rightarrow (f)$
Status Affected:	None
Description:	Move data from the W register to register 'f'.

MOVF	Move f
Syntax:	[<i>label</i>] MOVF f,d
Operands:	$\begin{array}{l} 0\leq f\leq 31\\ d\in [0,1] \end{array}$
Operation:	$(f) \rightarrow (dest)$
Status Affected:	Z
Description:	The contents of register 'f' are moved to destination 'd'. If 'd' is '0', destination is the W register. If 'd' is '1', the destination is file register 'f'. 'd' = 1 is useful as a test of a file register, since status flag Z is affected.

NOP	No Operation
Syntax:	[label] NOP
Operands:	None
Operation:	No operation
Status Affected:	None
Description:	No operation.

MOVLW	Move Literal to W
Syntax:	[<i>label</i>] MOVLW k
Operands:	$0 \leq k \leq 255$
Operation:	$k \rightarrow (W)$
Status Affected:	None
Description:	The eight-bit literal 'k' is loaded into the W register. The "don't cares" will assembled as '0's.

OPTION	Load OPTION Register
Syntax:	[label] OPTION
Operands:	None
Operation:	$(W) \rightarrow OPTION$
Status Affected:	None
Description:	The content of the W register is loaded into the OPTION register.

RETLW	Return with Literal in W	SLEEP
Syntax:	[<i>label</i>] RETLW k	Syntax:
Operands:	$0 \leq k \leq 255$	Operand
Operation:	$k \rightarrow (W);$ TOS $\rightarrow PC$	Operatio
Status Affected:	None	
Description:	The W register is loaded with the eight-bit literal 'k'. The program counter is loaded from the top of the stack (the return address). This is a two-cycle instruction.	Status Af Descripti

SLEEP	Enter SLEEP Mode
Syntax:	[label] SLEEP
Operands:	None
Operation:	$\begin{array}{l} 00h \rightarrow WDT; \\ 0 \rightarrow WDT \ prescaler; \\ 1 \rightarrow \overline{TO}; \\ 0 \rightarrow \overline{PD} \end{array}$
Status Affected:	TO, PD, RBWUF
Description:	Time-out Status bit (TO) is set. The Power-down Status bit (PD) is cleared. RBWUF is unaffected. The WDT and its prescaler are cleared.
	The processor is put into Sleep mode with the oscillator stopped. See Section 8.9 "Power-down Mode (Sleep)" on Sleep for more details.

RLF	Rotate Left f through Carry							
Syntax:	[<i>label</i>] RLF f,d							
Operands:	$\begin{array}{l} 0\leq f\leq 31\\ d\in [0,1] \end{array}$							
Operation:	See description below							
Status Affected:	С							
Description:	The contents of register 'f' are rotated one bit to the left through the Carry flag. If 'd' is '0', the result is placed in the W register. If 'd' is '1', the result is stored back in register 'f'.							

SUBWF	Subtract W from f							
Syntax:	[<i>label</i>] SUBWF f,d							
Operands:	$\begin{array}{l} 0\leq f\leq 31\\ d\in [0,1] \end{array}$							
Operation:	$(f) - (W) \rightarrow (dest)$							
Status Affected:	C, DC, Z							
Description:	Subtract (2's complement method) the W register from register 'f'. If 'd' is '0', the result is stored in the W register. If 'd' is '1', the result is stored back in register 'f'.							

RRF	Rotate Right f through Carry
Syntax:	[<i>label</i>] RRF f,d
Operands:	$\begin{array}{l} 0\leq f\leq 31\\ d\in [0,1] \end{array}$
Operation:	See description below
Status Affected:	С
Description:	The contents of register 'f' are rotated one bit to the right through the Carry flag. If 'd' is '0', the result is placed in the W register. If 'd' is '1', the result is placed back in register 'f'.

SWAPF	Swap Nibbles in f
Syntax:	[<i>label</i>] SWAPF f,d
Operands:	$\begin{array}{l} 0\leq f\leq 31\\ d\in [0,1] \end{array}$
Operation:	(f<3:0>) → (dest<7:4>); (f<7:4>) → (dest<3:0>)
Status Affected:	None
Description:	The upper and lower nibbles of register 'f' are exchanged. If 'd' is '0', the result is placed in W register. If 'd' is '1', the result is placed in register 'f'.

Status Affected:

Description:

Ζ

register.

The contents of the W register are XOR'ed with the eight-bit literal 'k'.

The result is placed in the W

TRIS	Load TRIS Register	XORWF	Exclusive OR W with f		
Syntax:	[<i>label</i>] TRIS f	Syntax:	[<i>label</i>] XORWF f,d		
Operands:	f = 6	Operands:	$0 \le f \le 31$		
Operation:	(W) \rightarrow TRIS register f		$d \in [0,1]$		
Status Affected:	None	Operation:	(W) .XOR. (f) \rightarrow (dest)		
Description:	TRIS register 'f' (f = 6 or 7) is	Status Affected:	Z		
	loaded with the contents of the W register	Description:	Exclusive OR the contents of the W register with register 'f'. If 'd' is '0', the result is stored in the W		
XORLW	Exclusive OR literal with W		register. If 'd' is '1', the result is stored back in register 'f'.		
Syntax:	[<i>label</i>] XORLW k				
Operands:	$0 \le k \le 255$				
Operation:	(W) .XOR. $k \rightarrow (W)$				

13.0 DEVELOPMENT SUPPORT

The PIC[®] microcontrollers and dsPIC[®] digital signal controllers are supported with a full range of software and hardware development tools:

- Integrated Development Environment
- MPLAB[®] IDE Software
- Compilers/Assemblers/Linkers
 - MPLAB C Compiler for Various Device Families
 - HI-TECH C for Various Device Families
 - MPASM[™] Assembler
 - MPLINK[™] Object Linker/ MPLIB[™] Object Librarian
 - MPLAB Assembler/Linker/Librarian for Various Device Families
- · Simulators
 - MPLAB SIM Software Simulator
- Emulators
 - MPLAB REAL ICE™ In-Circuit Emulator
- In-Circuit Debuggers
 - MPLAB ICD 3
 - PICkit™ 3 Debug Express
- Device Programmers
 - PICkit[™] 2 Programmer
 - MPLAB PM3 Device Programmer
- Low-Cost Demonstration/Development Boards, Evaluation Kits, and Starter Kits

13.1 MPLAB Integrated Development Environment Software

The MPLAB IDE software brings an ease of software development previously unseen in the 8/16/32-bit microcontroller market. The MPLAB IDE is a Windows[®] operating system-based application that contains:

- A single graphical interface to all debugging tools
 - Simulator
 - Programmer (sold separately)
 - In-Circuit Emulator (sold separately)
 - In-Circuit Debugger (sold separately)
- · A full-featured editor with color-coded context
- A multiple project manager
- Customizable data windows with direct edit of contents
- · High-level source code debugging
- · Mouse over variable inspection
- Drag and drop variables from source to watch windows
- · Extensive on-line help
- Integration of select third party tools, such as IAR C Compilers

The MPLAB IDE allows you to:

- Edit your source files (either C or assembly)
- One-touch compile or assemble, and download to emulator and simulator tools (automatically updates all project information)
- · Debug using:
 - Source files (C or assembly)
 - Mixed C and assembly
 - Machine code

MPLAB IDE supports multiple debugging tools in a single development paradigm, from the cost-effective simulators, through low-cost in-circuit debuggers, to full-featured emulators. This eliminates the learning curve when upgrading to tools with increased flexibility and power.

13.2 MPLAB C Compilers for Various Device Families

The MPLAB C Compiler code development systems are complete ANSI C compilers for Microchip's PIC18, PIC24 and PIC32 families of microcontrollers and the dsPIC30 and dsPIC33 families of digital signal controllers. These compilers provide powerful integration capabilities, superior code optimization and ease of use.

For easy source level debugging, the compilers provide symbol information that is optimized to the MPLAB IDE debugger.

13.3 HI-TECH C for Various Device Families

The HI-TECH C Compiler code development systems are complete ANSI C compilers for Microchip's PIC family of microcontrollers and the dsPIC family of digital signal controllers. These compilers provide powerful integration capabilities, omniscient code generation and ease of use.

For easy source level debugging, the compilers provide symbol information that is optimized to the MPLAB IDE debugger.

The compilers include a macro assembler, linker, preprocessor, and one-step driver, and can run on multiple platforms.

13.4 MPASM Assembler

The MPASM Assembler is a full-featured, universal macro assembler for PIC10/12/16/18 MCUs.

The MPASM Assembler generates relocatable object files for the MPLINK Object Linker, Intel[®] standard HEX files, MAP files to detail memory usage and symbol reference, absolute LST files that contain source lines and generated machine code and COFF files for debugging.

The MPASM Assembler features include:

- · Integration into MPLAB IDE projects
- User-defined macros to streamline assembly code
- Conditional assembly for multi-purpose source files
- Directives that allow complete control over the assembly process

13.5 MPLINK Object Linker/ MPLIB Object Librarian

The MPLINK Object Linker combines relocatable objects created by the MPASM Assembler and the MPLAB C18 C Compiler. It can link relocatable objects from precompiled libraries, using directives from a linker script.

The MPLIB Object Librarian manages the creation and modification of library files of precompiled code. When a routine from a library is called from a source file, only the modules that contain that routine will be linked in with the application. This allows large libraries to be used efficiently in many different applications.

The object linker/library features include:

- Efficient linking of single libraries instead of many smaller files
- Enhanced code maintainability by grouping related modules together
- Flexible creation of libraries with easy module listing, replacement, deletion and extraction

13.6 MPLAB Assembler, Linker and Librarian for Various Device Families

MPLAB Assembler produces relocatable machine code from symbolic assembly language for PIC24, PIC32 and dsPIC devices. MPLAB C Compiler uses the assembler to produce its object file. The assembler generates relocatable object files that can then be archived or linked with other relocatable object files and archives to create an executable file. Notable features of the assembler include:

- · Support for the entire device instruction set
- · Support for fixed-point and floating-point data
- Command line interface
- · Rich directive set
- Flexible macro language
- · MPLAB IDE compatibility

13.7 MPLAB SIM Software Simulator

The MPLAB SIM Software Simulator allows code development in a PC-hosted environment by simulating the PIC MCUs and dsPIC[®] DSCs on an instruction level. On any given instruction, the data areas can be examined or modified and stimuli can be applied from a comprehensive stimulus controller. Registers can be logged to files for further run-time analysis. The trace buffer and logic analyzer display extend the power of the simulator to record and track program execution, actions on I/O, most peripherals and internal registers.

The MPLAB SIM Software Simulator fully supports symbolic debugging using the MPLAB C Compilers, and the MPASM and MPLAB Assemblers. The software simulator offers the flexibility to develop and debug code outside of the hardware laboratory environment, making it an excellent, economical software development tool.

13.8 MPLAB REAL ICE In-Circuit Emulator System

MPLAB REAL ICE In-Circuit Emulator System is Microchip's next generation high-speed emulator for Microchip Flash DSC and MCU devices. It debugs and programs PIC[®] Flash MCUs and dsPIC[®] Flash DSCs with the easy-to-use, powerful graphical user interface of the MPLAB Integrated Development Environment (IDE), included with each kit.

The emulator is connected to the design engineer's PC using a high-speed USB 2.0 interface and is connected to the target with either a connector compatible with incircuit debugger systems (RJ11) or with the new high-speed, noise tolerant, Low-Voltage Differential Signal (LVDS) interconnection (CAT5).

The emulator is field upgradable through future firmware downloads in MPLAB IDE. In upcoming releases of MPLAB IDE, new devices will be supported, and new features will be added. MPLAB REAL ICE offers significant advantages over competitive emulators including low-cost, full-speed emulation, run-time variable watches, trace analysis, complex breakpoints, a ruggedized probe interface and long (up to three meters) interconnection cables.

13.9 MPLAB ICD 3 In-Circuit Debugger System

MPLAB ICD 3 In-Circuit Debugger System is Microchip's most cost effective high-speed hardware debugger/programmer for Microchip Flash Digital Signal Controller (DSC) and microcontroller (MCU) devices. It debugs and programs PIC[®] Flash microcontrollers and dsPIC[®] DSCs with the powerful, yet easyto-use graphical user interface of MPLAB Integrated Development Environment (IDE).

The MPLAB ICD 3 In-Circuit Debugger probe is connected to the design engineer's PC using a high-speed USB 2.0 interface and is connected to the target with a connector compatible with the MPLAB ICD 2 or MPLAB REAL ICE systems (RJ-11). MPLAB ICD 3 supports all MPLAB ICD 2 headers.

13.10 PICkit 3 In-Circuit Debugger/ Programmer and PICkit 3 Debug Express

The MPLAB PICkit 3 allows debugging and programming of PIC[®] and dsPIC[®] Flash microcontrollers at a most affordable price point using the powerful graphical user interface of the MPLAB Integrated Development Environment (IDE). The MPLAB PICkit 3 is connected to the design engineer's PC using a full speed USB interface and can be connected to the target via an Microchip debug (RJ-11) connector (compatible with MPLAB ICD 3 and MPLAB REAL ICE). The connector uses two device I/O pins and the reset line to implement in-circuit debugging and In-Circuit Serial Programming[™].

The PICkit 3 Debug Express include the PICkit 3, demo board and microcontroller, hookup cables and CDROM with user's guide, lessons, tutorial, compiler and MPLAB IDE software.

13.11 PICkit 2 Development Programmer/Debugger and PICkit 2 Debug Express

The PICkit[™] 2 Development Programmer/Debugger is a low-cost development tool with an easy to use interface for programming and debugging Microchip's Flash families of microcontrollers. The full featured Windows® programming interface supports baseline (PIC10F, PIC12F5xx, PIC16F5xx), midrange (PIC12F6xx, PIC16F), PIC18F, PIC24, dsPIC30, dsPIC33, and PIC32 families of 8-bit, 16-bit, and 32-bit microcontrollers, and many Microchip Serial EEPROM products. With Microchip's powerful MPLAB Integrated Development Environment (IDE) the PICkit[™] 2 enables in-circuit debugging on most PIC[®] microcontrollers. In-Circuit-Debugging runs, halts and single steps the program while the PIC microcontroller is embedded in the application. When halted at a breakpoint, the file registers can be examined and modified.

The PICkit 2 Debug Express include the PICkit 2, demo board and microcontroller, hookup cables and CDROM with user's guide, lessons, tutorial, compiler and MPLAB IDE software.

13.12 MPLAB PM3 Device Programmer

The MPLAB PM3 Device Programmer is a universal, CE compliant device programmer with programmable voltage verification at VDDMIN and VDDMAX for maximum reliability. It features a large LCD display (128 x 64) for menus and error messages and a modular, detachable socket assembly to support various package types. The ICSP™ cable assembly is included as a standard item. In Stand-Alone mode, the MPLAB PM3 Device Programmer can read, verify and program PIC devices without a PC connection. It can also set code protection in this mode. The MPLAB PM3 connects to the host PC via an RS-232 or USB cable. The MPLAB PM3 has high-speed communications and optimized algorithms for quick programming of large memory devices and incorporates an MMC card for file storage and data applications.

13.13 Demonstration/Development Boards, Evaluation Kits, and Starter Kits

A wide variety of demonstration, development and evaluation boards for various PIC MCUs and dsPIC DSCs allows quick application development on fully functional systems. Most boards include prototyping areas for adding custom circuitry and provide application firmware and source code for examination and modification.

The boards support a variety of features, including LEDs, temperature sensors, switches, speakers, RS-232 interfaces, LCD displays, potentiometers and additional EEPROM memory.

The demonstration and development boards can be used in teaching environments, for prototyping custom circuits and for learning about various microcontroller applications.

In addition to the PICDEM[™] and dsPICDEM[™] demonstration/development board series of circuits, Microchip has a line of evaluation kits and demonstration software for analog filter design, KEELOQ[®] security ICs, CAN, IrDA[®], PowerSmart battery management, SEEVAL[®] evaluation system, Sigma-Delta ADC, flow rate sensing, plus many more.

Also available are starter kits that contain everything needed to experience the specified device. This usually includes a single application and debug capability, all on one board.

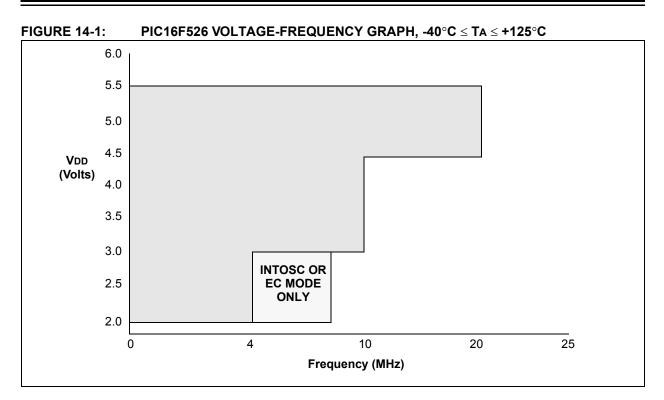
Check the Microchip web page (www.microchip.com) for the complete list of demonstration, development and evaluation kits.

14.0 ELECTRICAL CHARACTERISTICS

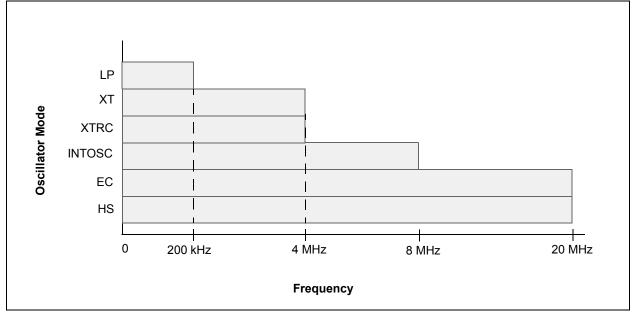
Absolute Maximum Ratings^(†)

Ambient temperature under bias	40°C to +125°C
Storage temperature	65°C to +150°C
Voltage on VDD with respect to Vss	0 to +6.5V
Voltage on MCLR with respect to Vss	
Voltage on all other pins with respect to Vss	0.3V to (VDD + 0.3V)
Total power dissipation ⁽¹⁾	700 mW
Max. current out of Vss pin	200 mA
Max. current into VDD pin	
Input clamp current, liк (Vi < 0 or Vi > Vod)	±20 mA
Output clamp current, Ioк (Vo < 0 or Vo > Voo)	±20 mA
Max. output current sunk by any I/O pin	25 mA
Max. output current sourced by any I/O pin	25 mA
Max. output current sourced by I/O port	75 mA
Max. output current sunk by I/O port	75 mA
Note 1: Power dissipation is calculated as follows: PDIS = VDD x {IDD $-\Sigma$ IOH} + Σ {(VDD $-$	VOH) x IOH} + Σ (VOL x IOL)

[†]NOTICE: Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at those or any other conditions above those indicated in the operation listings of this specification is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.







DC Characteristics			Standard Operating Conditions (unless otherwise specified) Operating Temperature -40°C \leq TA \leq +85°C (industrial)					
Param No.	Sym.	Characteristic	Min.	Min. Typ. ⁽¹⁾	Max.	Units	Conditions	
D001	Vdd	Supply Voltage	2.0		5.5	V	See Figure 14-1	
D002	Vdr	RAM Data Retention Voltage ⁽²⁾		1.5*		V	Device in Sleep mode	
D003	VPOR	VDD Start Voltage to ensure Power-on Reset	—	Vss	—	V	See Section 8.4 "Power-on Reset (POR)" for details	
D004	SVDD	VDD Rise Rate to ensure Power-on Reset	0.05*	_	—	V/ms	See Section 8.4 "Power-on Reset (POR)" for details	
D005	IDDP	Supply Current During Prog/ Erase	—	250*	—	μA		
D010	IDD	Supply Current ^(3, 4, 6)	_	175 400	250 700	μΑ μΑ	Fosc = 4 MHz, VDD = 2.0V Fosc = 4 MHz, VDD = 5.0V	
			_	250 0.75	400 1.2	μA mA	Fosc = 8 MHz, VDD = 2.0V Fosc = 8 MHz, VDD = 5.0V	
				1.4	2.2	mA	Fosc = 20 MHz, VDD = 5.0V	
			_	11 38	22 55	μΑ μΑ	Fosc = 32 kHz, VDD = 2.0V Fosc = 32 kHz, VDD = 5.0V	
D020	IPD	Power-down Current ⁽⁵⁾	_	0.1 0.35	1.2 2.2	μΑ μΑ	VDD = 2.0V VDD = 5.0V	
D022	Iwdt	WDT Current ⁽⁵⁾	_	1.0 7.0	3.0 16.0	μΑ μΑ	VDD = 2.0V VDD = 5.0V	
D023	ICMP	Comparator Current ⁽⁵⁾	_	15 60	26 76	μΑ μΑ	VDD = 2.0V (per comparator) VDD = 5.0V (per comparator)	
D022	ICVREF	CVREF Current ⁽⁵⁾	_	30 75	75 135	μΑ μΑ	VDD = 2.0V (high range) VDD = 5.0V (high range)	
D023	IFVR	Internal 0.6V Fixed Voltage Reference Current ⁽⁵⁾	_	100 175	120 205	μΑ μΑ	VDD = 2.0V (reference and 1 comparator enabled) VDD = 5.0V (reference and 1 comparator enabled)	
D024	ΔIAD^*	A/D Conversion Current	—	120	150	μA	2.0V	
				200	250	μA	5.0V	

14.1 DC Characteristics: PIC16F526 (Industrial)

* These parameters are characterized but not tested.

Note 1: Data in the Typical ("Typ") column is based on characterization results at 25°C. This data is for design guidance only and is not tested.

- 2: This is the limit to which VDD can be lowered in Sleep mode without losing RAM data.
- **3:** The supply current is mainly a function of the operating voltage and frequency. Other factors such as bus loading, oscillator type, bus rate, internal code execution pattern and temperature also have an impact on the current consumption.
- 4: The test conditions for all IDD measurements in Active Operation mode are: OSC1 = external square wave, from rail-to-rail; all I/O pins tri-stated, pulled to Vss, T0CKI = VDD, MCLR = VDD; WDT enabled/disabled as specified.
- **5:** For standby current measurements, the conditions are the same as IDD, except that the device is in Sleep mode. If a module current is listed, the current is for that specific module enabled and the device in Sleep.
- 6: For EXTRC mode, does not include current through REXT. The current through the resistor can be estimated by the formula:

I = VDD/2REXT (mA) with REXT in $k\Omega$.

14.2 DC Characteristics: PIC16F526 (Extended)

DC Characteristics			Standard Operating Conditions (unless otherwise specified) Operating Temperature -40°C \leq TA \leq +125°C (extended)					
Param No.	Sym.	Characteristic	Min.	Тур. ⁽¹⁾	Max.	Units	Conditions	
D001	Vdd	Supply Voltage	2.0		5.5	V	See Figure 14-1	
D002	Vdr	RAM Data Retention Voltage ⁽²⁾		1.5*		V	Device in Sleep mode	
D003	VPOR	VDD Start Voltage to ensure Power-on Reset	-	Vss		V	See Section 8.4 "Power-on Reset (POR)" for details	
D004	SVDD	VDD Rise Rate to ensure Power-on Reset	0.05*	—		V/ms	See Section 8.4 "Power-on Reset (POR)" for details	
D005	IDDP	Supply Current During Prog/ Erase	—	250*		μA		
D010	IDD	Supply Current ^(3,4,6)	_	175 400	250 700	μΑ μΑ	Fosc = 4 MHz, Vdd = 2.0V Fosc = 4 MHz, Vdd = 5.0V	
			_	250 0.75	400 1.2	μA mA	Fosc = 8 MHz, VDD = 2.0V Fosc = 8 MHz, VDD = 5.0V	
				1.4	2.2	mA	Fosc = 20 MHz, VDD = 5.0V	
			_	11 38	26 110	μA μA	Fosc = 32 kHz, VDD = 2.0V Fosc = 32 kHz, VDD = 5.0V	
D020	IPD	Power-down Current ⁽⁵⁾	_	0.1 0.35	9.0 15.0	μΑ μΑ	VDD = 2.0V VDD = 5.0V	
D022	Iwdt	WDT Current ⁽⁵⁾	_	1.0 7.0	18 22	μΑ μΑ	VDD = 2.0V VDD = 5.0V	
D023	ICMP	Comparator Current ⁽⁵⁾	_	15 60	26 76	μΑ μΑ	VDD = 2.0V (per comparator) VDD = 5.0V (per comparator)	
D022	ICVREF	CvREF Current ⁽⁵⁾	_	30 75	75 135	μΑ μΑ	VDD = 2.0V (high range) VDD = 5.0V (high range)	
D023	IFVR	Internal 0.6V Fixed Voltage Reference Current ⁽⁵⁾		100 175	130 220	μΑ μΑ	V _{DD} = 2.0V (reference and 1 comparator enabled) V _{DD} = 5.0V (reference and 1	
D004	414-5*			400	450	•	comparator enabled)	
D024	ΔIAD^*	A/D Conversion Current		120	150	μA	2.0V	
			—	200	250	μA	5.0V	

* These parameters are characterized but not tested.

Note 1: Data in the Typical ("Typ") column is based on characterization results at 25°C. This data is for design guidance only and is not tested.

2: This is the limit to which VDD can be lowered in Sleep mode without losing RAM data.

3: The supply current is mainly a function of the operating voltage and frequency. Other factors such as bus loading, oscillator type, bus rate, internal code execution pattern and temperature also have an impact on the current consumption.

4: The test conditions for all IDD measurements in Active Operation mode are: OSC1 = external square wave, from rail-to-rail; all I/O pins tri-stated, pulled to Vss, T0CKI = VDD, MCLR = VDD; WDT enabled/disabled as specified.

5: For standby current measurements, the conditions are the same as IDD, except that the device is in Sleep mode. If a module current is listed, the current is for that specific module enabled and the device in Sleep.

6: For EXTRC mode, does not include current through REXT. The current through the resistor can be estimated by the formula:

I = VDD/2REXT (mA) with REXT in $k\Omega$.

TABLE 14-1: DC CHARACTERISTICS: PIC16F526 (Industrial, Extended)

DC CH/	ARACT	ERISTICS	$\begin{array}{llllllllllllllllllllllllllllllllllll$							
Param No.	Sym.	Characteristic	Min.	Typ.†	Max.	Units	Conditions			
	VIL	Input Low Voltage	•				·			
		I/O ports								
D030		with TTL buffer	Vss	—	0.8	V	For all $4.5 \le VDD \le 5.5V$			
D030A			Vss	_	0.15 VDD	V	Otherwise			
D031		with Schmitt Trigger buffer	Vss	—	0.15 VDD	V				
D032		MCLR, TOCKI	Vss	_	0.15 VDD	V				
D033		OSC1 (EXTRC mode), EC ⁽¹⁾	Vss	_	0.15 VDD	V				
D033		OSC1 (HS mode)	Vss	_	0.3 VDD	v				
D033		OSC1 (XT and LP modes)	Vss	_	0.3	V				
	VIH	Input High Voltage	-				•			
		I/O ports		_						
D040		with TTL buffer	2.0	_	Vdd	v	$4.5 \le VDD \le 5.5V$			
D040A			0.25VDD + 0.8V	_	Vdd	V	Otherwise			
D041		with Schmitt Trigger buffer	0.85VDD	_	VDD	v	For entire VDD range			
D042		MCLR, TOCKI	0.85VDD	_	VDD	v				
D042A		OSC1 (EXTRC mode), EC ⁽¹⁾	0.85VDD	_	VDD	V				
D042A		OSC1 (HS mode)	0.7VDD	_	VDD	v				
D043		OSC1 (XT and LP modes)	1.6	_	VDD	v				
D070	IPUR	PORTB weak pull-up current ⁽⁴⁾	50	250	400	μA	VDD = 5V, VPIN = VSS			
	liL	Input Leakage Current ^(2,5)								
D060		I/O ports	_	_	±1	μA	Vss \leq VPIN \leq VDD, Pin at high-impedance			
D061		RB3/MCLR ⁽³⁾	_	±0.7	±5	μA	$Vss \leq VPIN \leq VDD$			
D063		OSC1	_	_	±5	μΑ	Vss ≤ VPIN ≤ VDD, XT, HS and LP osc configuration			
	Vol	Output Low Voltage					comgaration			
D080	VOL	I/O ports/CLKOUT		_	0.6	V	IOL = 8.5 mA, VDD = 4.5V, -40°C to +85°C			
D080A			_		0.6	v	$IOL = 7.0 \text{ mA}, VDD = 4.5V, -40^{\circ}C \text{ to } +125^{\circ}C$			
DUUUA	Vон	Output High Voltage			0.0	v	10E - 7.0 HIA, VDD - 4.3V, -40 C 10 + 123 C			
D090	VOIT	I/O ports/CLKOUT	VDD - 0.7			V	Юн = -3.0 mA, VDD = 4.5V, -40°С to +85°С			
D090A			VDD - 0.7		_	v	$IOH = -2.5 \text{ mA}, \text{ VDD} = 4.5 \text{V}, -40^{\circ}\text{C to } +125^{\circ}\text{C}$			
DUJUA		$\frac{VDD - 0.7}{Capacitive Loading Specs on Output Pins}$								
D100	COSC2	OSC2 pin	-	_	15	pF	In XT, HS and LP modes when external clock is used to drive OSC1.			
D101	CIO	All I/O pins and OSC2	_	_	50	pF				
5101		Flash Data Memory		L		Pi	I			
		Byte endurance	100K	1M	_	E/W	$-40^{\circ}C \le TA \le +85^{\circ}C$			
D120	FD									
D120 D120A	Ed Ed	Byte endurance	10K	100K	_	E/W	$+85^{\circ}C \le TA \le +125^{\circ}C$			

Data in "Typ" column is at 5V, 25°C unless otherwise stated. These parameters are for design guidance only and are not tested.
 Note 1: In EXTRC oscillator configuration, the OSC1/CLKIN pin is a Schmitt Trigger input. It is not recommended that the PIC16F526 be driven with external clock in RC mode.

2: Negative current is defined as coming out of the pin.

3: This spec. applies to RB3/MCLR configured as RB3 with pull-up disabled.

4: This spec. applies to all weak pull-up devices, including the weak pull-up found on RB3/MCLR. The current value listed will be the same whether or not the pin is configured as RB3 with pull-up enabled or as MCLR.

5: The leakage current on the nMCLR pin is strongly dependent on the applied voltage level. The specified levels represent normal operating conditions. Higher leakage may be measured at different input voltages.

TABLE 14-2: COMPARATOR SPECIFICATIONS.

Comparator Specifications		Standard Operating Conditions (unless otherwise stated) Operating temperature -40°C to 125°C								
Characteristics	Sym.	Sym. Min. Typ. Max. Units Comments								
Internal Voltage Reference	VIVRF	0.50	0.60	0.70	V					
Input offset voltage	Vos	_	± 5.0	± 10	mV					
Input common mode voltage*	Vсм	0	—	Vdd – 1.5	V					
CMRR*	CMRR	55	—	_	db					
Response Time ^{(1)*}	Trt	_	150	400	ns					
Comparator Mode Change to Output Valid*	TMC2COV	_	—	10	μS					

* These parameters are characterized but not tested.

Note 1: Response time measured with one comparator input at (VDD - 1.5)/2 while the other input transitions from Vss to VDD - 1.5V.

Sym.	Characteristics	Min.	Тур.	Max.	Units	Comments
CVRES	Resolution		VDD/24* VDD/32	_	LSb LSb	Low Range (VRR = 1) High Range (VRR = 0)
	Absolute Accuracy ⁽²⁾			±1/2* ±1/2*	LSb LSb	Low Range (VRR = 1) High Range (VRR = 0)
	Unit Resistor Value (R)		2K*	—	Ω	
	Settling Time ⁽¹⁾		—	10*	μS	

* These parameters are characterized but not tested.

Note 1: Settling time measured while VRR = 1 and VR<3:0> transitions from 0000 to 1111.

2: Do not use reference externally when VDD < 2.7V. Under this condition, reference should only be used with comparator Voltage Common mode observed.

A/D Con	verter	Specifications		• •	perating Conditions (unless otherwise stated) emperature -40°C \leq TA \leq +125°C				
Param No.	Sym.	Characteristic	Min.	Typ.†	Max.	Units	Conditions		
A01	NR	Resolution	—	_	8	bit			
A03	Einl	Integral Error	—	—	±1.5	LSb	VDD = 5.0V		
A04	Ednl	Differential Error	—	—	-1< EDNL ≤1.7	LSb	No missing codes to 8 bits VDD = 5.0V		
A06	EOFF	Offset Error	—	—	±1.5	LSb	VDD = 5.0V		
A07	Egn	Gain Error	-0.7	—	+2.2	LSb	VDD = 5.0V		
A10	_	Monotonicity	—	guaranteed ⁽¹⁾	_		$Vss \leq Vain \leq Vdd$		
A25	Vain	Analog Input Voltage	Vss	—	Vdd	V			
A30	ZAIN	Recommended Impedance of Analog Voltage Source	_	—	10	KΩ			

TABLE 14-4: A/D CONVERTER CHARACTERISTICS:

* These parameters are characterized but not tested.

† Data in "Typ" column is at 5.0V, 25°C unless otherwise stated. These parameters are for design guidance only and are not tested.

Note 1: The A/D conversion result never decreases with an increase in the input voltage and has no missing codes.

VDD (Volts)	Temperature (°C)	Min.	Тур.	Max.	Units
RB0/RB1/RB4					
2.0	-40	73K	105K	186K	Ω
	25	73K	113K	187K	Ω
	85	82K	123K	190K	Ω
	125	86K	132k	190K	Ω
5.5	-40	15K	21K	33K	Ω
	25	15K	22K	34K	Ω
	85	19K	26k	35K	Ω
	125	23K	29K	35K	Ω
RB3					
2.0	-40	63K	81K	96K	Ω
	25	77K	93K	116K	Ω
	85	82K	96k	116K	Ω
	125	86K	100K	119K	Ω
5.5	-40	16K	20k	22K	Ω
	25	16K	21K	23K	Ω
	85	24K	25k	28K	Ω
	125	26K	27K	29K	Ω

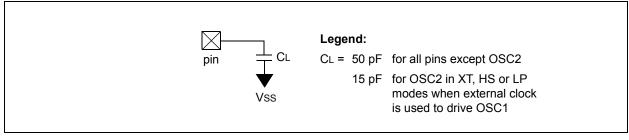
14.3 Timing Parameter Symbology and Load Conditions

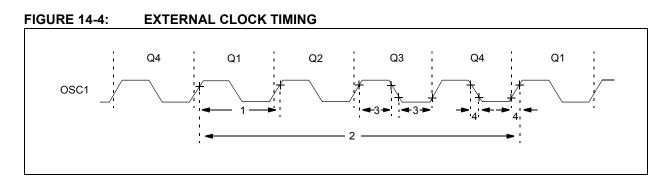
The timing parameter symbols have been created following one of the following formats:

1. TppS2ppS

2. TppS			
т			
FF	requency	T Time	
Lower	case subscripts (pp) and their meanings:		
рр			
2	to	mc	MCLR
ck	CLKOUT	osc	Oscillator
су	Cycle time	os	OSC1
drt	Device Reset Timer	tO	ТОСКІ
io	I/O port	wdt	Watchdog Timer
Uppero	case letters and their meanings:		
S			
F	Fall	Р	Period
н	High	R	Rise
I	Invalid (high-impedance)	V	Valid
L	Low	Z	High-impedance

FIGURE 14-3: LOAD CONDITIONS





AC CHA	ARACTE	ERISTICS	Standard Operating Conditions (unless otherwise specified)Operating Temperature $-40^{\circ}C \le TA \le +85^{\circ}C$ (industrial), $-40^{\circ}C \le TA \le +125^{\circ}C$ (extended)Operating Voltage VDD range is described in Section 14.1 "DC						
			Characteristics: PIC16F526 (Industrial)"						
Param No.	Sym.	Characteristic	Min.	Тур. ⁽¹⁾	Max.	Units	Conditions		
1A	Fosc	External CLKIN Frequency ⁽²⁾	DC	—	4	MHz	XT Oscillator mode		
			DC	—	20	MHz	HS/EC Oscillator mode		
			DC	—	200	kHz	LP Oscillator mode		
		Oscillator Frequency ⁽²⁾	—	_	4	MHz	EXTRC Oscillator mode		
			0.1	—	4	MHz	XT Oscillator mode		
			4	—	20	MHz	HS/EC Oscillator mode		
			—	_	200	kHz	LP Oscillator mode		
1	Tosc	External CLKIN Period ⁽²⁾	250	—	—	ns	XT Oscillator mode		
			50	—	—	ns	HS/EC Oscillator mode		
			5	—	—	μS	LP Oscillator mode		
		Oscillator Period ⁽²⁾	250	—	—	ns	EXTRC Oscillator mode		
			250	_	10,000	ns	XT Oscillator mode		
			50	_	250	ns	HS/EC Oscillator mode		
			5	—	—	μS	LP Oscillator mode		
2	Тсү	Instruction Cycle Time	200	4/Fosc	—	ns			
3	TosL,	Clock in (OSC1) Low or High	50*	_	_	ns	XT Oscillator		
	TosH	Time	2*	_	—	μS	LP Oscillator		
			10*	—	—	ns	HS/EC Oscillator		
4	TosR,	Clock in (OSC1) Rise or Fall	—	_	25*	ns	XT Oscillator		
	TosF	Time	—	—	50*	ns	LP Oscillator		
			—	_	15*	ns	HS/EC Oscillator		

TABLE 14-6: EXTERNAL CLOCK TIMING REQUIREMENTS

* These parameters are characterized but not tested.

Note 1: Data in the Typical ("Typ") column is at 5V, 25°C unless otherwise stated. These parameters are for design guidance only and are not tested.

2: All specified values are based on characterization data for that particular oscillator type under standard operating conditions with the device executing code. Exceeding these specified limits may result in an unstable oscillator operation and/or higher than expected current consumption. When an external clock input is used, the "max" cycle time limit is "DC" (no clock) for all devices.

TABLE 14-7: CALIBRATED INTERNAL RC FREQUENCIES

AC CHARACTERISTICS			Operating	lemper /oltage	ature - - VDD ran	40°C ≤ 40°C ≤ ge is de	$TA \le +8$ $TA \le +1$ escribed	otherwise specified) 5°C (industrial), 25°C (extended) in 6F526 (Industrial)"
Param No.	Sym.	Characteristic	Freq. Tolerance	Min.	Typ.†	Max.	Units	Conditions
F10	Fosc	Internal Calibrated INTOSC Frequency ⁽¹⁾	± 1% ± 2%	7.92 7.84	8.00 8.00	8.08 8.16	MHz	$3.5V, +25^{\circ}C$ $2.5V \le VDD \le 5.5V$ $0^{\circ}C \le TA \le +85^{\circ}C$
			± 5%	7.60	8.00	8.40	MHz	$\begin{array}{l} 2.0V \leq V \text{DD} \leq 5.5V \\ -40^{\circ}\text{C} \leq \text{TA} \leq +85^{\circ}\text{C} \ (\text{Ind.}) \\ -40^{\circ}\text{C} \leq \text{TA} \leq +125^{\circ}\text{C} \ (\text{Ext.}) \end{array}$

* These parameters are characterized but not tested.

† Data in the Typical ("Typ") column is at 5V, 25°C unless otherwise stated. These parameters are for design guidance only and are not tested.

Note 1: To ensure these oscillator frequency tolerances, VDD and VSS must be capacitively decoupled as close to the device as possible. 0.1 uF and 0.01 uF values in parallel are recommended.

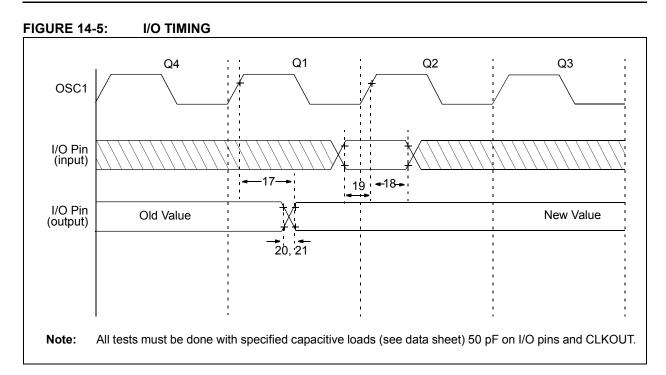


TABLE 14-8: TIMING REQUIREMENTS

AC CHARAC	TERISTICS	Standard Operating Conditions (unless otherwise specified)Operating Temperature $-40^{\circ}C \le TA \le +85^{\circ}C$ (industrial) $-40^{\circ}C \le TA \le +125^{\circ}C$ (extended)Operating Voltage VDD range is described in Section 14.1 "DC Characteristics: PIC16F526(Industrial)"						
Param No.	Sym.	Characteristic	Min.	Тур. ⁽¹⁾	Max.	Units		
17	TosH2ıoV	OSC1↑ (Q1 cycle) to Port Out Valid ^{(2), (3)}	_	_	100*	ns		
18	TosH2iol	OSC1↑ (Q2 cycle) to Port Input Invalid (I/O in hold time) ⁽²⁾		—	_	ns		
19	TIOV20sH	Port Input Valid to OSC1 [↑] (I/O in setup time)			_	ns		
20	TIOR	Port Output Rise Time ⁽³⁾		10	50**	ns		
21	TIOF	Port Output Fall Time ⁽³⁾		10	58**	ns		

* These parameters are characterized but not tested.

** These parameters are design targets and are not tested.

Note 1: Data in the Typical ("Typ") column is at 5V, 25°C unless otherwise stated. These parameters are for design guidance only and are not tested.

2: Measurements are taken in EXTRC mode.

3: See Figure 14-3 for loading conditions.

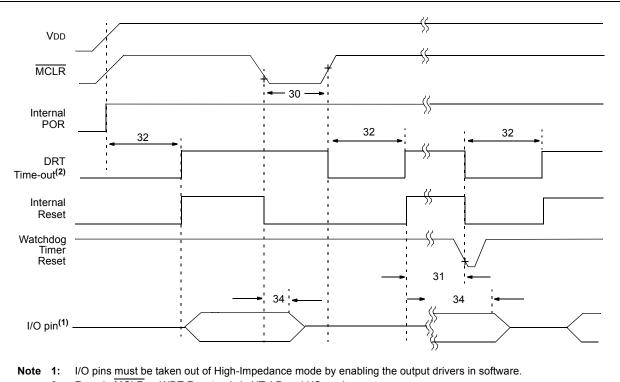


FIGURE 14-6: **RESET, WATCHDOG TIMER AND DEVICE RESET TIMER TIMING**

Runs in MCLR or WDT Reset only in XT, LP and HS modes. 2:

TABLE 14-9: RESET, WATCHDOG TIMER AND DEVICE RESET TIMER

				erature ge VDD r	-40°C ≤ -40°C ≤ ange is o	$TA \le +85^{\circ}C$ (industrial) $TA \le +125^{\circ}C$ (extended) described in
Sym.	Characteristic	Min.	Тур. ⁽¹⁾	Max.	Units	Conditions
TMCL	MCLR Pulse Width (low)	2000*	_	_	ns	VDD = 5.0V
Twdt	Watchdog Timer Time-out Period (no prescaler)	9* 9*	18* 18*	30* 40*	ms ms	VDD = 5.0V (Industrial) VDD = 5.0V (Extended)
TDRT	Device Reset Timer Period					
	Standard	9* 9*	18* 18*	30* 40*	ms ms	VDD = 5.0V (Industrial) VDD = 5.0V (Extended)
	Short	0.5* 0.5*	1.125* 1.125*	2* 2.5*	ms ms	VDD = 5.0V (Industrial) VDD = 5.0V (Extended)
Tioz	I/O High-impedance from MCLR low	—	—	2000*	ns	
	Sym. TMCL TWDT TDRT	Sym.CharacteristicTMCLMCLR Pulse Width (low)TWDTWatchdog Timer Time-out Period (no prescaler)TDRTDevice Reset Timer PeriodStandardStandardShortI/O High-impedance from MCLR	ARACTERISTICS Operating Sym. Characteristic Operating TMCL MCLR Pulse Width (low) 2000* TWDT Watchdog Timer Time-out Period (no prescaler) 9* TDRT Device Reset Timer Period 9* Standard 9* 9* Short 0.5* 0.5* TIOZ I/O High-impedance from MCLR —	ARACTERISTICS Operating Temp Sym. Characteristic Min. Typ.(1) TMCL MCLR Pulse Width (low) 2000* — TWDT Watchdog Timer Time-out Period (no prescaler) 9* 18* TDRT Device Reset Timer Period 9* 18* Standard 9* 18* Short 0.5* 1.125* TIOZ I/O High-impedance from MCLR — —	ARACTERISTICSOperating Temperature Operating Voltage VDD in Section 14.1 "DC CharaSym.CharacteristicMin.Typ.(1)Max.TMCLMCLR Pulse Width (low)2000*TWDTWatchdog Timer Time-out Period (no prescaler)9*18*30* 40*TDRTDevice Reset Timer Period9*18*40*Standard9*18*40*Short0.5*1.125*2* 2.5*TIOZI/O High-impedance from MCLR2000*	Sym.CharacteristicMin.Typ.(1)Max.UnitsTMCLMCLR Pulse Width (low)2000*nsTMCLMCLR Pulse Width (low)2000*18*30*msTWDTWatchdog Timer Time-out Period (no prescaler)9*18*40*msTDRTDevice Reset Timer Period9*18*30*msTDRTStandard9*18*30*msShort0.5*1.125*2*msTIOZI/O High-impedance from MCLR2000*ns

These parameters are characterized but not tested.

Note 1: Data in the Typical ("Typ") column is at 5V, 25°C unless otherwise stated. These parameters are for design guidance only and are not tested.

FIGURE 14-7: TIMER0 CLOCK TIMINGS

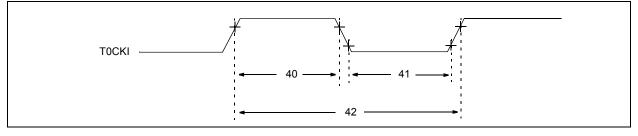


TABLE 14-10: TIMER0 CLOCK REQUIREMENT

AC CHARACTERISTICS Operating Temp				ating Conditions (u perature $-40^{\circ}C \le TA \le -40^{\circ}C \le TA \le$ ge VDD range is des DC Characteristics:	≤ +85°C ≤ +125° cribed ir	์ (indus C (exte า	strial) ended)	
Param No.	Sym.	Characte	eristic	Min.	Тур. ⁽¹⁾	Max.	Units	Conditions
40	Tt0H	T0CKI High Pulse	No Prescaler	0.5 Tcy + 20*	_	_	ns	
		Width	With Prescaler	10*	_	_	ns	
41	Tt0L	T0CKI Low Pulse	No Prescaler	0.5 Tcy + 20*	_	—	ns	
		Width	With Prescaler	10*	—		ns	
42	Tt0P	T0CKI Period		20 or Tcy + 40* N			ns	Whichever is greater. N = Prescale Value (1, 2, 4,, 256)

* These parameters are characterized but not tested.

Note 1: Data in the Typical ("Typ") column is at 5V, 25°C unless otherwise stated. These parameters are for design guidance only and are not tested.

TABLE 14-11: FLASH DATA MEMORY WRITE/ERASE TIME

Param	26 (Industrial)"
No. Sym. Characteristic Min. Typ. ⁽¹⁾ Max. Units Cor	onditions
43TDWFlash Data Memory Write Cycle Time23.55ms	
44 TDE Flash Data Memory 2 3.5 5 ms Erase Cycle Time 2 3.5 5 ms	

These parameters are characterized but not tested.

Note 1: Data in the Typical ("Typ") column is at 5V, 25°C unless otherwise stated. These parameters are for design guidance only and are not tested.

15.0 DC AND AC CHARACTERISTICS GRAPHS AND CHARTS

The graphs and tables provided in this section are for **design guidance** and are **not tested**.

In some graphs or tables, the data presented are **outside specified operating range** (i.e., outside specified VDD range). This is for **information only** and devices are ensured to operate properly only within the specified range

Note: The graphs and tables provided following this note are a statistical summary based on a limited number of samples and are provided for informational purposes only. The performance characteristics listed herein are not tested or guaranteed. In some graphs or tables, the data presented may be outside the specified operating range (e.g., outside specified power supply range) and therefore, outside the warranted range.

"Typical" represents the mean of the distribution at 25°C. "Maximum" or "minimum" represents (mean + 3σ) or (mean - 3σ) respectively, where s is a standard deviation, over each temperature range.

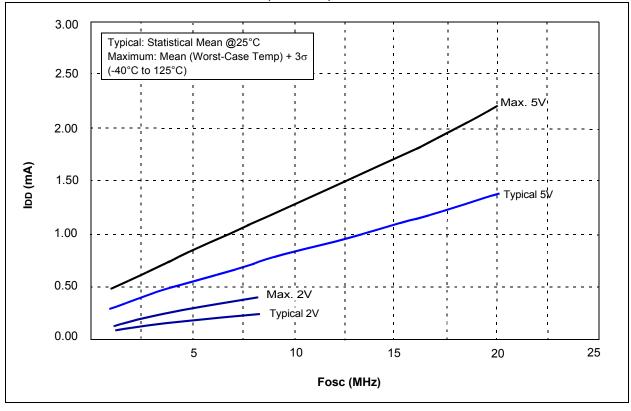
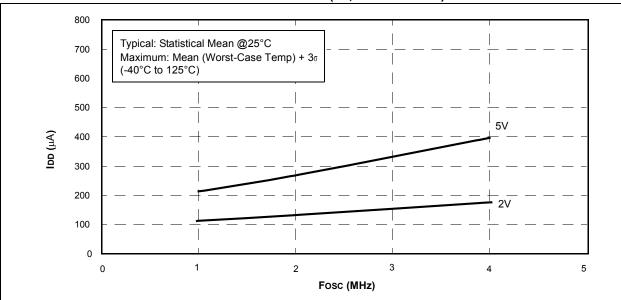
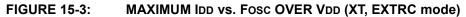
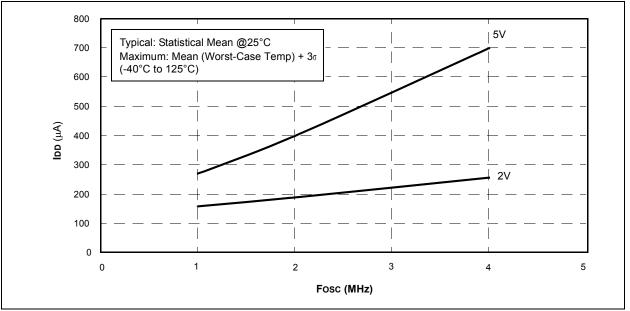


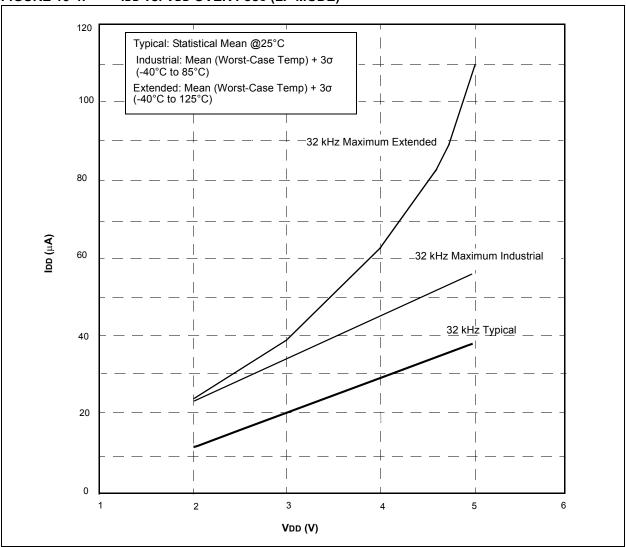
FIGURE 15-1: IDD vs. Fosc Over VDD (HS Mode)













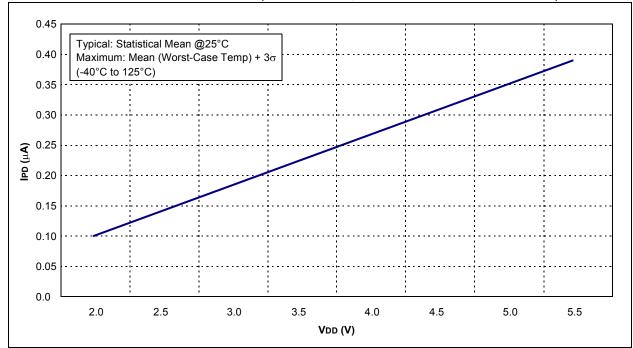
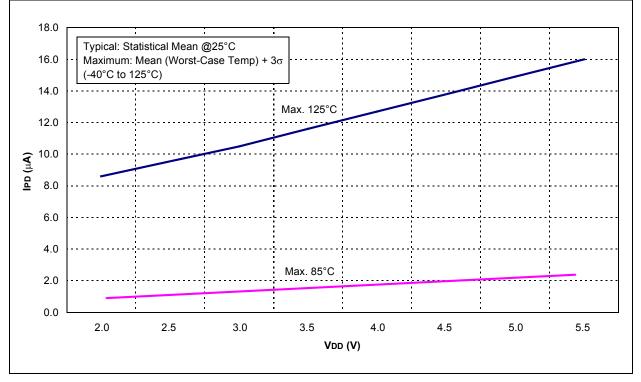


FIGURE 15-5: TYPICAL IPD vs. VDD (SLEEP MODE, ALL PERIPHERALS DISABLED)







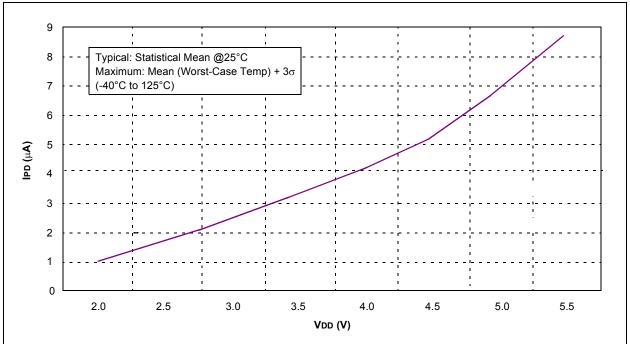
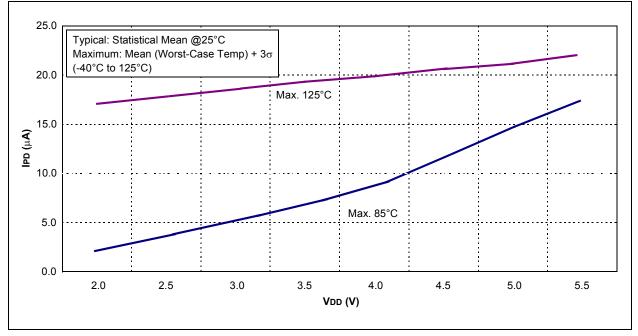
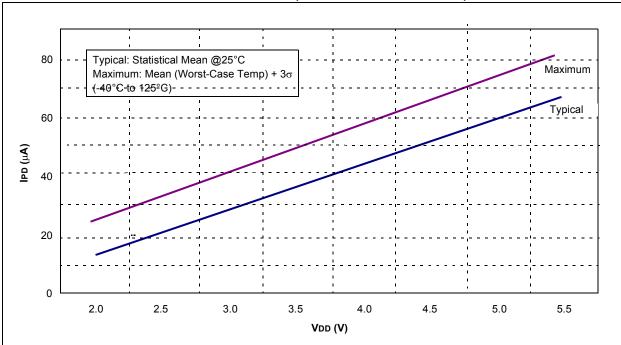


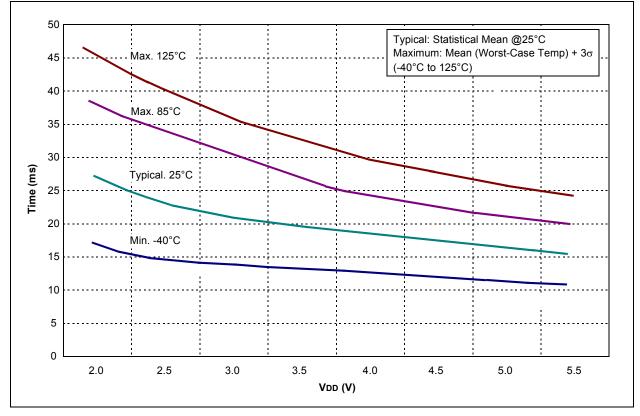
FIGURE 15-8: MAXIMUM WDT IPD vs. VDD OVER TEMPERATURE











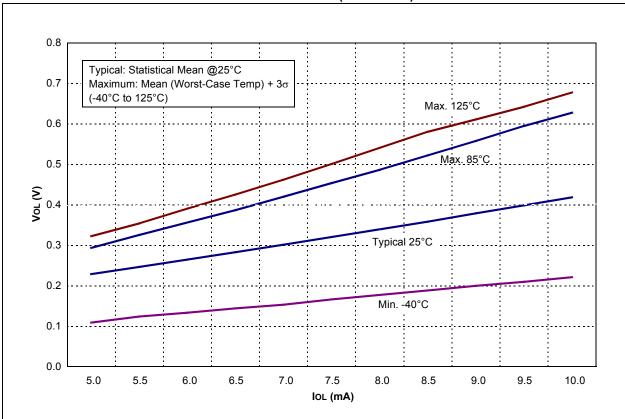
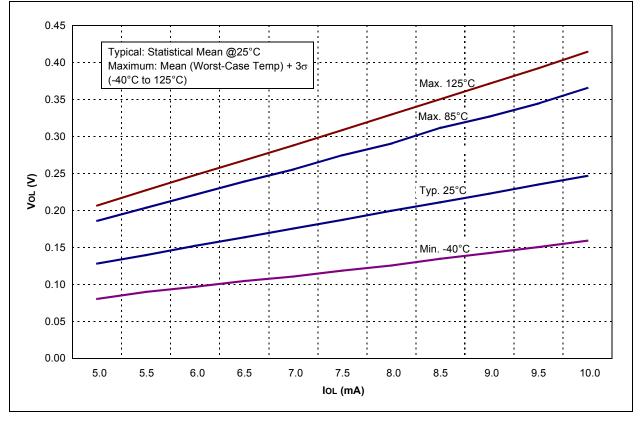


FIGURE 15-11: Vol vs. IoL OVER TEMPERATURE (VDD = 3.0V)





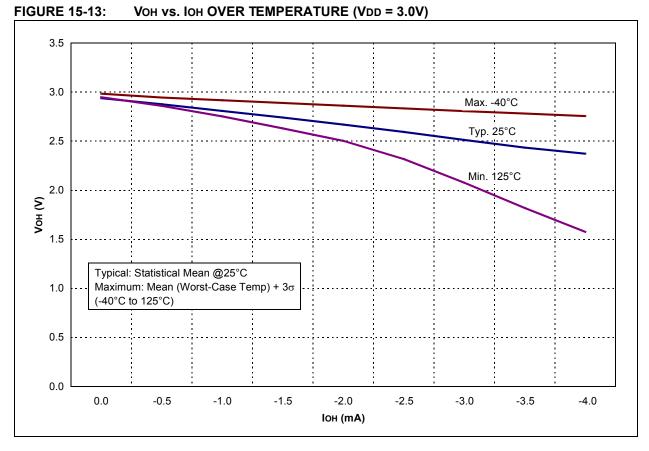
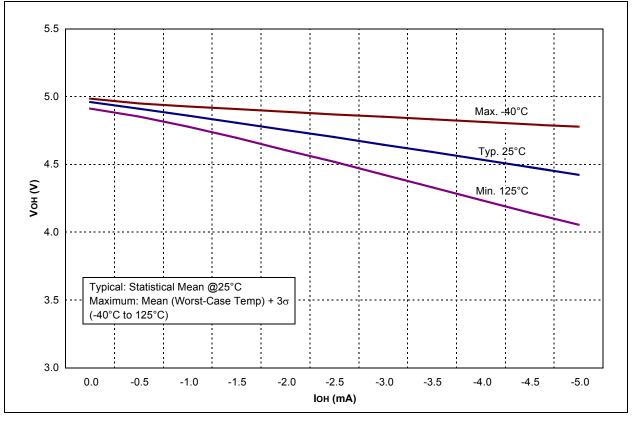
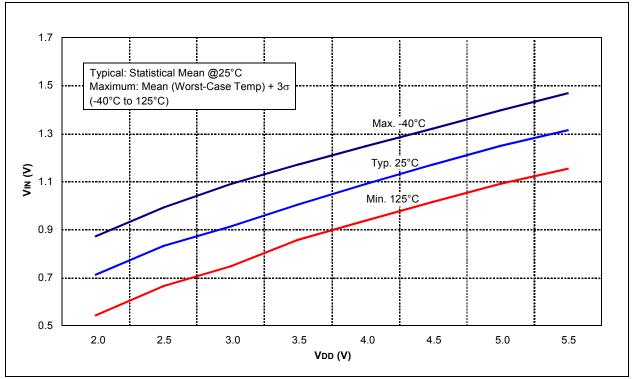


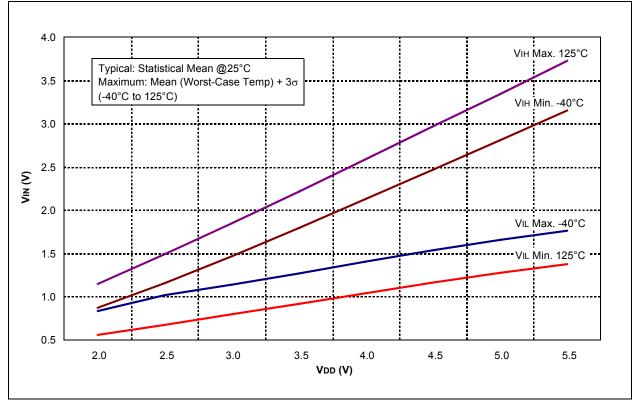
FIGURE 15-14: VOH vs. IOH OVER TEMPERATURE (VDD = 5.0V)











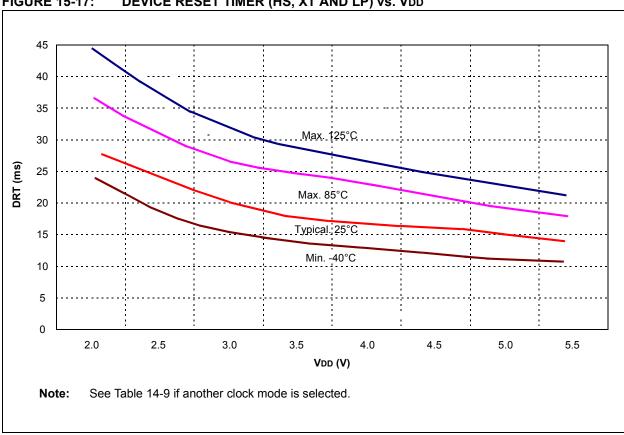
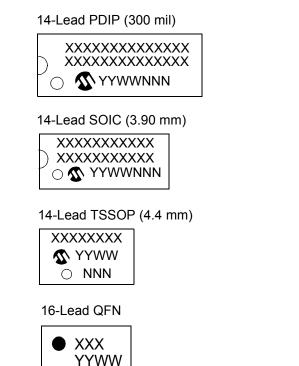


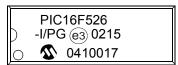
FIGURE 15-17: DEVICE RESET TIMER (HS, XT AND LP) vs. VDD

16.0 PACKAGING INFORMATION

16.1 Package Marking Information



Example



Example

Example

•

Example



TABLE 16-1: 16-LEAD 3X3 QFN (MG) TOP MARKING

NNN

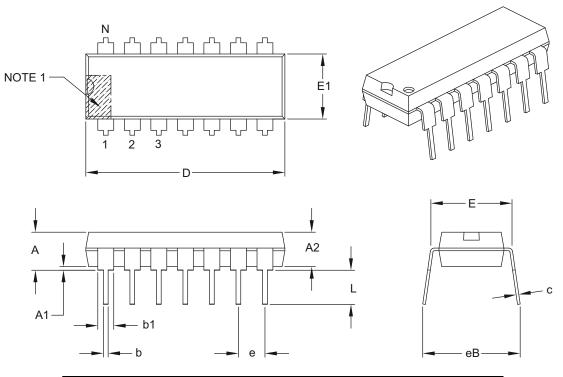
Part Number	Marking		
PIC16F526-I/MG	MG1		
PIC16F526-E/MG	MG2		

Legen	d: XXX Y YY WW NNN (e3) *	Customer-specific information Year code (last digit of calendar year) Year code (last 2 digits of calendar year) Week code (week of January 1 is week '01') Alphanumeric traceability code Pb-free JEDEC designator for Matte Tin (Sn) This package is Pb-free. The Pb-free JEDEC designator ((23)) can be found on the outer packaging for this package.
Note:	In the event the full Microchip part number cannot be marked on one line, it wi be carried over to the next line thus limiting the number of available characters for customer specific information.	

* Standard PIC[®] device marking consists of Microchip part number, year code, week code, and traceability code. For PIC device marking beyond this, certain price adders apply. Please check with your Microchip Sales Office. For QTP devices, any special marking adders are included in QTP price.

14-Lead Plastic Dual In-Line (P) – 300 mil Body [PDIP]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



	Units		INCHES	
Dimensio	n Limits	MIN	NOM	MAX
Number of Pins	Ν	14		
Pitch	е	.100 BSC		
Top to Seating Plane	А	-	-	.210
Molded Package Thickness	A2	.115	.130	.195
Base to Seating Plane	A1	.015	-	-
Shoulder to Shoulder Width	Е	.290	.310	.325
Molded Package Width	E1	.240	.250	.280
Overall Length	D	.735	.750	.775
Tip to Seating Plane	L	.115	.130	.150
Lead Thickness	С	.008	.010	.015
Upper Lead Width	b1	.045	.060	.070
Lower Lead Width	b	.014	.018	.022
Overall Row Spacing §	eB	-	-	.430

Notes:

1. Pin 1 visual index feature may vary, but must be located with the hatched area.

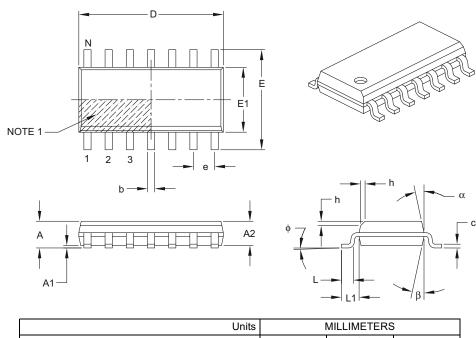
2. § Significant Characteristic.

3. Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed .010" per side.

4. Dimensioning and tolerancing per ASME Y14.5M.

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

Microchip Technology Drawing C04-005B



For the most current package drawings, please see the Microchip Packaging Specification located at

14-Lead Plastic Small Outline (SL) – Narrow, 3.90 mm Body [SOIC]

http://www.microchip.com/packaging

MIN NOM **Dimension Limits** MAX Number of Pins Ν 14 Pitch 1.27 BSC е **Overall Height** А 1.75 Molded Package Thickness A2 1.25 _ _ Standoff § A1 0.10 0.25 Overall Width 6.00 BSC Е Molded Package Width E1 3.90 BSC 8.65 BSC **Overall Length** D Chamfer (optional) 0.25 0.50 h Foot Length L 0.40 1.27 Footprint L1 1.04 REF Foot Angle 0° 8° ø _ Lead Thickness 0.17 0.25 С _ Lead Width 0.31 0.51 b _ Mold Draft Angle Top 5° 15° α _ Mold Draft Angle Bottom 5° 15° β _

Notes:

Note:

1. Pin 1 visual index feature may vary, but must be located within the hatched area.

2. § Significant Characteristic.

3. Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.15 mm per side.

4. Dimensioning and tolerancing per ASME Y14.5M.

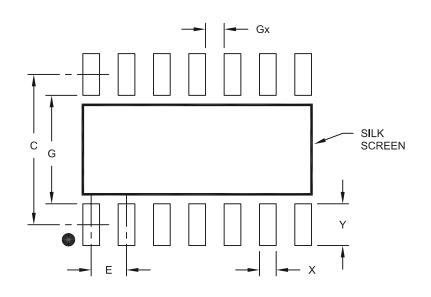
BSC: Basic Dimension. Theoretically exact value shown without tolerances.

REF: Reference Dimension, usually without tolerance, for information purposes only.

Microchip Technology Drawing C04-065B

14-Lead Plastic Small Outline (SL) - Narrow, 3.90 mm Body [SOIC]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



RECOMMENDED LAND PATTERN

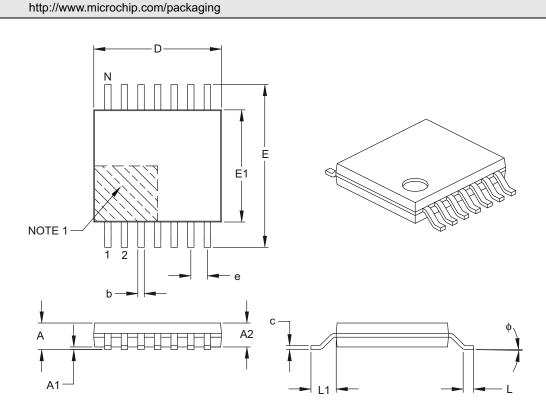
Units		N	IILLIMETER	S
Dimension	Limits	MIN	NOM	MAX
Contact Pitch	Е		1.27 BSC	
Contact Pad Spacing	С		5.40	
Contact Pad Width	Х			0.60
Contact Pad Length	Y			1.50
Distance Between Pads	Gx	0.67		
Distance Between Pads	G	3.90		

Notes:

1. Dimensioning and tolerancing per ASME Y14.5M

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

Microchip Technology Drawing No. C04-2065A



For the most current package drawings, please see the Microchip Packaging Specification located at

14-Lead Plastic Thin Shrink Small Outline (ST) – 4.4 mm Body [TSSOP]

Units		MILLIMETERS		
D	imension Limits	MIN	NOM	MAX
Number of Pins	N	14		
Pitch	е		0.65 BSC	
Overall Height	A	-	-	1.20
Molded Package Thickness	A2	0.80	1.00	1.05
Standoff	A1	0.05	-	0.15
Overall Width	E	6.40 BSC		
Molded Package Width	E1	4.30	4.40	4.50
Molded Package Length	D	4.90	5.00	5.10
Foot Length	L	0.45	0.60	0.75
Footprint	L1	1.00 REF		
Foot Angle	ф	0°	_	8°
Lead Thickness	С	0.09	-	0.20
Lead Width	b	0.19	-	0.30

Notes:

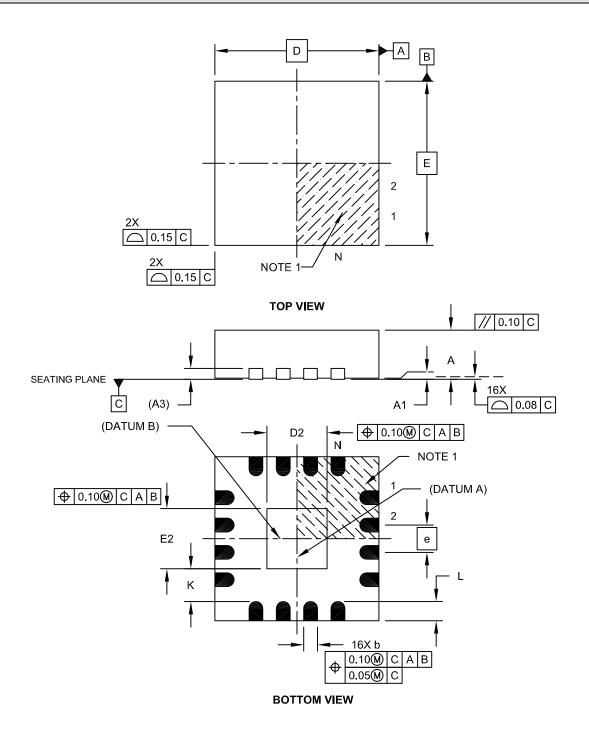
Note:

- 1. Pin 1 visual index feature may vary, but must be located within the hatched area.
- 2. Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.15 mm per side.
- 3. Dimensioning and tolerancing per ASME Y14.5M.
 - $\ensuremath{\mathsf{BSC}}$: Basic Dimension. Theoretically exact value shown without tolerances.
 - REF: Reference Dimension, usually without tolerance, for information purposes only.

Microchip Technology Drawing C04-087B

16-Lead Plastic Quad Flat, No Lead Package (MG) - 3x3x0.9 mm Body [QFN]

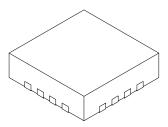
Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



Microchip Technology Drawing C04-142A Sheet 1 of 2

16-Lead Plastic Quad Flat, No Lead Package (MG) - 3x3x0.9 mm Body [QFN]

For the most current package drawings, please see the Microchip Packaging Specification located at Note: http://www.microchip.com/packaging



	Units	Ν	ILLIMETER	S
Dimension	n Limits	MIN	NOM	MAX
Number of Pins	N		16	
Pitch	е		0.50 BSC	
Overall Height	Α	0.80	0.85	0.90
Standoff	A1	0.00	0.02	0.05
Contact Thickness	A3	0.20 REF		
Overall Width	E	3.00 BSC		
Exposed Pad Width	E2	1.00	1.10	1.50
Overall Length	D	3.00 BSC		
Exposed Pad Length	D2	1.00	1.10	1.50
Contact Width	b	0.18	0.25	0.30
Contact Length	L	0.25	0.35	0.45
Contact-to-Exposed Pad	K	0.20	_	_

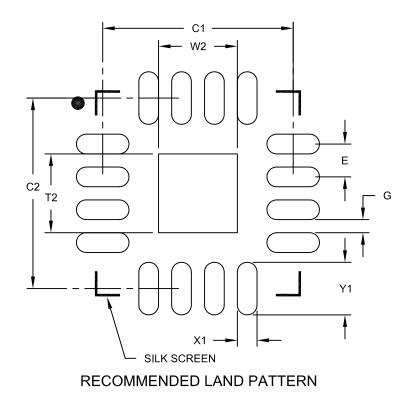
Notes:

- 1. Pin 1 visual index feature may vary, but must be located within the hatched area.
- 2. Package is saw singulated.
- Dimensioning and tolerancing per ASME Y14.5M.
 BSC: Basic Dimension. Theoretically exact value shown without tolerances.
 - REF: Reference Dimension, usually without tolerance, for information purposes only.

Microchip Technology Drawing C04-142A Sheet 2 of 2

16-Lead Plastic Quad Flat, No Lead Package (MG) – 3x3x0.9 mm Body [QFN]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



Units		MILLIMETERS			
Dimensior	n Limits	MIN	NOM	MAX	
Contact Pitch	E		0.50 BSC		
Optional Center Pad Width	W2			1.20	
Optional Center Pad Length	T2			1.20	
Contact Pad Spacing	C1		2.90		
Contact Pad Spacing	C2		2.90		
Contact Pad Width (X16)	X1			0.30	
Contact Pad Length (X16)	Y1			0.80	
Distance Between Pads	G	0.20			

Notes:

1. Dimensioning and tolerancing per ASME Y14.5M

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

Microchip Technology Drawing No. C04-2142A

APPENDIX A: REVISION HISTORY

Revision A (August 2007)

Original release of this document.

Revision B (December 2008)

Added DC and AC Characteristics graphs; Updated Electrical Characteristics section; added I/O diagrams; updated the Flash Data Memory Control Section; made various changes to the Special Features of the CPU Section and made general edits. Miscellaneous updates.

Revision C (July 2009)

Removed "Preliminary" status; Revised Table 6-3: I/O Pins; Revised Table 8-3: Reset Conditions; Revised Table 14-4: A/D Converter Char.

Revision D (March 2010)

Added Package Drawings and Package Marking Information for the 16-Lead Package Quad Flat, No Lead Package (MG) - 3x3x0.9 mm Body (QFN); Updated the Product Identification System section.

Revision E (June 2010)

Revised Section 6 (I/O) Figures 6-1, 6-4 and 6-6.

PIC16F526

NOTES:

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PRODUCT IDENTIFICATION SYSTEM

To order or obtain information, e.g., on pricing or delivery, refer to the factory or the listed sales office.

PART NO.	x <u>xx xxx</u>	Examples:
Device	Temperature Package Pattern Range	 a) PIC16F526-E/P 301 = Extended Temp., PDIP package, QTP pattern #301 b) PIC16F526-I/SL = Industrial Temp., SOIC package
Device:	PIC16F526 PIC16F526T ⁽¹⁾	 c) PIC16F526T-E/P = Extended Temp., PDIP package, Tape and Reel d) PIC16F526T-I/MG = Industrial Temp., QFN Package, Tape and Reel
Temperature Range:	I = -40° C to $+85^{\circ}$ C (Industrial) E = -40° C to $+125^{\circ}$ C (Extended)	
Package:	P = Plastic (PDIP) ⁽²⁾ SL = 14L Small Outline, 3.90 mm (SOIC) ⁽²⁾ ST = Thin Shrink Small Outline (TSSOP) ⁽²⁾ MG = 16-Lead 3x3 (QFN) ⁽²⁾	
Pattern:	Special Requirements	Note 1: T = in tape and reel SOIC, TSSOP and QFN packages only 2: Pb-free.



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